BQ25751 Standalone/I²C Controlled, 70V Bidirectional Buck-Boost Lead Acid Battery Charge Controller with Direct Power Path Control

1 Features

- Wide input voltage operating range: 4.4V to 70V
- Wide battery voltage operating range: up-to 70V
  - 6V up-to 48V lead-acid charging profile with bulk, absorb and float voltage charging phases
  - Charge voltage temperature compensation
- Synchronous buck charge controller with NFET drivers
  - Adjustable switching frequency from 200kHz to 600kHz
  - Optional synchronization to external clock
  - Integrated loop compensation with soft start
  - Optional gate driver supply input for optimized efficiency
- Bidirectional converter operation (Reverse Mode) supporting USB-PD Extended Power Range (EPR)
  - Adjustable input voltage (VAC) regulation from 3.3V to 65V with 20mV/step
  - Adjustable input current regulation (R_{AC_SNS}) from 400mA to 20A with 50mA/step using 2mΩ resistor
- Direct power path management for highest efficiency to power system
  - System power selection from adapter or battery
  - Dynamic power management
  - All N-channel FET drivers
- High accuracy
  - ±0.5% charge voltage regulation
  - ±3% charge current regulation
  - ±3% input current regulation
- I²C controlled for optimal system performance with resistor-programmable option
  - Hardware adjustable input and output current limits
- Integrated 16-bit ADC for voltage, current, and temperature monitoring
- Low battery quiescent current
- High safety integration
  - Adjustable input overvoltage and undervoltage protection
  - Battery Overvoltage and overcurrent protection
  - Charging safety timer in CV Mode
  - Thermal shutdown
- Status outputs
  - Adapter present status ($\overline{PG}$)
  - Charger Operation status
- Package
  - 36-pin 6mm × 5mm QFN

2 Applications

- Fire alarm control panel
- Anesthesia delivery system
- Battery backup unit (BBU)
- Elevator main control panel
- Emergency power supply
- HVAC gateway
- Intrusion control panel

3 Description

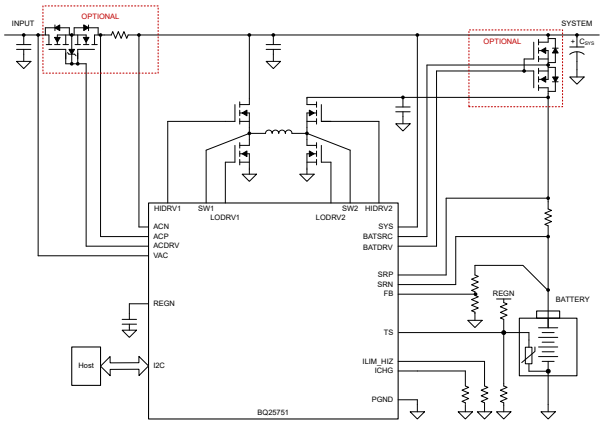
The BQ25751 is a wide input voltage, switched-mode buck-boost battery charge controller with direct power path control. The device offers high-efficiency battery charging over a wide voltage range with bulk, float and absorption charging for lead-acid batteries. The device integrates all the loop compensation for the buck-boost converter, thereby providing a high density solution with ease of use.

Besides the I²C host-controlled charging mode, the device also supports standalone charging mode via resistor programmable limits. Input current, charge current and charge voltage regulation targets can be set via the ILIM_HIZ, ICHG and FB pins, respectively.

Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)	BODY SIZE (NOM)
BQ25751	RRV (VQFN 36)	6.0mm x 5.0mm	6.0mm x 5.0mm

(1) For all available packages, see Section 14.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Simplified Schematic

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Device Comparison

PART NUMBER	BQ25856-Q1	BQ25756	BQ25750	BQ25751
Key Feature	Li-Ion, LFP, DRSS introduced, increased TSHUT → 150 C, automotive qualified	Li-Ion, LFP	Li-Ion, LFP	Lead Acid
Charger Topology	Buck-Boost	Buck-Boost	Buck-Boost	Buck-Boost
Power Topology	Non Power-Path	Non Power-Path	Power-Path	Power-Path
I^2C Address	0X6B	0X6B	0X6B	0X6B
Default Charge Profile	Li-Ion (trickle, precharge, CC, CV)	Li-Ion (trickle, precharge, CC, CV)	Li-Ion (trickle, precharge, CC, CV)	Pb-Acid (CC, CV-Absorb, CV-Float)
Configuration	I^2C + Standalone	I^2C + Standalone	I^2C + Standalone	I^2C + Standalone
Operating VIN	4.4V → 70V	4.4V → 70V	4.4V → 70V	4.4V → 70V
Pin Count	36	36	36	36
Package	5X6 QFN	5X6 QFN	5X6 QFN	5X6 QFN
TS Pin Function	JEITA profile	JEITA profile	JEITA profile	CV voltage change with -2mV/°C temp. co. at FB pin

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5 Pin Configuration and Functions

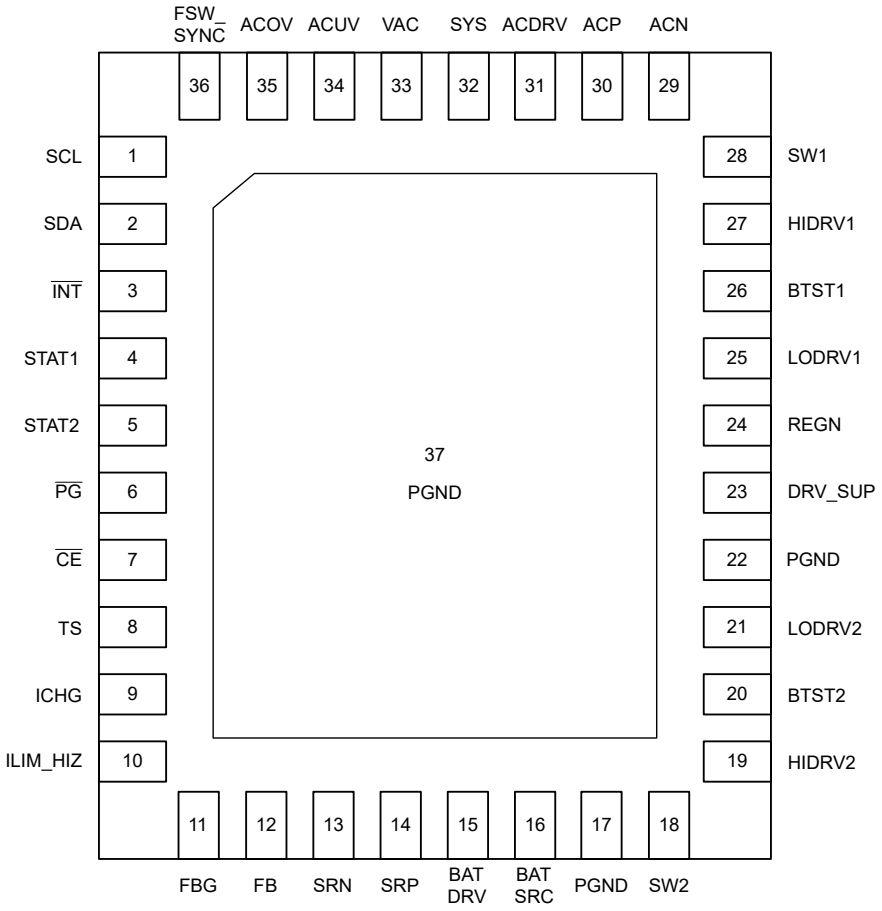


Figure 5-1. BQ25751, RRV Package 36-Pin VQFN Top View

Table 5-1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
SCL	1	I	**I²C Interface Clock –** Connect SCL to the logic rail through a 10kΩ resistor.
SDA	2	IO	**I²C Interface Data –** Connect SDA to the logic rail through a 10kΩ resistor.
$\overline{INT}$	3	O	**Open Drain Interrupt Output –** Connect the $\overline{INT}$ pin to a logic rail via 10kΩ resistor. The $\overline{INT}$ pin sends an active low, 256µs pulse to host to report the charger device status and faults.
STAT1	4	O	**Open Drain Charge Status 1 Output –** STAT1 and STAT2 indicate various charger operations, see Table 7-6. Connect to the pull up rail via 10kΩ resistor. The STAT1, STAT2 pin functions can be disabled when DIS_STAT_PINS bit is set to 1. When disabled, this pin can be used as a general purpose indicator via the FORCE_STAT1_ON bit.
STAT2	5	O	**Open Drain Charge Status 2 Output –** STAT1 and STAT2 indicate various charger operations, see Table 7-6. Connect to the pull up rail via 10kΩ resistor. The STAT1, STAT2 pin functions can be disabled when DIS_STAT_PINS bit is set to 1. When disabled, this pin can be used as a general purpose indicator via the FORCE_STAT2_ON bit.
$\overline{PG}$	6	O	**Open Drain Active Low Power Good Indicator –** Connect to the pull up rail via 10kΩ resistor. LOW indicates a good input source if VAC is within the programmed ACUV / ACOV operating window. The $\overline{PG}$ pin function can be disabled when DIS_PG_PIN bit is set to 1. When disabled, this pin can be used as a general purpose indicator via the FORCE_STAT3_ON bit.
$\overline{CE}$	7	IO	**Active Low Charge Enable Pin –** Battery charging is enabled when EN_CHG bit is 1 and $\overline{CE}$ pin is LOW. $\overline{CE}$ pin must be pulled HIGH or LOW, do not leave floating. The $\overline{CE}$ pin function can be disabled when DIS_CE_PIN bit is set to 1. When disabled, this pin can be used as a general purpose indicator via the FORCE_STAT4_ON bit.

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Table 5-1. Pin Functions (continued)

PIN		I/O	DESCRIPTION
NAME	NO.		
TS	8	I	**Temperature Qualification Voltage Input –** Connect a negative temperature coefficient thermistor. Program temperature window with a resistor divider from REGN to TS to PGND. Charge suspends when TS pin voltage is out of range. Recommend 103AT-2 10-kΩ thermistor.
ICHG	9	I	**Charge Current Limit Setting –** ICHG pin sets the maximum charge current, and can be used to monitor the charge current. A programming resistor to PGND is used to set the charge current limit as $I_{CHG} = K_{ICHG} / R_{ICHG}$. When the device is under charge current regulation, the voltage at ICHG pin is V_{REF_ICHG}. When ICHG pin voltage is less than V_{REF_ICHG}, the actual charge current can be calculated as: $IBAT = K_{ICHG} \times V_{ICHG} / (R_{ICHG} \times V_{REF_ICHG})$. The actual charge current limit is the lower of the limits set by ICHG pin or the ICHG_REG register bits. This pin function can be disabled when EN_ICHG_PIN bit is 0. If ICHG pin is not used, this pin must be pulled to PGND, do not leave floating.
ILIM_HIZ	10	I	**Input Current Limit Setting and HIZ Mode Control Pin –** ILIM_HIZ pin sets the maximum input current limit, can be used to monitor the input current and can be pulled HIGH to force device into HIZ mode. A programming resistor to PGND is used to set the input current limit as $I_{LIM} = K_{ILIM} / R_{ILIM}$. When the device is under input current regulation, the voltage at ILIM_HIZ pin is V_{REF_ILIM}. When ILIM_HIZ pin voltage is less than V_{REF_ILIM}, the actual input current can be calculated as: $IAC = K_{ILIM} \times V_{ILIM} / (R_{ILIM} \times V_{REF_ILIM})$. The actual input current limit is the lower of the limits set by ILIM_HIZ pin or the IAC_DPM register bits. This pin function can be disabled when EN_ILIM_HIZ_PIN bit is 0. If ILIM_HIZ pin is not used, this pin must be pulled to PGND, do not leave floating.
FBG	11	I	**Voltage Feedback Divider Return –** Connect to the bottom of battery feedback resistor. When charging, this pin is driven to PGND internally. When input voltage is outside of the ACUV / ACOV operating window, this pin is high-impedance, minimizing battery leakage current.
FB	12	I	**Charge Voltage Analog Feedback Adjustment –** Connect the output of a resistive voltage divider from the battery terminals to this node to adjust the output battery regulation voltage.
SRN	13	I	**Charge Current-Sense Resistor, Negative Input –** A 0.47-µF ceramic capacitor is placed from SRN to SRP to provide differential-mode filtering. An optional 0.1-µF ceramic capacitor is placed from the SRN pin to PGND for common-mode filtering.
SRP	14	I	**Charge Current-Sense Resistor, Positive Input –** A 0.47-µF ceramic capacitor is placed from SRN to SRP to provide differential-mode filtering. A 0.1-µF ceramic capacitor is placed from the SRP pin to PGND for common-mode filtering.
BATDRV	15	O	**N-Channel Battery FET Gate Drive –** Connect directly to the BATFET gate. Pin drives the gate with 10 V relative to BATSRC to turn on BATFET when the input voltage is outside of the ACUV / ACOV operating window. An optional capacitor from BATDRV to BATSRC can be used to slow down the turn on transition.
BATSRC	16	I	**N-Channel Battery FET Source –** Connect directly to the BATFET common source.
PGND	17	I	Tie this pin directly to PGND.
SW2	18	P	**Boost Side Half Bridge Switching Node –** Connect to the source of boost HS FET and the drain of boost LS FET. Connect the inductor between SW1 and SW2.
HIDRV2	19	O	**Boost Side High-Side Gate Driver –** Connect to the boost high-side N-channel MOSFET gate.
BTST2	20	P	**Boost Side High-Side Power MOSFET Gate Driver Power Supply –** Connect a capacitor between BTST2 and SW2 to provide bias to the high-side MOSFET gate driver.
LODRV2	21	O	**Boost Side Low-Side Gate Driver –** Connect to the boost low-side N-channel MOSFET gate.
PGND	22	P	**Power Ground Return –** The high current ground connection for the low-side gate drivers.
DRV_SUP	23	P	**Charger Gate Drive Supply Input –** Voltage on this pin is used to drive the gates of buck-boost converter switching FET. Connect a 4.7µF ceramic capacitor from DRV_SUP to power ground. REGN LDO voltage can be used as the gate driver supply for all switching FETs by connecting REGN to DRV_SUP pin. In high-voltage applications, it is possible to directly provide the DRV_SUP voltage with an external supply up to 12V to achieve higher switching efficiency. See Section 7.3.3.2 for more details.
REGN	24	P	**Charger Internal Linear Regulator Output –** Connect a 4.7µF ceramic capacitor from REGN to power ground. REGN LDO voltage can be used as the gate driver supply for all switching FETs by connecting REGN to DRV_SUP pin. In high-voltage applications, it is possible to directly provide the DRV_SUP voltage with an external supply up to 12V to achieve higher switching efficiency. See Section 7.3.3.2 for more details.
LODRV1	25	O	**Buck Side Low-Side Gate Driver –** Connect to the buck low-side N-channel MOSFET gate.
BTST1	26	P	**Buck Side High-Side Power MOSFET Gate Driver Power Supply –** Connect a capacitor between BTST1 and SW1 to provide bias to the high-side MOSFET gate driver.

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Table 5-1. Pin Functions (continued)

PIN		I/O	DESCRIPTION
NAME	NO.		
HIDRV1	27	O	**Buck Side High-Side Gate Driver –** Connect to the buck high-side N-channel MOSFET gate.
SW1	28	P	**Buck Side Half Bridge Switching Node –** Connect to the source of buck HS FET and the drain of buck LS FET. Connect the inductor between SW1 and SW2.
ACN	29	I	**Adapter Current-Sense Resistor, Negative Input –** A 0.47µF ceramic capacitor is placed from ACN to ACP to provide differential-mode filtering. An optional 0.1µF ceramic capacitor is placed from the ACN pin to PGND for common-mode filtering.
ACP	30	I	**Adapter Current-Sense Resistor, Positive Input –** A 0.47µF ceramic capacitor is placed from ACN to ACP to provide differential-mode filtering. A 0.1µF ceramic capacitor is placed from the ACP pin to PGND for common-mode filtering
ACDRV	31	O	**N-Channel Input FET Gate Drive –** Connect directly to the back-to-back input FETs (ACFETs) gates. Pin drives the gate with 10V to turn on ACFETs when the input voltage is inside of the ACUV / ACOV operating window. If input voltage is outside the valid operating window, this pin pulls to PGND to turn off the FETs. Connect a 15V Zener diode from ACDRV to the common source of the ACFETs.
SYS	32	I	**System voltage sense point –** Sense point for system voltage. If VAC is outside of the ACUV / ACOV operating window, the BATFET will only turn on once the SYS voltage falls below battery voltage (ideal-diode turn on). When Reverse Mode is enabled, this pin voltage is regulated to VSYS_REV.
VAC	33	P	**Input Voltage Detection and Power –** VAC is the input bias to power the IC. Connect a 1µF capacitor from pin to PGND.
ACUV	34	I	**AC Undervoltage Comparator Input –** Connect a resistor divider from VAC to PGND to program the undervoltage protection. When this pin falls below V_{REF_ACUV}, the device stops charging, disables the ACFETs and enables the BATFET. The hardware limit for input voltage regulation reference is V_{ACUV_DPM}. The actual input voltage regulation is the higher of the pin-programmed value and the VAC_DPM register value. If ACUV programming is not used, pull this pin to VAC, do not leave floating.
ACOV	35	I	**AC Overvoltage Comparator Input –** Connect a resistor divider from VAC to PGND to program the overvoltage protection. When this pin rises above V_{REF_ACOV}, the device stops charging, disables the ACFETs and enables the BATFET. If ACOV programming is not used, pull this pin to PGND, do not leave floating.
FSW_SYNC	36	I	**Switching Frequency and Synchronization Input –** An external resistor is connected to the FSW_SYNC pin and PGND to set the nominal switching frequency. This pin can also be used to synchronize the PWM controller to an external clock with 200kHz to 600kHz frequency.
Thermal Pad	37	P	**Exposed pad beneath the IC –** Always solder the thermal pad to the board, and have vias on the thermal pad plane star-connecting to PGND and ground plane for high-current power converter. It also serves as a thermal pad to dissipate the heat.

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Voltage	VAC, ACUV, ACOV, ACP, ACN, SYS, ACDRV, BATDRV, BATSRC, SRP, SRN, FB, FBG	–0.3	85	V
Voltage	SW1, SW2	–2	85	V
Voltage	$\overline{PG}$	–0.3	40	V
Voltage	BATDRV with respect to BATSRC	–0.3	12	V
Voltage	BTST1, HIDRV1 with respect to SW1	–0.3	14	V
Voltage	BTST2, HIDRV2 with respect to SW2	–0.3	14	V
Voltage	ACP with respect to ACN, SRP with respect to SRN	–0.3	0.3	V
Voltage	$\overline{CE}$, FSW_SYNC, ICHG, ILIM_HIZ, $\overline{INT}$, REGN, SCL, SDA, MODE, STAT1, $\overline{STAT2}$, TS	–0.3	6	V
Output Sink Current	$\overline{CE}$, $\overline{PG}$, STAT1, STAT2		5	mA
T_J	Junction temperature	–40	150	°C
T_{stg}	Storage temperature	–65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±2000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins(2)	±500	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

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6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{AC}	Input voltage	4.2		70	V
V_{BAT}	Battery voltage	0		70	V
V_{DRV_SUP}	DRV_SUP pin direct drive voltage range	4.0		12	V
F_{SW}	Switching Frequency	200		600	kHz
T_J	Junction temperature	–40		125	°C
T_A	Ambient temperature	–40		105	°C
C_{VAC}	VAC capacitor	1			µF
C_{IN}	Buck-boost input capacitance (minimum value after derating)	160			µF
C_{OUT}	Buck-boost output capacitance (minimum value after derating)	160			µF
C_{REGN}	REGN capacitor (nominal value before derating)	4.7			µF
C_{DRV_SUP}	DRV_SUP capacitor (nominal value before derating)	4.7			µF
L	Switched Inductor	2.2		15	µH
R_{DCR}	Inductor DC resistance	1.75		60	mΩ
R_{AC_SNS}	Input current sense resistor	0(1)	2	10	mΩ
R_{BAT_SNS}	Battery current sense resistor		5		mΩ
R_{ICHG}	ICHG programming pulldown resistor	0.0(2)		100	kΩ
R_{ILIM_HIZ}	ILIM_HIZ programming pulldown resistor	0.0(3)		50	kΩ

(1) When R_{AC_SNS} is 0mΩ, input current limit function is disabled
(2) When R_{ICHG} is pulled to GND, the hardware charge current limit is disabled, actual charge current is controlled by the ICHG_REG register setting
(3) When R_{ILIM_HIZ} is pulled to GND, the hardware input current limit is disabled, actual input current is controlled by the IAC_DPM register setting

6.4 Thermal Information

THERMAL METRIC(1)		BQ25751 RRV 36 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance (JEDEC(1))	29.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	18.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	9.9	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	0.2	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	9.8	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	2.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application note.

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6.5 Electrical Characteristics

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
QUIESCENT CURRENTS							
I_{SD_BAT}	Shutdown battery current with BATFET off (I_{SRN} + I_{SRP})	V_{BAT} = 28V, VAC = 0V, ADC_EN = 0, FORCE_BATFET_OFF = 1, T_J < 105 °C		10		µA	
I_{Q_BAT}	Quiescent battery current with BATFET on (I_{SRN} + I_{SRP})	V_{BAT} = 28V, VAC = 0V, ADC_EN = 0, T_J < 105 °C		17		µA	
		V_{BAT} = 28V, VAC = 0V, ADC_EN = 1, T_J < 105 °C		500	700	µA	
I_{HIZ_VAC}	HIZ input current (I_{VAC})	EN_HIZ = 1		10	30	µA	
I_{Q_VAC}	Quiescent input current (I_{VAC})	Not switching		0.75	1	mA	
I_{Q_REV}	Quiescent battery current in Reverse mode (I_{SRN} + I_{SRP})	Not switching		0.75	1	mA	
VAC / BAT POWER UP							
V_{VAC_OP}	VAC operating range		4.4		70	V	
V_{VAC_OK}	VAC converter enable threshold	VAC rising, no battery	4.4			V	
V_{VAC_OKZ}	VAC converter disable threshold	VAC falling, no battery			3.5	V	
V_{REF_ACUV}	ACUV comparator threshold to enter VAC_UVP	V_{ACUV} falling	1.095	1.1	1.106	V	
$V_{REF_ACUV_HYS}$	ACUV comparator threshold hysteresis	V_{ACUV} rising		50		mV	
$V_{VAC_INT_OV}$	VAC internal threshold to enter VAC_OVP	IN rising	72	74	76	V	
$V_{VAC_INT_OVZ}$	VAC internal thresholds to exit VAC_OVP	IN falling	69	71	73	V	
V_{REF_ACOV}	ACOV comparator threshold to enter VAC_OVP	V_{ACOV} rising	1.184	1.2	1.206	V	
$V_{REF_ACOV_HYS}$	ACOV comparator threshold hysteresis	V_{ACOV} falling		50		mV	
V_{SRN_OK}	Battery voltage to enable BATFET	V_{SRN} rising, no input			3.1	V	
V_{SRN_OKZ}	Battery voltage to disable BATFET	- V_{SRN} falling, no input	2.15		2.65	V	
CHARGE VOLTAGE REGULATION							
V_{VFB_RANGE}	Feedback voltage range		1.504		1.566	V	
V_{VFB_NOM}	Nominal feedback voltage	VFB_REG = 0x10		1.536		V	
V_{VFB_ACC}	Feedback voltage regulation accuracy	T_J = 0°C to 85°C	–0.5		0.5	%	
		T_J = -40°C to 125°C	–0.7		0.7	%	
V_{VFB_ABSORB}	Absorb phase charging voltage	Offset above V_{FB_REG}, VBAT_ABSORB[2:0] = 3		140		mV	
		Offset above V_{FB_REG}, VBAT_ABSORB[2:0] = 1		84		mV	
R_{FBG}	FBG resistance to PGND	I_{FBG} = 1mA		33	55	Ω	
FAST CHARGECURRENT REGULATION							
$I_{CHG_REG_RANGE}$	Charge current regulation range		0.4		20	A	

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6.5 Electrical Characteristics (continued)

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
$I_{CHG_REG_ACC}$	I^2C setting charge current regulation accuracy	R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V. ICHG_REG = 0x012C		15		A	
			–3		3	%	
		R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V. ICHG_REG = 0x0064		5		A	
			–3		3	%	
		R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V. ICHG_REG = 0x0028		2		A	
			–5		5	%	
K_{ICHG}	Hardware charge current limit set factor (Amperes of charge current per kΩ on ICHG pin)	R_{BAT_SNS} = 5mΩ, R_{ICHG} = 10kΩ, 5kΩ, and 3.33kΩ	48	50	52	A x kΩ	
V_{REF_ICHG}	ICHG pin voltage when ICHG pin is in regulation			2.0		V	
PRE-CHARGE CURRENT REGULATION							
CHARGE TERMINATION							
I_{TERM_RANGE}	Termination current range	V_{FB} = V_{VFB_REG}	0.25		10	A	
I_{TERM_ACC}	Termination current accuracy	R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V . ITERM = 0x001E		1.5		A	
			–7		7	%	
		R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V. ITERM = 0x000A		0.50		A	
			–20		20	%	
		R_{BAT_SNS} = 5mΩ, VBAT = 12V, 36V, 55V. ITERM = 0x0005		0.250		A	
			–50		50	%	
BATTERY VOLTAGE COMPARATORS							
INPUT CURRENT REGULATION							
$I_{IREG_DPM_ACC}$	I^2C setting input current regulation accuracy in forward mode	R_{AC_SNS} = 2mΩ, IAC_DPM = 0x00A0		20		A	
			–3		3	%	
		R_{AC_SNS} = 2mΩ, IAC_DPM = 0x0050		10		A	
			–4		4	%	
		R_{AC_SNS} = 2mΩ, IAC_DPM = 0x0028		5		A	
			–7		7	%	
K_{ILIM}	Hardware input current limit set factor (Amperes of input current per kΩ on ILIM_HIZ pin)	R_{AC_SNS} = 2mΩ, R_{ILIM} = 5kΩ, 2.5kΩ, and 1.67kΩ	48	50	52	A x kΩ	
$V_{REF_ILIM_HIZ}$	ILIM_HIZ pin voltage when ILIM_HIZ pin is in regulation			2.0		V	
$V_{IH_ILIM_HIZ}$	ILIM_HIZ input high threshold to enter HIZ mode	V_{ILIM_HIZ} rising	3.7			V	
INPUT VOLTAGE REGULATION							
$V_{VREG_DPM_RANGE}$	Input voltage DPM regulation range		4.4		65	V	
$V_{VREG_DPM_ACC}$	I^2C setting input voltage regulation accuracy	VAC_DPM = 0x076C		38		V	
			–2		2	%	
$V_{VREG_DPM_ACC}$	I^2C setting input voltage regulation accuracy in forward mode	VAC_DPM = 0x04E2		25		V	
			–2		2	%	
		VAC_DPM = 0x03B6		19		V	
			–2		2	%	
V_{ACUV_DPM}	ACUV pin voltage when in VDPM regulation		1.198	1.210	1.222	V	
REVERSE MODE VOLTAGE REGULATION							

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6.5 Electrical Characteristics (continued)

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V_{REV_RANGE}	SYS Voltage regulation range in Reverse mode		3.3		65	V	
V_{REV_ACC}	Voltage regulation accuracy in Reverse mode	VSYS_REV = 0x0960		48		V	
			–2		2	%	
		VSYS_REV = 0x0578		28		V	
			–2		2	%	
V_{REV_ACC}	VAC Voltage regulation accuracy in Reverse mode	VSYS_REV = 0x02EE		15		V	
			–2		2	%	
		VSYS_REV = 0x00FA		5		V	
			–2		2	%	
REVERSE MODE CURRENT REGULATION							
I_{IREV_ACC}	Input current regulation accuracy in Reverse mode	R_{AC_SNS} = 2mΩ, IAC_REV = 0x00A0		20		A	
			–3.5		3.5	%	
		R_{AC_SNS} = 2mΩ, IAC_REV = 0x0028		5		A	
			–5.5		5.5	%	
CHARGE MODE BATTERY-PACK NTC MONITOR							
V_{T1_RISE}	TS pin voltage rising T1 threshold, charge suspended above this voltage.	As Percentage to REGN, TS_T1=0°C w/ 103AT	72.75	73.25	73.85	%	
V_{T1_FALL}	TS pin voltage falling T1 threshold, charge re-enabled below this voltage.	As Percentage to REGN, TS_T1=0°C w/ 103AT	71.5	72	72.5	%	
V_{T5_FALL}	TS pin voltage falling T5 threshold, charge suspended below this voltage	As Percentage to REGN, TS_T5=60°C w/ 103AT	33.875	34.375	34.875	%	
V_{T5_RISE}	TS pin voltage rising T5 threshold. Charge back to ICHG and reduced V_{FB_REG} above this voltage.	As Percentage to REGN, TS_T5=60°C w/ 103AT	35	35.5	36	%	
REVERSE MODE BATTERY-PACK NTC MONITOR							
V_{BCOLD_RISE}	TS pin voltage rising TCOLD threshold. Reverse mode suspended above this voltage	As Percentage to REGN (BCOLD = –20°C w/ 103AT)	79.45	80.0	80.55	%	
V_{BCOLD_RISE}	TS pin voltage rising TCOLD threshold. Reverse mode suspended above this voltage	As Percentage to REGN (BCOLD = –10°C w/ 103AT)	76.65	77.15	77.65	%	
V_{BCOLD_FALL}	TCOLD comparator falling threshold.	As Percentage to REGN (–20°C w/ 103AT)	78.2	78.7	79.2	%	
V_{BCOLD_FALL}	TCOLD comparator falling threshold.	As Percentage to REGN (–10°C w/ 103AT)	75.5	75.6	76.5	%	
V_{BHOT_FALL}	TS pin voltage falling THOT threshold. Reverse mode suspends below this voltage	As Percentage to REGN, (BHOT = 55°C w/ 103AT)	37.2	37.7	38.2	%	
V_{BHOT_FALL}	TS pin voltage falling THOT threshold. Reverse mode suspends below this voltage	As Percentage to REGN, (BHOT = 60°C w/ 103AT)	33.875	34.375	34.875	%	
V_{BHOT_FALL}	TS pin voltage falling THOT threshold. Reverse mode suspends below this voltage	As Percentage to REGN, (BHOT 65°C w/ 103AT)	30.75	31.25	31.75	%	

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6.5 Electrical Characteristics (continued)

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V_{BHOT_RISE}	TS pin voltage rising THOT threshold. Reverse mode allowed above this voltage	As Percentage to REGN, (BHOT = 55°C w/ 103AT)	38.5	39.0	39.95	%	
V_{BHOT_RISE}	TS pin voltage rising THOT threshold. Reverse mode allowed above this voltage	As Percentage to REGN, (BHOT = 60°C w/ 103AT)	35	35.5	36	%	
V_{BHOT_RISE}	TS pin voltage rising THOT threshold. Reverse mode allowed above this voltage	As Percentage to REGN, (BHOT 65°C w/ 103AT)	32.0	32.5	33.0	%	
BATTERY CHARGER PROTECTION							
$V_{BAT_ABSORB_OV}$	Battery overvoltage threshold for Lead Acid Charging (SPEC only)	V_{FB} rising, as percentage of V_{FB_REG} + VBAT_ABSORB. EN_3_STAGE_CHARGE = 1, absorb charge stage		113		%	
$V_{BAT_ABSORB_OVZ}$	Battery overvoltage falling threshold for Lead Acid Charging (SPEC only)	V_{FB} falling, as percentage of V_{FB_REG} + VBAT_ABSORB. EN_3_STAGE_CHARGE = 1, absorb charge stage		111		%	
$V_{BAT_FLOAT_OV}$	Battery overvoltage threshold for Lead Acid Charging (SPEC only)	V_{FB} rising, as percentage of V_{FB_REG}. EN_3_STAGE_CHARGE = 1, float charge stage		113		%	
$V_{BAT_FLOAT_OVZ}$	Battery overvoltage falling threshold for Lead Acid Charging (SPEC only)	V_{FB} falling, as percentage of V_{FB_REG}. EN_3_STAGE_CHARGE = 1, float charge stage		111		%	
V_{ICHG_OC}	Battery charge over-current threshold	V_{SRP} - V_{SRN} rising	120		170	mV	
THERMAL SHUTDOWN							
T_{SHUT}	Thermal shutdown rising threshold	Temperature increasing		150		°C	
	Thermal shutdown falling threshold	Temperature decreasing		135		°C	
REGN REGULATOR AND GATE DRIVE SUPPLY (DRV_SUP)							
V_{REGN}	REGN LDO output voltage	IREGN = 20mA	4.8	5	5.2	V	
		VAC = 5V, IREGN = 20mA	4.35	4.6		V	
I_{REGN}	REGN LDO current limit	VREGN = 4.5V	70			mA	
V_{REGN_OK}	REGN OK threshold to allow switching	REGN rising		3.55		V	
V_{DRV_UVPZ}	DRV_SUP under-voltage threshold to allow switching	DRV_SUP rising			3.7	V	
V_{DRV_OVP}	DRV_SUP over-voltage threshold to disable switching	DRV_SUP rising	12.8	13.2	13.6	V	
POWER-PATH MANAGER							
V_{ACDRV_REG}	ACFET drive voltage	V_{ACDRV} - V_{VAC}, I_{ACDRV} = 10µA		10		V	
I_{ACDRV_ON}	ACFET charge pump current limit	V_{ACDRV} - V_{VAC} = 5V		40		µA	
I_{ACDRV_OFF}	ACFET turnoff current		3			mA	
V_{BATDRV_REG}	BATFET drive voltage	V_{BATDRV} - V_{BATSRC}, VAC = 0V, I_{BATDRV} = 10µA		10		V	
I_{BATDRV_REG}	BATFET charge pump current limit	V_{BATDRV} - V_{BATSRC} = 5V, VAC = 0V		40		µA	
I_{BATDRV_OFF}	BATFET turnoff current			400		µA	
I_{AC_LOAD}	VAC discharge load current		16			mA	
I_{BAT_LOAD}	Battery (SRP) discharge load current		16			mA	

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6.5 Electrical Characteristics (continued)

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
SWITCHING FREQUENCY AND SYNC							
f_{SW}	Switching Frequency	R_{FSW_SYNC} = 133kΩ	212	250	288	kHz	
		R_{FSW_SYNC} = 50kΩ	425	500	575	kHz	
V_{IH_SYNC}	FSW_SYNC input high threshold		1.3			V	
V_{IL_SYNC}	FSW_SYNC input low threshold				0.4	V	
PW_{SYNC}	FSW_SYNC input pulse width		80			ns	
PWM DRIVERS							
R_{HIDRV1_ON}	Buck side high-side turnon resistance	V_{BTST1} - V_{SW1} = 5V		3.4		Ω	
R_{HIDRV1_OFF}	Buck side high-side turnoff resistance	V_{BTST1} - V_{SW1} = 5V		1.0		Ω	
$V_{BTST1_REFRESH}$	Bootstrap refresh comparator threshold voltage	BTST1 falling, V_{BTST1} - V_{SW1} when low-side refresh pulse is requested	2.7	3.1	3.9	V	
R_{LODRV1_ON}	Buck side low-side turnon resistance	VREGN = 5V		3.4		Ω	
R_{LODRV1_OFF}	Buck side low-side turnoff resistance	VREGN = 5V		1.0		Ω	
t_{DT1}	Buck side dead time, both edges			45		ns	
R_{HIDRV2_ON}	Boost side high-side turnon resistance	V_{BTST2} - V_{SW2} = 5V		3.4		Ω	
R_{HIDRV2_OFF}	Boost side high-side turnoff resistance	V_{BTST2} - V_{SW2} = 5V		1.0		Ω	
$V_{BTST2_REFRESH}$	Bootstrap refresh comparator threshold voltage	BTST2 falling, V_{BTST2} - V_{SW2} when low-side refresh pulse is requested	2.7	3.1	3.9	V	
R_{LODRV2_ON}	Boost side low-side turnon resistance	VREGN = 5V		3.4		Ω	
R_{LODRV2_OFF}	Boost side low-side turnoff resistance	VREGN = 5V		1.0		Ω	
t_{DT2}	Boost side dead time, both edges			45		ns	
ANALOG-TO-DIGITAL CONVERTER (ADC)							
t_{ADC_CONV}	Conversion-time, each measurement	ADC_SAMPLE[1:0] = 00		24		ms	
		ADC_SAMPLE[1:0] = 01		12		ms	
		ADC_SAMPLE[1:0] = 10		6		ms	
ADC_{RES}	Effective resolution	ADC_SAMPLE[1:0] = 00	14	15		bits	
		ADC_SAMPLE[1:0] = 01	13	14		bits	
		ADC_SAMPLE[1:0] = 10	12	13		bits	
ADC MEASUREMENT RANGE AND LSB							
I_{AC_ADC}	Input current ADC reading (positive or negative)	Range with 2mΩ R_{AC_SNS}	–50000		50000	mA	
		LSB with 2mΩ R_{AC_SNS}		2		mA	
I_{BAT_ADC}	Battery current ADC reading (positive or negative)	Range with 5mΩ R_{BAT_SNS}	–20000		20000	mA	
		LSB with 5mΩ R_{BAT_SNS}		2		mA	
V_{AC_ADC}	Input voltage ADC reading	Range	0		65534	mV	
		LSB		2		mV	
V_{BAT_ADC}	Battery voltage ADC reading	Range	0		65534	mV	
		LSB		2		mV	

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6.5 Electrical Characteristics (continued)

VAC = ACP = ACN = SYS = SRP = SRN = 28V, T_J = -40°C to +125°C, and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V_{SYS_ADC}	System voltage ADC reading	Range	0		65534	mV	
		LSB		2		mV	
TS_{ADC}	TS voltage ADC reading, as percentage of REGN	Range	0		99.9	%	
		LSB		0.098		%	
V_{FB_ADC}	FB voltage ADC reading	Range	0		2047	mV	
		LSB		1		mV	
I²C INTERFACE (SCL, SDA)							
V_{IH}	Input high threshold level		1.3			V	
V_{IL}	Input low threshold level				0.4	V	
V_{OL}	Output low threshold level	Sink current = 5mA			0.4	V	
I_{IN_BIAS}	High-level leakage current	Pull up rail 3.3V			1	µA	
LOGIC I/O PIN ($\overline{CE}$, $\overline{PG}$, STAT1, STAT2)							
V_{IH}	Input high threshold level ($\overline{CE}$)		1.3			V	
V_{OL}	Output low threshold level ($\overline{CE}$, $\overline{PG}$, STAT1, STAT2)	Sink current = 5mA			0.4	V	
V_{IL}	Input low threshold level ($\overline{CE}$)				0.4	V	
I_{OUT_BIAS}	High-level leakage current ($\overline{CE}$, $\overline{PG}$, STAT1, STAT2)	Pull up rail 3.3V			1	µA	

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6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
VAC / BAT POWER UP					
t_{ACOV_DGL}	Enter ACOV deglitch time, ACOV rising		100		µs
t_{ACOVZ_DGL}	Exit ACOV deglitch time, ACOV falling		12		ms
t_{ACUV_DGL}	Enter ACUV deglitch time, ACUV falling		100		µs
t_{ACUVZ_DGL}	Exit ACUV deglitch time, ACUV rising		12		ms
BATTERY CHARGER					
t_{TERM_DGL}	Deglitch time for charge termination, V_{SRP} - V_{SRN} falling		220		ms
t_{TOPOFF}	Top-off timer accuracy, TOPOFF_TMR = 30 min	25.5	30	34.5	min
t_{CV_TIMER}	CV timer accuracy, CV_TMR = 10hr	8.5	10	11.5	hr
BATTERY-PACK NTC MONITOR					
t_{TS_DGL}	Deglitch time for TS threshold crossing		25		ms
MPPT TIMERS					
t_{FULL_SWEEP}	Full Panel Sweep timer accuracy, FULL_SWEEP_TMR = 10 min	8.5	10	11.5	min
I^2C INTERFACE					
f_{SCL}	SCL clock frequency			1000	kHZ
DIGITAL CLOCK AND WATCHDOG					
t_{LP_WDT}	I^2C Watchdog reset time (EN_HIZ = 1, WATCHDOG[1:0] = 160s)	100	160		s
t_{WDT}	I^2C Watchdog reset time (EN_HIZ = 0, WATCHDOG[1:0] = 160s)	130	160		s

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6.7 Typical Characteristics (BQ25751)

C_{VAC} = 160 µF, C_{OUT}= 160 µF, f_{SW} = 250 kHz, L = 10 µH, T_A = 25°C (unless otherwise specified)

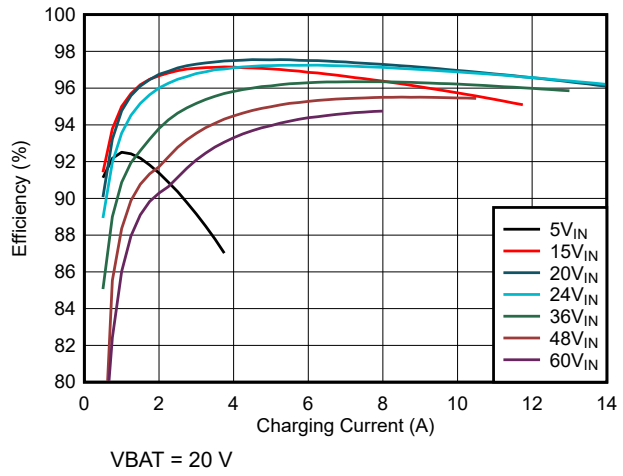


Figure 6-1. Charge Efficiency vs Charge Current (5s battery configuration)

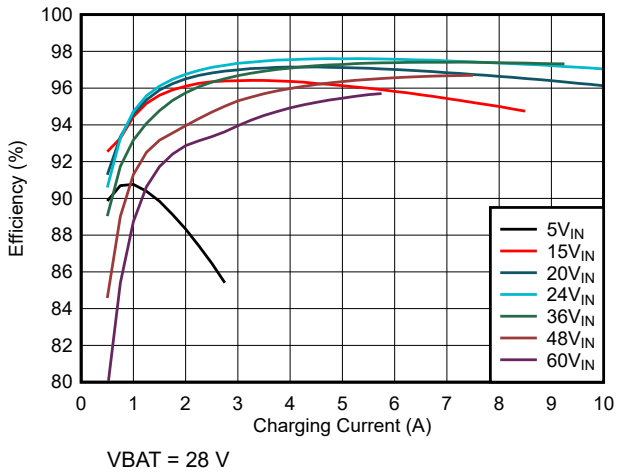


Figure 6-2. Charge Efficiency vs Charge Current (7s battery configuration)

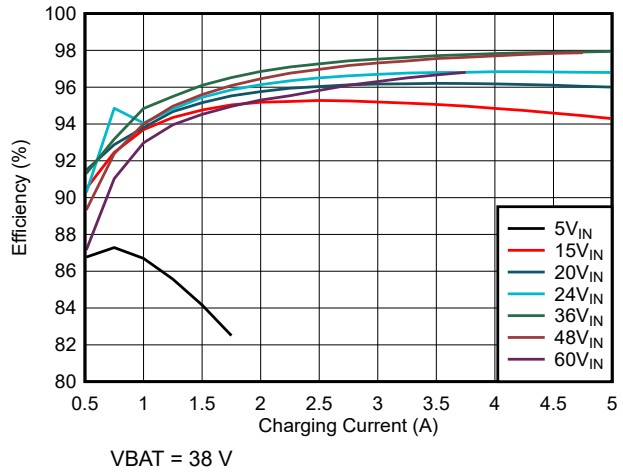


Figure 6-3. Charge Efficiency vs Charge Current (10s battery configuration)

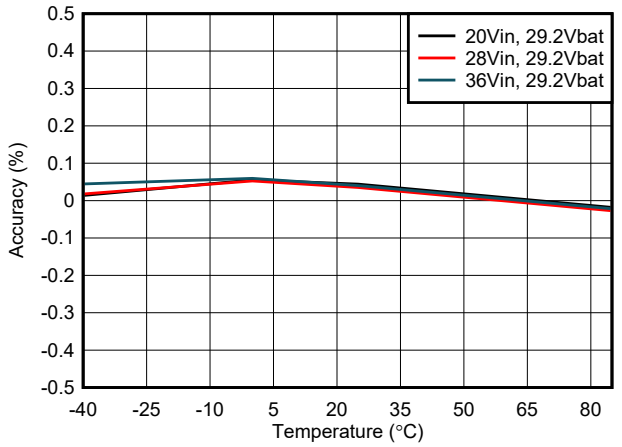


Figure 6-4. Charge Voltage Accuracy vs Temperature

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6.7 Typical Characteristics (BQ25751) (continued)

C_{VAC} = 160 µF, C_{OUT}= 160 µF, f_{SW} = 250 kHz, L = 10 µH, T_A = 25°C (unless otherwise specified)

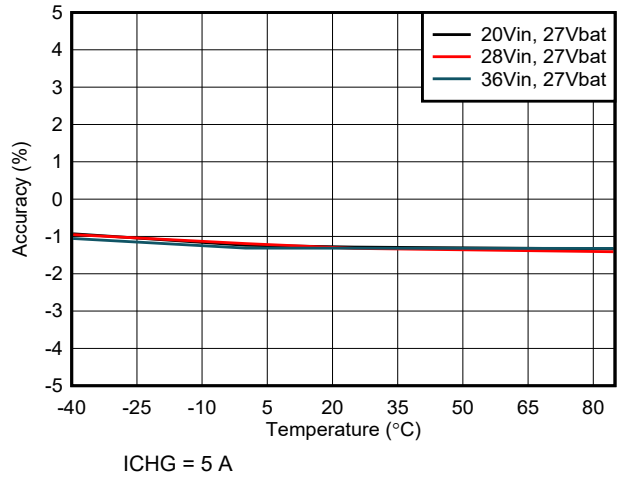


Figure 6-5. Charge Current Accuracy vs Temperature

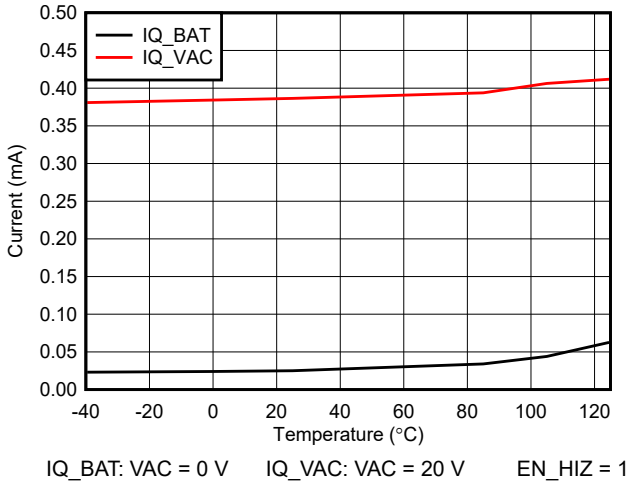


Figure 6-6. Battery and Input Quiescent Current vs Temperature with VBAT = 28 V

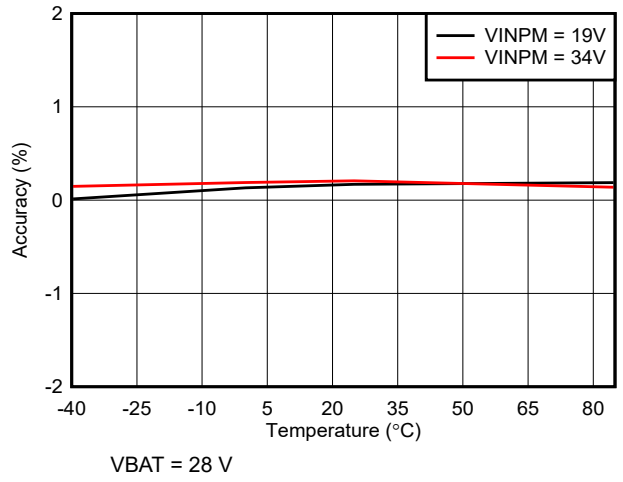


Figure 6-7. Input Voltage (VAC_DPM) Regulation Accuracy vs Temperature

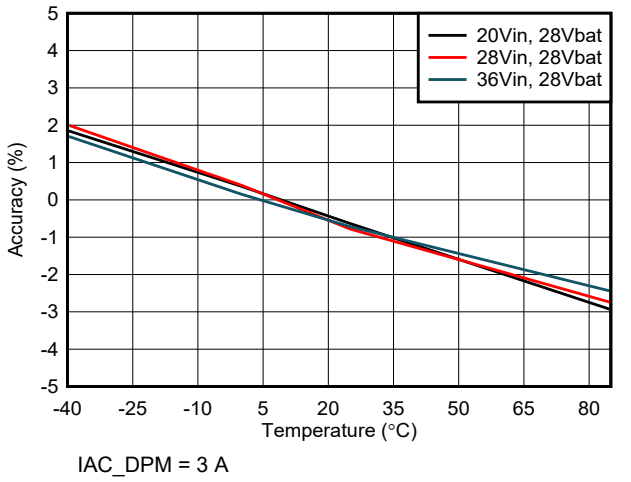


Figure 6-8. Input Current (IAC_DPM) Regulation Accuracy vs Temperature

6.7 Typical Characteristics (BQ25751) (continued)

C_{VAC} = 160 µF, C_{OUT}= 160 µF, f_{SW} = 250 kHz, L = 10 µH, T_A = 25°C (unless otherwise specified)

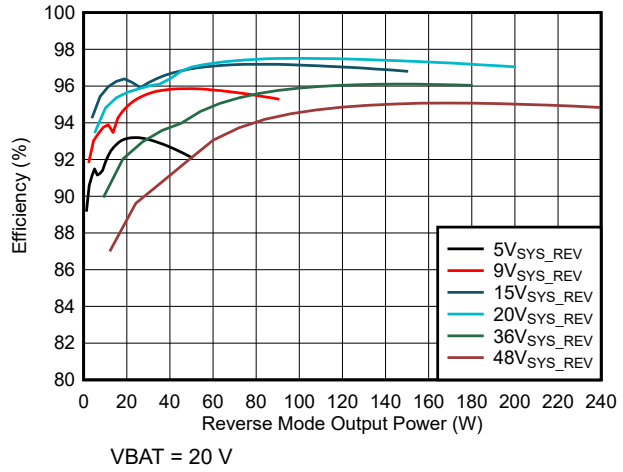


Figure 6-9. Reverse Mode Efficiency (5s battery configuration)

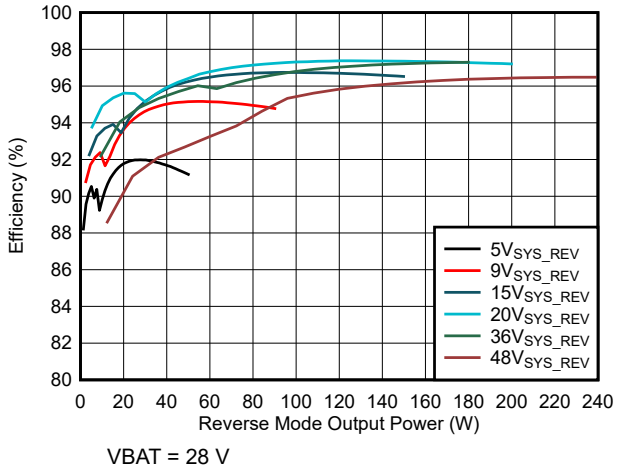


Figure 6-10. Reverse Mode Efficiency (7s battery configuration)

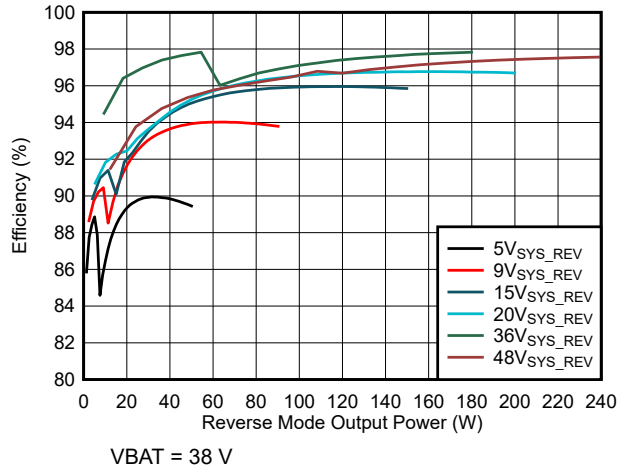


Figure 6-11. Reverse Mode Efficiency (10s battery configuration)

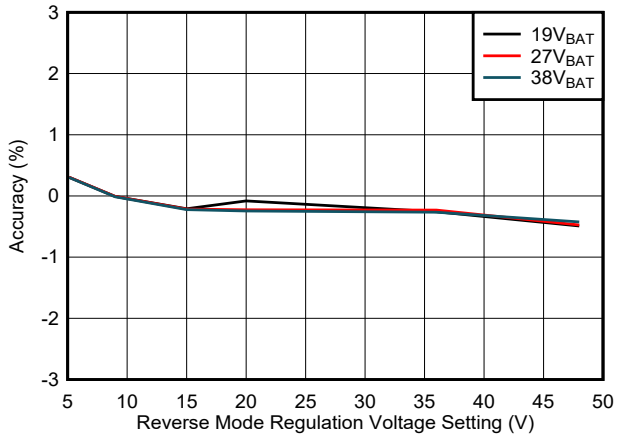


Figure 6-12. Reverse Mode Output Voltage Accuracy vs VAC_REV Setting

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7 Detailed Description

7.1 Overview

The BQ25751 is a wide input voltage, lead-acid switched-mode buck-boost battery charge controller with direct power path control. The device offers high-efficiency battery charging over a wide voltage range with accurate and programmable charge current and charge voltage regulation, in addition to automatic charge preconditioning, termination, and charge status indication. The device integrates all the loop compensation and 5V gate drivers for the buck converter, thereby providing a high density solution with ease of use. The switching frequency of the device can be programmed or forced to follow an external clock frequency via the FSW_SYNC pin. While switching under light-load the device offers an optional Pulse Frequency Modulation (PFM) mode to increase efficiency. The charger has a digital state machine that advances the charger's states as the converter analog feedback loops hand off control to each other. It also manages the fault protection comparators. The loops regulate and comparators compare against reference values in the I^2C registers, unless clamped by external resistors.

For Lead Acid battery chemistry, the device checks battery voltage and charges the battery in three different phases accordingly: constant current (CC), constant voltage absorption charging (CV), and constant voltage float charging (CV). The transition from absorb charging phase to float charging phase occurs when either the charge current is below termination current limit, or the CV timer expires. After this transition, the device remains in the float charging phase indefinitely.

The input operating window is programmed via the ACUV and ACOV pins. When the input voltage is outside the programmed window, the device automatically stops the charger, transitions to power the system load from the battery, and the $\overline{PG}$ pin pulls HIGH. In the absence of an input source, the device can power the system load from battery through BATFET or via reverse power flow, discharging the battery through the buck converter to generate a programmable, regulated voltage on system which is above or below the battery voltage.

The charger provides various safety features for battery charging and system operation, including battery temperature negative thermistor (NTC) monitoring, and over-voltage/over-current protections on battery and input. The thermal shutdown prevents charging when the junction temperature exceeds the T_{SHUT} limit.

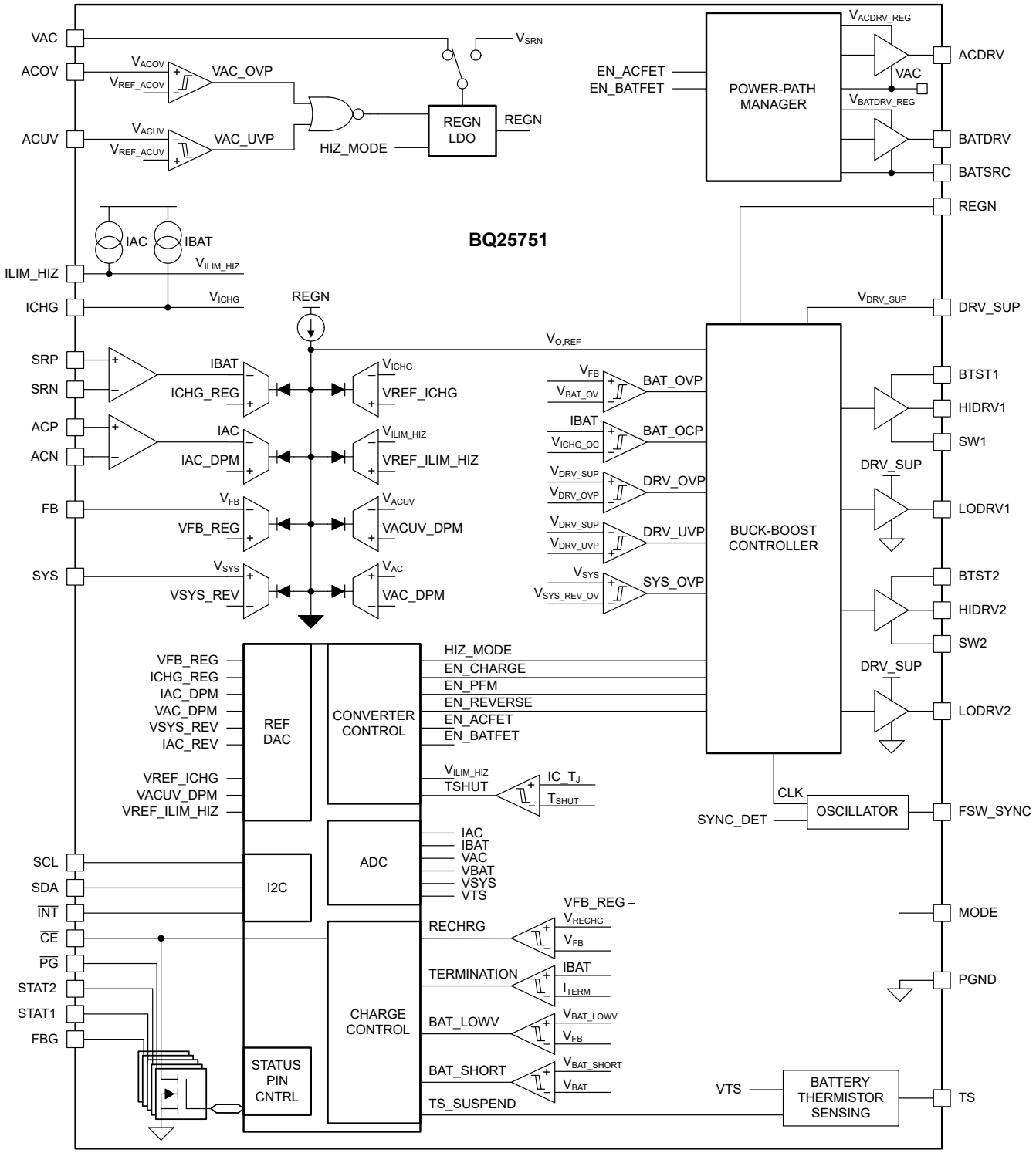
The device has three status pins (STAT1, STAT2, and $\overline{PG}$) to indicate the charging status and input voltage status. These pins can be used to drive LEDs or communicate with a host processor. If needed, these pins can also be used as general purpose indicators and their status controlled directly by the I^2C interface. In addition, the $\overline{CE}$ pin can also be used as a general purpose indicator. The $\overline{INT}$ pin immediately notifies host when the device status changes, including faults.

The device also provides a 16-bit analog-to-digital converter (ADC) for monitoring input current, charge current and input/battery/system/thermistor voltages (IAC, IBAT, VAC, VBAT, VSYS, TS).

The device comes with a 36-pin 5mm × 6mm QFN package with 0.5mm pin pitch.

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7.2 Functional Block Diagram



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7.3 Feature Description

7.3.1 Device Power-On-Reset

The internal bias circuits are powered from either VAC or SRN. When VAC rises above V_{VAC_OK}, the ACFET driver is active and charging is allowed. When BAT rises above 3V, the BATFET driver is active, and reverse mode operation is allowed.

A POR occurs when one of these supplies rises above its corresponding V_{OK} level, while the other supply is below its corresponding V_{OK} level. After the POR, I^2C interface is ready for communication and all the registers are reset to default value. The host can access all the registers after POR.

7.3.2 Device Power-Up From Battery Without Input Source

If only battery is present and the voltage is above V_{SRN_OK} threshold, the BATFET turns on and connects battery to system. The REGN LDO stays off to minimize the quiescent current. The N-type driver allows for use of low $R_{DS,ON}$ external BATFET, minimizing the conduction loss. The low quiescent current on BAT maximizes the battery run time. The ADC can be used to monitor discharge current through SRP and SRN pins. The BATFET can be forced to turn off via the FORCE_BATFET_OFF register bit.

7.3.3 Device Power Up from Input Source

When a valid input source (V_{VAC_OK} < VAC and VAC within the ACUV and ACOV operating window) is detected, the ACFET turns on to connect the input to the system, and the $\overline{PG}$ pin pulls LOW. If charging is enabled, the device proceeds to enable the REGN LDO and power up the buck converter.

7.3.3.1 VAC Operating Window Programming (ACUV and ACOV)

The VAC operating window can be programmed via the ACUV and ACOV pins using a three-resistor divider from VAC to PGND as shown in Figure 7-1.

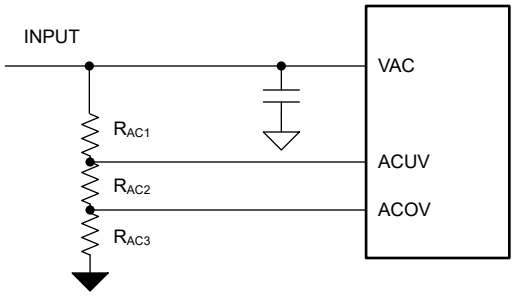


Figure 7-1. ACUV and ACOV Programming

When V_{ACUV} falls and reaches V_{ACUV_DPM}, the device enters input voltage regulation, thereby reducing the charge current. V_{ACUV} continues falling below V_{REF_ACUV}, the device automatically stops the converter, turns off the ACFET, turns on the BATFET and the $\overline{PG}$ pin pulls high.

System Note: if VAC_DPM register is programmed to a value higher than POR, the device regulates the VAC voltage to the higher of VAC_DPM register or V_{ACUV_DPM} pin voltage. Refer to Section 7.3.5.1.2 for more information.

When V_{ACOV} rises above V_{REF_ACOV}, the device automatically stops the converter, turns off the ACFET, turns on the BATFET and the $\overline{PG}$ pin pulls high.

The following equations govern the relationship between the resistor divider and the target operating voltage window programmed by ACOV and ACUV pins:

$$V_{ACOV_TARGET} = V_{REF_ACOV} \times \frac{R_{AC1} + R_{AC2} + R_{AC3}}{R_{AC3}} \quad (1)$$

$$V_{ACUV_TARGET} = V_{REF_ACUV} \times \frac{R_{AC1} + R_{AC2} + R_{AC3}}{R_{AC2} + R_{AC3}} \quad (2)$$

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If unused, tie ACUV to VAC and ACOV to PGND to apply the internal VAC operating window (V_{VAC_OP}).

7.3.3.2 REGN Regulator (REGN LDO)

The REGN LDO regulator provides a regulated bias supply for the IC and the TS external resistors. Additionally, REGN voltage can be used to drive the buck switching FETs directly by tying the DRV_SUP pin to REGN. The pull-up rail of $\overline{PG}$, STAT1, and STAT2 can be connected to REGN as well. The REGN LDO is enabled when below conditions are valid:

1. VAC voltage above V_{VAC_OK} and charge is enabled in forward mode.
2. BAT voltage above 3.8V in Reverse mode and Reverse Mode is enabled (EN_REV = 1)

At high input voltages and/or large gate drive requirements, the power loss from gate driving via the REGN LDO can be excessive. This power for the gate drivers can be provided externally by directly driving the DRV_SUP pin with a high efficiency supply ranging from 4.5V to 12V. This supply must be able to provide at least 50mA or more as required to drive the switching FET gate charge. When the converter is disabled, the DRV_SUP supply needs to be disabled such that BTST1/BTST2 and DRV_SUP pins are not biased.

The power dissipation for driving the gates via the REGN LDO is: $P_{REGN} = (VAC - V_{REGN}) \times Q_{G(TOT)1,2} \times f_{SW}$, where $Q_{G(TOT)1,2}$ is the sum of the total gate charge for all switching FETs and f_{SW} is the programmed switching frequency. The Safe Operating Area (SOA) below is based on a 1W power loss limit.

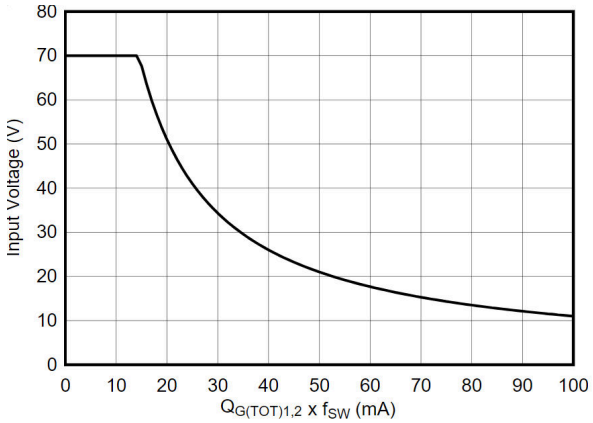


Figure 7-2. REGN LDO Safe Operating Area (SOA)

7.3.3.3 Compensation-Free Buck-Boost Converter Operation

The device integrates all the loop compensation, thereby providing a high density solution with ease of use. At startup, the device toggles the SW node for about 40ms to determine the correct compensation values for a given set of passives. If the battery is above VBAT_LOWV, then SW2 is toggled. SW1 is toggled otherwise.

The charger employs a synchronous buck-boost converter that allows charging from a wide range of input voltage sources. The charger operates in buck, buck-boost or boost mode. The converter can operate uninterruptedly and continuously across the three operation modes. During buck-boost mode, the converter alternates a SW1 pulse with a SW2 pulse, with effective switching frequency interleaved among these pulses for highest efficiency operation.

During boost mode operation, the HS FET is forced to turn on for 225ns in each switching cycle to ensure inductor energy is delivered to the output, effectively limiting the maximum boosting ratio. For example, when device is configured to switch at 500kHz, the switching period is 2µs, yielding a duty cycle limit of (1 - 0.225µs/2µs) = 88.75%. Given a 5V input, this translates to a maximum 44V output assuming 100% efficiency. The true output will be lower than this ideal limit. At lower switching frequencies, the maximum duty cycle increases, making the limitation less significant.

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Table 7-1. Switching MOSFET Operation

MODE	BUCK	BUCK-BOOST	BOOST
HS BUCK FET	Switching at f_{SW}	Switching (f_{SW} interleaved between SW1 and SW2)	ON
LS BUCK FET	Switching at f_{SW}	Switching (f_{SW} interleaved between SW1 and SW2)	OFF
LS BOOST FET	OFF	Switching (f_{SW} interleaved between SW1 and SW2)	Switching at f_{SW}
HS BOOST FET	ON	Switching (f_{SW} interleaved between SW1 and SW2)	Switching at f_{SW}

7.3.3.4 Light-Load Operation

To improve converter light-load efficiency, the device switches to Pulse Frequency Modulation (PFM) control at light load when the EN_PFM bit is set to 1. The effective switching frequency decreases accordingly when output load decreases.

EN_PFM bit is automatically cleared to 0 every time the converter starts and a valid SYNC clock input is detected on the FSW_SYNC pin, for fixed frequency operation regardless of output current. The bit can be overwritten to 1 to allow PFM after startup even when SYNC signal is present.

Light-load PFM mode can be disabled by clearing the EN_PFM bit. In this case, the device switches in PWM mode at a fixed switching frequency. It is recommended to disable PFM mode (EN_PFM = 0) when termination is enabled and set lower than 2A.

7.3.3.5 Switching Frequency and Synchronization (FSW_SYNC)

The device switching frequency can be programmed between 200kHz to 600kHz using a resistor from the FSW_SYNC pin to PGND. The R_{FSW} resistor is related to the nominal switching frequency (f_{SW}) by the equation:

$$R_{FSW} = \frac{1}{10 \times \left(f_{SW} \times 5 \times 10^{-12} - 500 \times 10^{-9}\right)} \quad (3)$$

This pin must be pulled to PGND using a R_{FSW}, do not leave floating. In addition to programming the nominal switching frequency, the FSW_SYNC pin can also be used to synchronize the internal oscillator to an external clock signal. The synchronization feature works over the same range as the switching frequency: 200kHz to 600kHz range.

Table 7-2. Common R_{FSW} and Switching Frequency Values

R_{FSW} (kΩ)	SWITCHING FREQUENCY (kHz)
200	200
133	250
100	300
80	350
66.67	400
57.1	450
50	500
44.4	550
40	600

7.3.3.6 Device HIZ Mode

When a valid input supply is present, it is possible to force the device into HIZ Mode which disables switching, disables the REGN LDO, turns off the ACFET, turns on the BATFET. The system load is provided by the battery in this mode. The device draws less than I_{HIZ_VAC} from the input supply in this mode. The charger enters HIZ Mode when EN_HIZ bit is set to 1 or the pin is pulled above $V_{IH_ILIM_HIZ}$ (refer to Section 7.3.5.1.1.1).

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If the device is operating in reverse mode with the converter turned on, and the device enters HIZ mode (EN_HIZ bit is set to 1 or pin is pulled above $V_{IH_ILIM_HIZ}$), switching stops and the system load is provided by the battery through the BATFETs. Once HIZ mode condition is cleared by the host, the device resumes reverse mode operation, powering the system through the converter with the BATFET off.

The device exits HIZ Mode when the EN_HIZ bit is cleared to 0 and the pin is pulled below 0.4V.

7.3.4 Battery Charging Management

The device charges 6-V up-to 48-V Lead Acid batteries. The charge cycle is autonomous and requires no host interaction.

7.3.4.1 Autonomous Charging Cycle

When battery charging is enabled (EN_CHG bit =1 and $\overline{CE}$ pin is LOW), the device autonomously completes a charging cycle without host involvement. The device charging parameters can be set by hardware through the FB pin to set regulation voltage and the ICHG pin to set charging current. The host can always control the charging operation and optimize the charging parameters by writing to the corresponding registers through I^2C.

Table 7-3. Lead Acid Charging Parameter Default Settings

DEFAULT MODE	BQ25751
Charge Stages	Fast Charge (CC) → Absorb Charge → Float Charge
FB Voltage Regulation Target (VFB_REG) - Float Voltage	1.536V
Absorb Voltage	109.1% x VFB_REG = 1.6758V
Charging Current	ICHG
Termination Current	10% x ICHG
CV Timer	5 hr
NTC Temperature Float Voltage Compensation (at battery)	-3mV/°C/cell (1-cell = ~2.2V)
Safety Timer	Disabled

A new charge cycle starts when the following conditions are valid:

- VAC is within the ACUV and ACOV operating window
- Device is not in HIZ mode (EN_HIZ = 0 and ILIM_HIZ pin voltage is below $V_{IH_ILIM_HIZ}$)
- REGN is above V_{REGN_OK}
- Battery charging is enabled (EN_CHG = 1 and $\overline{CE}$ pin is LOW)
- No thermistor fault on TS
- No safety timer fault

For lead acid battery charging (EN_3_STAGE_CHARGE = 1), the charger device automatically transitions from Absorb phase to Float voltage phase when the charging current is below termination threshold, and device is not in DPM mode. In addition, the device offers a dedicated CV timer to transition from Absorb to Float stage after a programmable period (CV_TMR bits) regardless of the charge current value. The device remains in the Float stage indefinitely. A new charge cycle can be initiated by toggle of either $\overline{CE}$ pin or EN_CHG bit. In addition, the device offers a dedicated CV timer to stop the charging after a programmable period (CV_TMR bits) in CV mode, regardless of the charge current value.

The status register (CHARGE_STAT) indicates the different charging phases as:

- 000 – Not Charging
- 011 – Fast-charge (CC mode)
- 100 – Absorb Charge (CV mode)
- 101 – Float Charge (CV mode)
- 110 – Top-off Timer Active Charging
- All other codes are RESERVED

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When the charger transitions to any of these states, including when charge cycle is completed, an INT pulse is asserted to notify the host.

For supercapacitor charging, the charger outputs ICHG current as long as the feedback voltage (V_{FB}) is below VFB_REG. The following settings are recommended for supercapacitor charging:

- EN_TERM = 0

7.3.4.1.1 Charge Current Programming (ICHG pin and ICHG_REG)

There are two distinct thresholds to limit the charge current (if both are enabled, the lowest limit of these will apply):

1. ICHG pin pull down resistor (hardware control)
2. ICHG_REG register bits (host software control)

To set the maximum charge current using the ICHG pin, a pull-down resistor to PGND is used. It is required to use a 5-mΩ R_{BAT_SNS} sense resistor. The charge current limit is controlled by:

$$I_{CHG_MAX} = \frac{K_{ICHG}}{R_{ICHG}} \quad (4)$$

The actual charge current limit is the lower value between ICHG pin setting and I^2C register setting (ICHG_REG). For example, if the register setting is 10 A (0xC8), and ICHG pin has a 10kΩ resistor (K_{ICHG} = 50AkΩ) to ground for 5A, the actual charge current limit is 5A. The device regulates ICHG pin at V_{REF_ICHG}. If ICHG pin voltage exceeds V_{REF_ICHG}, the device enters charge current regulation.

The ICHG pin can also be used to monitor charge current when device is not in charge current regulation. When not in charge current regulation, the voltage on ICHG pin (V_{ICHG}) is proportional to the actual charging current. ICHG pin can be used to monitor battery current with the following relationship:

$$I_{BAT} = \frac{K_{ICHG} \times V_{ICHG}}{R_{ICHG} \times V_{REF_ICHG}} \quad (5)$$

For example, if ICHG pin is set with 10-kΩ resistor, and the ICHG voltage 1.0V, the actual charge current is between 2.4A to 2.6A (based on K_{ICHG} specified).

If ICHG pin is shorted to PGND, the charge current limit is set by the ICHG_REG register. If hardware charge current limit function is not needed, it is recommended to short this pin to PGND. The ICHG pin function can be disabled by setting the EN_ICHG_PIN bit to 0 (recommended when pin is shorted to PGND). When the pin is disabled, charge current limit and monitoring functions via ICHG pin are not available.

To set the maximum charge current using the ICHG_REG register bits, write to the ICHG_REG register bits. The charge current limit range is from 400mA to 20,000mA with 50mA/step. The default ICHG_REG is set to maximum code, allowing ICHG pin to limit the current in hardware.

7.3.4.2 Lead Acid Battery Charging Profile

The device charges the battery in three phases: constant current, absorb voltage, and float voltage charging. At the beginning of a charging cycle, the device checks the battery voltage and regulates current/voltage accordingly. The table below summarizes the register bit recommendations to configure the device as a Lead-Acid battery charger.

Table 7-4. Recommended Lead Acid Charge Settings

PARAMETER	I2C REGISTER BITS	VALUE	EQUIVALENT PER 13.2V FLOAT V
Three-Stage Charging Control	EN_3_STAGE_CHARGE	1	N/A
Absorb Voltage	VBAT_ABSORB	0x3 = 140mV + VFB_REG	14.4V
Absorb Timer	CV_TMR	0x5 = 5hr	N/A

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Table 7-4. Recommended Lead Acid Charge Settings (continued)

PARAMETER	I2C REGISTER BITS	VALUE	EQUIVALENT PER 13.2V FLOAT V
Temperature Compensated Charging	EN_VREG_TEMP_COMP	1	-18mV/ºC

If the charger device is in DPM regulation during charging, the actual charging current will be less than the programmed value. In this case, Absorb to Float transition through termination comparator is temporarily disabled. The device will remain in Absorb phase until either the battery current drops below the ITERM threshold or the CV timer expires. After the Absorb phase, the charge voltage drops to V_{FB_REG}, where it remains indefinitely.

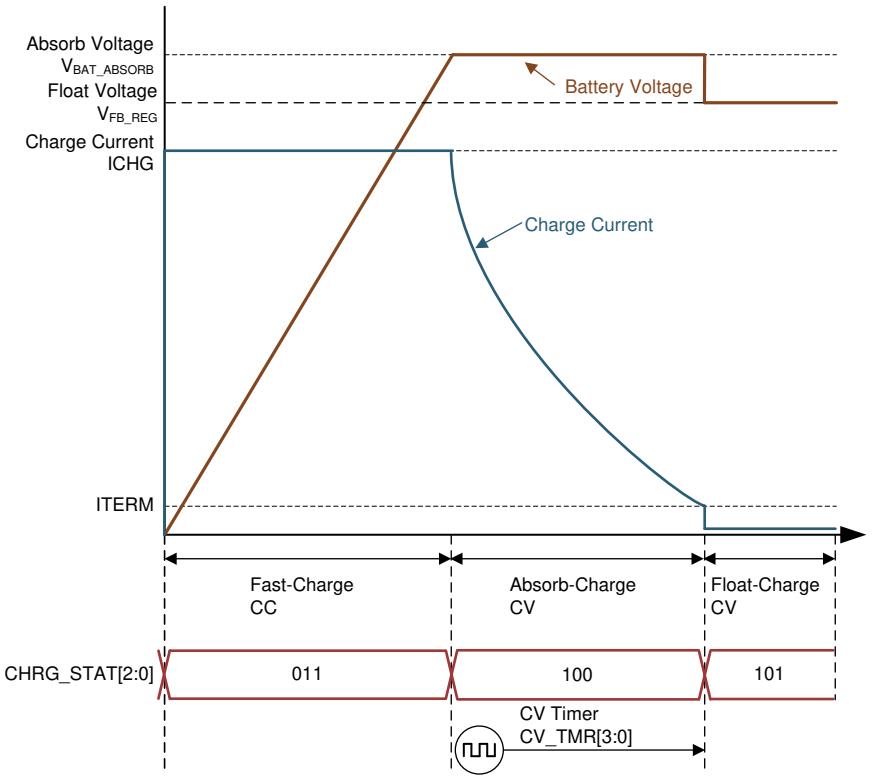


Figure 7-3. Typical Pb-Acid Battery Charging Profile

7.3.4.3 Absorb Charge to Float Charge for Lead-Acid

The device uses the termination comparator to transition from absorb charge to float charge when charging a lead-acid battery. The threshold is reached when the battery voltage is in absorb phase regulation, and the current is below termination current. The termination current threshold is controlled by the lower option between the 10% of ICHG pin setting or the ITERM register setting.

In standalone applications using the ICHG pin to program the current, the termination threshold is set at 10% of the ICHG pin value (10A ICHG pin programming results in 1A termination). The termination is detected when the ICHG pin voltage drops below V_{REF_ITERM}.

In host-controlled applications, the termination current can be programmed using the ITERM register bits. The ICHG pin can still be used to set a hardware limit for the charge current.

When termination occurs, the device reduces battery voltage to float charge regulation, the status register CHRG_STAT is set to 101, and an INT pulse is asserted to the host. Termination is temporarily disabled when the charger device is in input current, or input voltage regulation. Termination can be permanently disabled by

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writing 0 to EN_TERM prior to charge termination. In this case, the device can still exit the absorb phase voltage when the CV timer expires. Refer to Section 7.3.4.4 for more details.

At low termination currents, due to the comparator offset, the actual termination current may be significantly than the termination target. In order to compensate for comparator offset, a programmable top-off timer (default disabled) can be applied after termination is detected. The top-off timer will follow safety timer constraints, such that if safety timer is suspended, so will the top-off timer. Similarly, if safety timer is doubled, so will the top-off timer. CHRG_STAT reports whether the top off timer is active via the 110 code. Once the Top-Off timer expires, the CHRG_STAT register is set to 111 and an INT pulse is asserted to the host. Note that if CV timer expires while device is in Top-Off timer mode, the device will immediately transition from absorb charge voltage to float charge voltage.

7.3.4.4 CV Timer

In some applications, such as batteries with high-leakage or batteries in parallel with a system load, the battery current may never reach the ITERM threshold while in CV mode. The device offers a dedicated CV timer to control the amount of time the charger stays in absorb phase. This is especially important for lead-acid batteries, where limiting the exposure of the battery terminals to absorb voltage is ideal.

The CV timer begins counting when the device enters the absorb phase , and its duration can be programmed through the CV_TMR register bits. Note that CV_TMR = 0 disables the timer altogether. The CV timer is an absolute timer.

During faults which disable charging or when device falls out of CV regulation due to IAC_DPM or VAC_DPM, the CV timer is suspended. Once the device return to CV mode, the CV timer resumes. If the charging cycle is stopped and started again, the timer gets reset (toggle $\overline{CE}$ pin or EN_CHG bit restarts the timer).

An INT is asserted to the host when CV timer expires, and can be masked via the CV_TMR_MASK bit.

7.3.4.5 Thermistor Qualification

The charger device provides a single thermistor input for battery temperature monitor.

7.3.4.5.1 Temperature Compensated Charging

To improve the safety of charging lead-acid batteries, the target regulation voltage is modified in accordance with the battery temperature. The device provides a -3mV/ºC/cell temperature coefficient when using the recommended AT103-2 thermistor (10kΩ, β = 3435K). The FB pin temperature coefficient is -2mV/ºC. The battery temperature affects the targets for both the absorb phase charging voltage as well as the float phase charging voltage. This feature is controlled by the EN_VREG_TEMP_COMP register bit.

Table 7-5. Recommended I2C settings for Temperature Compensated Charging

BIT NAME	BIT VALUE
EN_VREG_TEMP_COMP	1
EN_TS	1

When EN_VREG_TEMP_COMP = 1, the device implements the temperature compensated charging. In this case, the TS_COOL (V_{T2} < V_{TS} < V_{T1}) and TS_WARM (V_{T5} < V_{TS} < V_{T3}) regions are ignored, and the device continues charging with the V_{FB_REG} temperature compensated value until the TS falls outside the COLD/HOT (V_{T1}/V_{T5}) thresholds.

When temperature compensation is enabled, the device will automatically enable the ADC to measure the TS pin every two seconds. The EN_ADC register bit will be set high and TS_ADC_DIS bit will be cleared. Because the ADC is used to sense the cell temperature and correct the voltage, the TS_ADC_DIS bit is inactive when the EN_VREG_TEMP_COMP bit is set to 1. To reduce power, host can disable other ADC channels. The device will not alter other bits in the register such as ADC_RATE, ADC_SAMPLE, ADC_AVG, ADC_AVG_INIT. It is recommended to leave those registers in their default state when using temperature compensated charging.

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7.3.4.5.2 Cold/Hot Temperature Window in Reverse Mode

For battery protection during reverse or auto-reverse mode operation, the device monitors the battery temperature to be within the VBCOLD to VBHOT thresholds. When temperature is outside of the thresholds, the reverse mode is shut off and device returns to powering the system from the battery. In addition, the EN_REV , EN_AUTO_REV and REVERSE_STAT bits are cleared to 0 and corresponding TS_STAT is reported (TS Cold or TS Hot). The temperature protection in reverse mode can be completely disabled by clearing the EN_TS bit to 0.

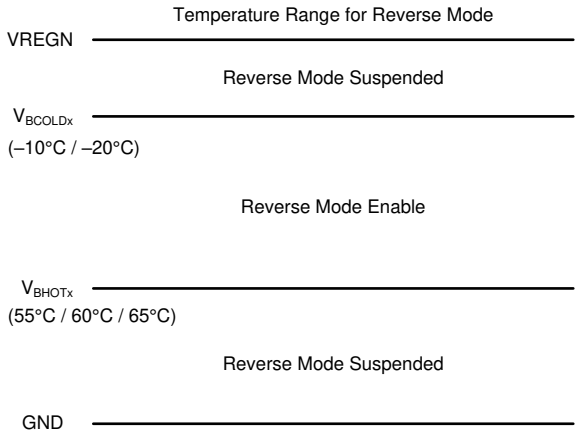


Figure 7-4. TS Pin Thermistor Sense Threshold in Reverse Mode

7.3.5 Power Path Management

The device accommodates a wide range of input sources from 4.4V up to 70V. The device provides dynamic power management and automatic power path selection to supply the system (SYS) from input source (VAC), or battery (BAT).

7.3.5.1 Dynamic Power Management: Input Voltage and Input Current Regulation

The device features Dynamic Power Management (DPM), which continuously monitors the input current and input voltage. When input source is over-loaded, either the current exceeds the input current limit (lower of IAC_DPM or pin setting), or the voltage falls below the input voltage limit (higher of VAC_DPM or ACUV pin setting, V_{ACUV_DPM}). The device then reduces the charge current until the input current falls below the input current limit and the input voltage rises above the input voltage limit.

When the charge current is reduced to zero, but the input source is still overloaded, the input voltage continues to drop. Once the input voltage drops below the ACUV limit ($V_{ACUV} < V_{REF_ACUV}$), the charger stops switching and the device automatically transitions to Battery Only Mode so that the system is supported by the battery.

7.3.5.1.1 Input Current Regulation

The total input current is a function of the system supply current and the battery charging current. System current normally fluctuates as portions of the systems are powered up or down. Without DPM, the source must be able to supply the maximum system current and the maximum charger input current simultaneously. By using DPM, the battery charger reduces the charging current when the input current exceeds the input current limit set by the lower of IAC_DPM register bits, or pin. This allows the current capability of the input source to be lowered, reducing system cost.

There are two thresholds to limit the input current (if both are enabled, the lower limit of these two will apply):

1. IAC_DPM register bits (host software control)
2. pull down resistor (hardware control)

The default IAC_DPM is set to maximum code, allowing pin to limit the current in hardware.

To set the maximum current using the pin, refer to Section 7.3.5.1.1.1.

For example, using a 5mΩ resistor yields programmability from 400mA to 20A with 50mA/step.

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7.3.5.1.1.1 ILIM_HIZ Pin

To set the maximum input current using the ILIM_HIZ pin, a pull-down resistor to PGND is used. When using a 2mΩ R_{AC_SNS} resistor, the input current limit is controlled by: $I_{AC_MAX} = K_{ILIM} / R_{ILIM_HIZ}$.

The actual input current limit is the lower value between ILIM_HIZ pin setting and register setting (IAC_DPM). For example, if the register setting is 20A, and ILIM_HIZ pin has a 5kΩ resistor (K_{ILIM} = 50AkΩ) to ground for 10A, the actual input current limit is 10A. ILIM_HIZ pin can be used to set the input current limit when EN_ILIM_HIZ_PIN bit is set to 1. The device regulates the pin at $V_{REF_ILIM_HIZ}$. If pin voltage exceeds $V_{REF_ILIM_HIZ}$, the device enters input current regulation. Entering input current regulation through the pin sets the IAC_DPM_STAT and FLAG bits, and produces an interrupt to host. The interrupt can be masked via the IAC_DPM_MASK bit.

The ILIM_HIZ pin can also be used to monitor input current. When not in input current regulation, the voltage on ILIM_HIZ pin (V_{ILIM_HIZ}) is proportional to the input current. Pin voltage can be used to monitor input current with the following relationship: IAC = K_{ILIM} x V_{ILIM_HIZ} / (R_{ILIM_HIZ} x $V_{REF_ILIM_HIZ}$).

If ILIM_HIZ pin is shorted, the input current limit is set by the IAC_DPM register. If hardware input current limit function is not needed, it is recommended to short this pin to GND. If ILIM_HIZ pin is pulled above $V_{IH_ILIM_HIZ}$, the device enters HIZ mode (refer to Section 7.3.3.6). The ILIM_HIZ pin function can be disabled by setting the EN_ILIM_HIZ_PIN bit to 0. When the pin is disabled, input current limit and monitoring functions as well as HIZ mode control via the pin are not available.

K_{ILIM} is defined as 50A×kΩ referenced to a 2mΩ sense resistor. A larger sense resistor provides a larger sense voltage and higher regulation accuracy, but changes the gain from the ILIM_HIZ pin. For example, using a 5mΩ resistor yields K_{ILIM} = 50 (A×kΩ) × 2 (mΩ) / 5 (mΩ) = 20 (A×kΩ).

7.3.5.1.2 Input Voltage Regulation

In addition to input current regulation, the device also offers input voltage regulation to limit the input power. This is especially useful when dealing with input sources such as solar panels, where the operating voltage must be controlled to extract the maximum power. Alternatively, if the input source current limitation is not known, input voltage regulation can be used to limit the power draw from the input source. By using input voltage regulation, the battery charger reduces the charging current when the input voltage falls below the input voltage limit set by the higher of VAC_DPM register bits, or ACUV pin.

There are two thresholds to limit the input voltage (the higher limit of these will apply)

1. VAC_DPM register bits (host software control)
2. ACUV pin falling threshold (hardware control)

To set the minimum input voltage using the VAC_DPM register bits, write the desired value directly to the VAC_DPM register bits. The default VAC_DPM is set to minimum code, allowing ACUV pin to limit the input voltage in hardware.

To set the minimum input voltage using the ACUV pin, refer to Section 7.3.3.1.

7.3.5.1.2.1 Max Power Point Tracking (MPPT) for Solar PV Panel

When EN_MPPT bit is 1, the device provides a maximum power point tracking (MPPT) algorithm for solar PV panel input sources. The Input Power Maximizer algorithm finds and tracks the maximum power point with full panel sweeps.

The full panel sweep is used to find the input operating voltage which delivers the maximum charge current to the battery. Before running a full panel sweep, the device momentarily enters HIZ mode to measure input source open-circuit voltage (V_{OC}). The device proceeds to reduce the input voltage regulation target, measuring the charge current output at each setting. The VAC_DPM register is used to program the minimum voltage to exit the full panel sweep. After the sweep is complete, the device updates the VAC_MPP register to the input voltage regulation value producing the maximum charge current. The device then waits for a period of FULL_SWEEP_TMR[1:0] before performing a new full panel sweep. A full panel sweep can be forced at any time by setting the FORCE_SWEEP bit to 1. Note that EN_MPPT = 1 is required for FORCE_SWEEP to work.

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The FORCE_SWEEP bit is automatically cleared to 0 after the full panel sweep is completed. Note that the device uses the internal ADC to determine the charge current at each step of the full panel sweep, therefore writes to the IBAT_ADC_DIS bit are ignored while MPPT is enabled (EN_MPPT = 1).

Note that when the system is directly connected to the input supply, the device cannot limit the system load. Therefore, the MPPT algorithm may not find and track the true MPP under all conditions. To enable MPPT operation, it is recommended to connect the system load directly in parallel to the battery pack.

The EN_VREG_TEMP_COMP bit must be disabled i.e., 0b to successfully run a full panel sweep and utilize the MPPT function.

7.3.5.2 Ideal Diode BATFET Control

When the device transitions into battery-only mode, the BATFET turns on with ideal diode control (if EN_BATFET_IDEAL_DIODE = 1) to prevent reverse current flowing into the battery when the system is higher than the battery voltage. The BATFET gate is regulated with a higher voltage to reduce R_{DSON} until the BATFET is in full conduction. At this point onwards, the BATFET V_{DS} linearly increases with discharge current.

System Note: Ideal diode mode can take a long time to enable the FET, therefore it is only recommended when using a single BATFET with body diode to support the transition. When ideal diode mode is disabled (EN_BATFET_IDEAL_DIODE = 0), the device turns on the BATFET gate with I_{BATDRV_REG}. This provides a quick turn-on transition for the BATFET. Ideal diode mode also consumes higher quiescent current from the battery while the loop is in regulation.

7.3.6 Reverse Mode Power Direction

The device supports boost reverse power direction to deliver power from the battery to the system when the adapter is not present. During this mode of operation, the ACFET and BATFET both remain off. The reverse mode output voltage regulation is set in VSYS_REV register bits. The reverse mode also offers output current regulation via the R_{AC_SNS} resistor. This parameter is controlled by the IAC_REV register bits. The reverse mode operation can be enabled if the following conditions are valid:

1. SRN above 3.8V.
2. DRV_SUP voltage within valid operating window ($V_{DRV_UVP} < V_{DRV} < V_{DRV_OVP}$.
3. VAC outside the ACOV / ACUV operating window, or $V_{VAC} < V_{VAC_OK}$, or $V_{VAC} > V_{VAC_INT_OV}$
4. Reverse mode operation is enabled (EN_REV = 1)
5. Voltage at TS (thermistor) pin is within range configured by Reverse Temperature Monitor as configured by BHOT and BCOLD register bits

While the reverse mode is active, the device sets the REVERSE_STAT bit to 1. Host can disable the reverse operation at any time by setting EN_REV bit to 0. The device disables the converter, and turns the BATFET on to connect the battery directly to the system.

The charger also monitors and regulates the battery discharging current in reverse mode. When the battery discharge current rises above the IBAT_REV register setting, the charger reduces the reverse mode power flow to limit the discharge current.

A minimum of 3.8V is needed to start the reverse mode successfully. However, once already in reverse mode, the VBAT side can be reduced up to 2.5V before the reverse mode turns off.

Once a valid VAC voltage is detected for forward operation, the device automatically disables reverse mode (EN_REV = 0), turns on the ACFETs and proceeds to charge the battery if enabled.

7.3.6.1 Auto Reverse Mode

In some applications, a regulated system voltage is required when the adapter power is removed. The device integrates an auto-reverse function which provides a regulated system voltage using the buck-boost converter in reverse direction once the input power is removed.

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When enabled by setting the AUTO_REV register bit to 1, Auto Reverse mode can be used to provide a regulated system voltage immediately after the input power is removed. The device transitions to reverse mode with the BATFET off and the converter on when the input falls below the ACUV threshold.

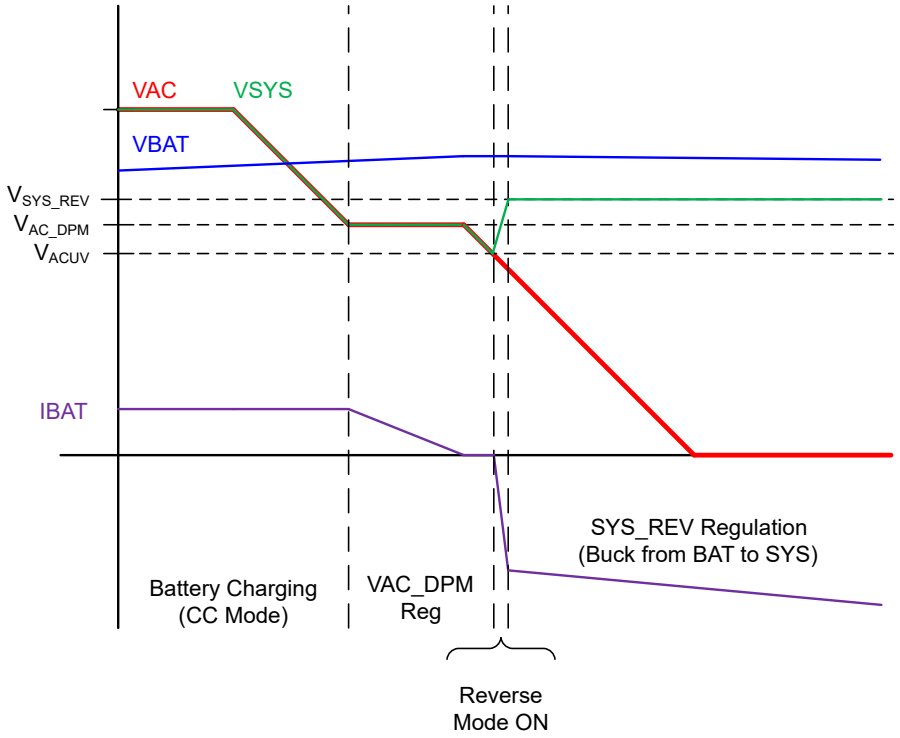


Figure 7-5. Auto Reverse Mode if BAT > VSYS_REV When VAC is Removed

The Auto Reverse mode operation will be automatically enabled if the following conditions are valid:

1. SRN voltage above V_{SRN_OK}
2. VAC outside the ACOV / ACUV operating window, or VAC < V_{VAC_OK}, or VAC > $V_{VAC_INT_OV}$
3. Auto Reverse mode operation is enabled (EN_AUTO_REV = 1)
4. Voltage at TS (thermistor) pin is within range configured by Reverse Temperature Monitor as configured by BHOT and BCOLD register bits

While the Auto reverse mode is active, the device sets the REVERSE_STAT bit to 1. Host can disable the Auto reverse operation at any time by setting EN_AUTO_REV = 0 and EN_REV = 0. The device then disables the converter, and turns the BATFET on to connect the battery directly to the system.

7.3.7 Integrated 16-Bit ADC for Monitoring

The device includes a 16-bit ADC to monitor critical system information based on the device's modes of operation. The ADC is allowed to operate if either the V_{VAC}>V_{VAC_OK} or VBAT>V_{REGN_OK} is valid. The ADC_EN bit provides the ability to enable and disable the ADC to conserve power. The ADC_RATE bit allows continuous conversion or one-shot behavior. After a one-shot conversion finishes, the ADC_EN bit is cleared, and must be re-asserted to start a new conversion.

The ADC_SAMPLE bits control the resolution and sample speed of the ADC. By default, ADC channels will be converted in one-shot or continuous conversion mode unless disabled in the ADC Function Disable register. If an ADC parameter is disabled by setting the corresponding bit, then the read-back value in the corresponding register will be from the last valid ADC conversion or the default POR value (all zeros if no conversions have taken place). If an ADC parameter is disabled in the middle of an ADC measurement cycle, the device will finish the conversion of that parameter, but will not convert the parameter starting the next conversion cycle. If all channels are disabled in one-shot conversion mode, the ADC_EN bit is cleared.

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The ADC_DONE_STAT and ADC_DONE_FLAG bits signal when a conversion is complete in one-shot mode only. This event produces an INT pulse, which can be masked with ADC_DONE_MASK. During continuous conversion mode, the ADC_DONE_STAT bit has no meaning and will be '0'. The ADC_DONE_FLAG bit will remain unchanged in continuous conversion mode.

ADC conversion operates independently of the faults present in the device. ADC conversion will continue even after a fault has occurred (such as one that causes the power stage to be disabled), and the host must set ADC_EN = '0' to disable the ADC. ADC readings are only valid for DC states and not for transients. When host writes ADC_EN = 0, the ADC stops immediately, and ADC measurement values correspond to last valid ADC reading.

If the host wants to exit ADC more gracefully, it is possible to do either of the following:

1. Write ADC_RATE to one-shot, and the ADC will stop at the end of a complete cycle of conversions, or
2. Disable all ADC conversion channels, and the ADC will stop at the end of the current measurement.

When the system load is powered from the battery (the input source is removed, or the device is in HIZ mode), enabling the ADC automatically powers up REGN and increases the quiescent current. To keep the battery leakage low, it is recommended to duty cycle or completely disable the ADC.

7.3.8 Status Outputs ($\overline{PG}$, STAT1, STAT2, and $\overline{INT}$)

7.3.8.1 Power Good Indicator ($\overline{PG}$)

The PG_STAT bit goes HIGH and the $\overline{PG}$ pin pulls LOW to indicate a good input source when a valid VAC voltage is detected. The $\overline{PG}$ pin can drive an LED. All conditions must be met to indicate power good:

1. $V_{VAC_OK} < V_{VAC} < V_{VAC_INT_OV}$
2. $V_{ACUV} > V_{REF_ACUV}$
3. $V_{ACOV} < V_{REF_ACOV}$
4. Device not in HIZ mode

The $\overline{PG}$ pin can be disabled via the DIS_PG_PIN bit. When disabled, this pin can be controlled to pull LOW using the FORCE_STAT3_ON bit.

7.3.8.2 Charging Status Indicator (STAT1, STAT2 Pins)

The device indicates charging state on the open drain STAT1 and STAT2 pins. The STAT1, STAT2 pins can drive LEDs.

Table 7-6. STAT1, STAT2 Pin State

CHARGING STATE	STAT1	STAT2
Charge in progress (including recharge)	ON	OFF
Charge done	OFF	ON
Charging fault detected (TS out of range, safety timer fault, etc.)	ON	ON
Charge disabled (EN_CHG = 0, or $\overline{CE}$ pin high)	OFF	OFF

The STAT1, STAT2 pin function can be disabled via the DIS_STAT_PINS bit. When disabled, these pins can be controlled to independently pull LOW using the FORCE_STAT1_ON and FORCE_STAT2_ON bits. The STAT pins are not affected by the Reverse mode and remain OFF during this mode.

7.3.8.3 Interrupt to Host ($\overline{INT}$)

In some applications, the host does not always monitor the charger operation. The $\overline{INT}$ pin notifies the system host on the device operation. By default, the following events will generate an active-low, 256-µs INT pulse.

1. Valid input source conditions detected (see conditions for $\overline{PG}$ pin)
2. Valid input source conditions removed (see conditions for $\overline{PG}$ pin)
3. Entering IAC_DPM regulation through register or pin
4. Entering VAC_DPM regulation through register or ACUV pin

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5. I²C Watchdog timer expired
6. Charger status changes state (CHARGE_STAT value change), including Charge Complete
7. TS_STAT changes state (TS_STAT value change)
8. Junction temperature shutdown (TSHUT)
9. Battery overvoltage detected (BATOVP)
10. Charge safety timer expired
11. A rising edge on any of the *_STAT bits

Each one of these INT sources can be masked off to prevent INT pulses from being sent out when they occur. Three bits exist for each one of these events:

- The STAT bit holds the *current status* of each INT source
- The FLAG bit holds information on which source produced an INT, regardless of the current status
- The MASK bit is used to prevent the device from sending out INT for each particular event

When one of the above conditions occurs (a rising edge on any of the *_STAT bits), the device sends out an INT pulse and keeps track of which source generated the INT via the FLAG registers. The FLAG register bits are automatically reset to zero after the host reads them, and a new edge on STAT bit is required to re-assert the FLAG.

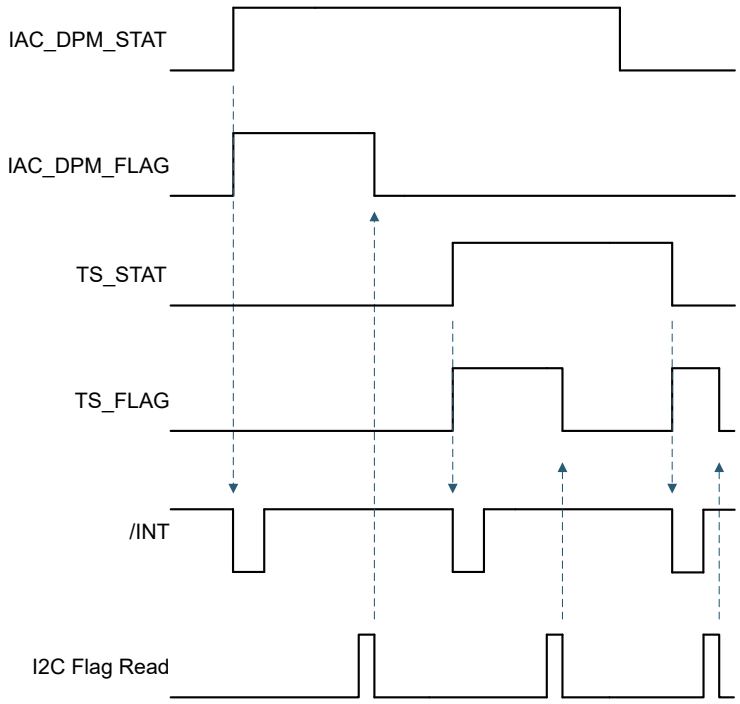


Figure 7-6. INT Generation Behavior Example

7.3.9 Serial Interface

The device uses I²C compatible interface for flexible charging parameter programming and instantaneous device status reporting. I²C is a bi-directional 2-wire serial interface. Only two open-drain bus lines are required: a serial data line (SDA), and a serial clock line (SCL). Devices can be considered as controllers or targets when performing data transfers. A controller is a device which initiates a data transfer on the bus and generates the clock signals to permit that transfer. At that time, any device addressed is considered a target.

The device operates as a target device with address 0x6B, receiving control inputs from the controller device like a micro-controller or digital signal processor through the registers defined in the Register Map. Registers read outside those defined in the map, return 0xFF. The I²C interface supports standard mode (up to 100 kbits/s), fast mode (up to 400 kbits/s), and fast mode plus (up to 1 Mbit/s). When the bus is free, both lines are HIGH. The

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SDA and SCL pins are open drain and must be connected to the positive supply voltage via a current source or pull-up resistor.

System Note: All 16-bit registers are defined as Little Endian, with the most-significant byte allocated to the higher address. 16-bit register writes must be done sequentially and are recommended to be programmed using multi-write approach described in the Section 7.3.9.7.

7.3.9.1 Data Validity

The data on the SDA line must be stable during the HIGH period of the clock. The HIGH or LOW state of the data line can only change when the clock signal on SCL line is LOW. One clock pulse is generated for each data bit transferred.

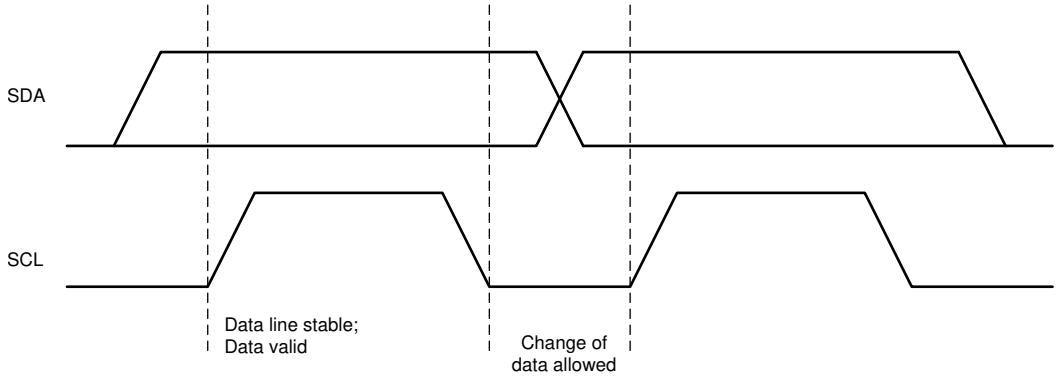


Figure 7-7. Bit Transfers on the I²C Bus

7.3.9.2 START and STOP Conditions

All transactions begin with a START (S) and are terminated with a STOP (P). A HIGH to LOW transition on the SDA line while SCL is HIGH defines a START condition. A LOW to HIGH transition on the SDA line when the SCL is HIGH defines a STOP condition.

START and STOP conditions are always generated by the controller. The bus is considered busy after the START condition, and free after the STOP condition. When timeout condition is met, for example START condition is active for more than 2 seconds and there is no STOP condition triggered, the charger I²C communication will automatically reset and communication lines are free for another transmission.

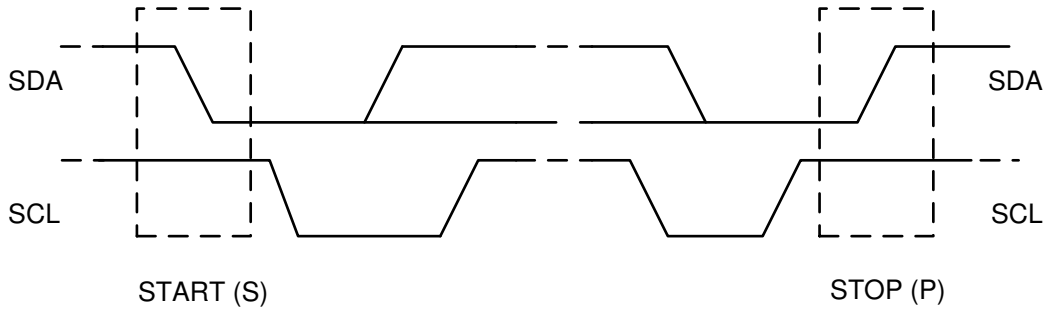


Figure 7-8. START and STOP Conditions on the I²C Bus

7.3.9.3 Byte Format

Every byte on the SDA line must be 8 bits long. The number of bytes to be transmitted per transfer is unrestricted. Each byte has to be followed by an ACKNOWLEDGE (ACK) bit. Data is transferred with the Most Significant Bit (MSB) first.

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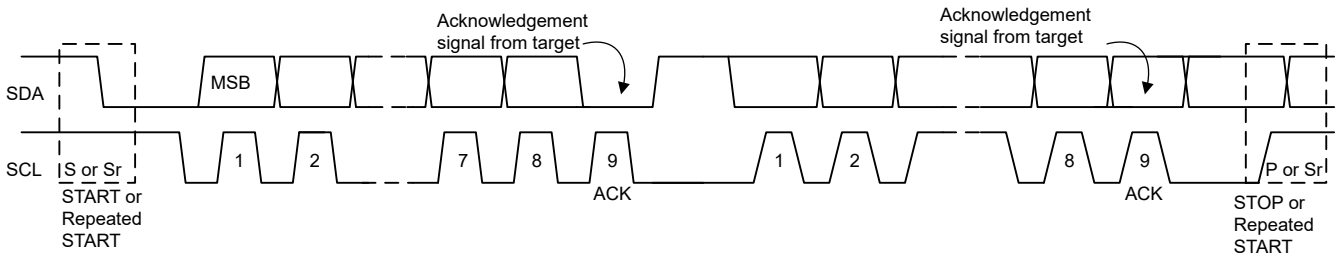


Figure 7-9. Data Transfer on the I²C Bus

7.3.9.4 Acknowledge (ACK) and Not Acknowledge (NACK)

The ACK signaling takes place after each byte. The ACK bit allows the target to signal the controller that the byte was successfully received and another byte may be sent. All clock pulses, including the acknowledge 9th clock pulse, are generated by the controller.

The controller releases the SDA line during the acknowledge clock pulse so the target can pull the SDA line LOW and it remains stable LOW during the HIGH period of this 9th clock pulse.

A NACK is signaled when the SDA line remains HIGH during the 9th clock pulse. The controller can then generate either a STOP to abort the transfer or a repeated START to start a new transfer.

7.3.9.5 Target Address and Data Direction Bit

After the START signal, a target address is sent. This address is 7 bits long, followed by the 8 bit as a data direction bit (bit R/ $\overline{W}$). A zero indicates a transmission (WRITE) and a one indicates a request for data (READ). The device 7-bit address is defined as 1101 011' (0x6B) by default.

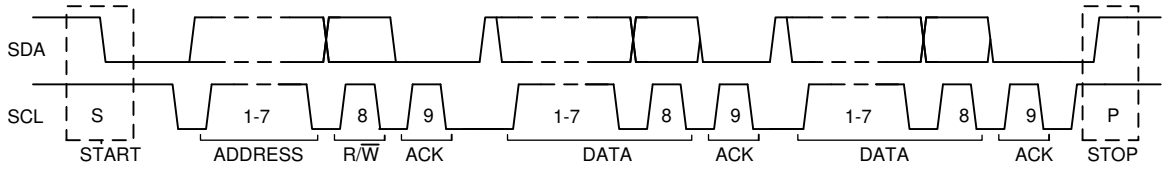


Figure 7-10. Complete Data Transfer on the I²C Bus

7.3.9.6 Single Write and Read

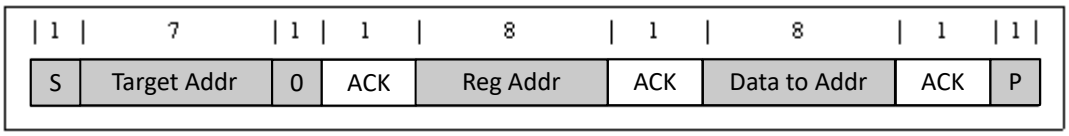


Figure 7-11. Single Write

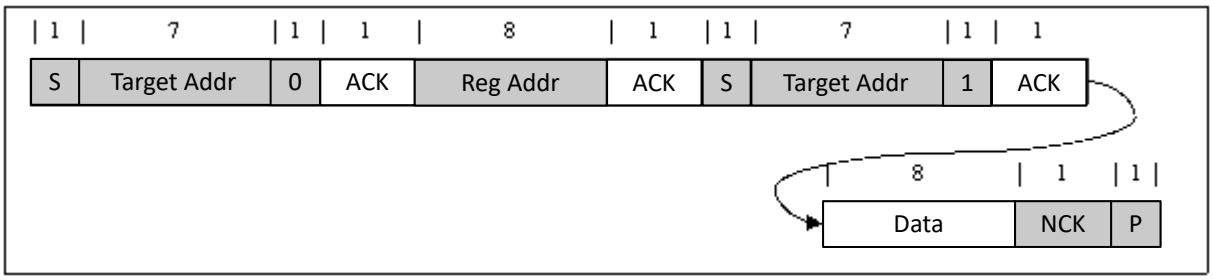


Figure 7-12. Single Read

If the register address is not defined, the charger IC sends back NACK and returns to the idle state.

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7.3.9.7 Multi-Write and Multi-Read

The charger device supports multi-read and multi-write of all registers.

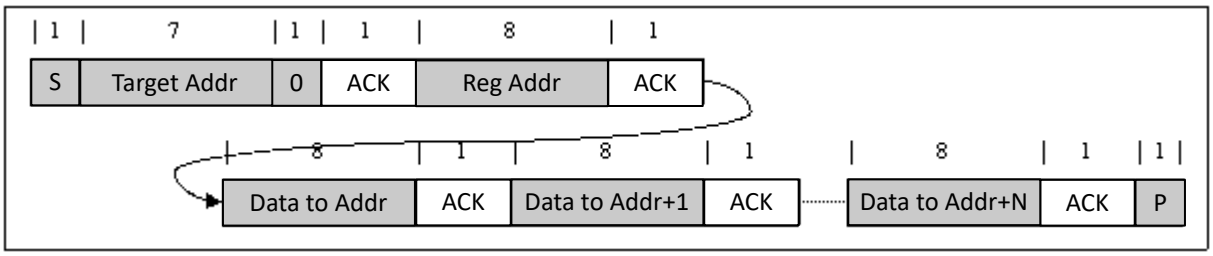


Figure 7-13. Multi-Write

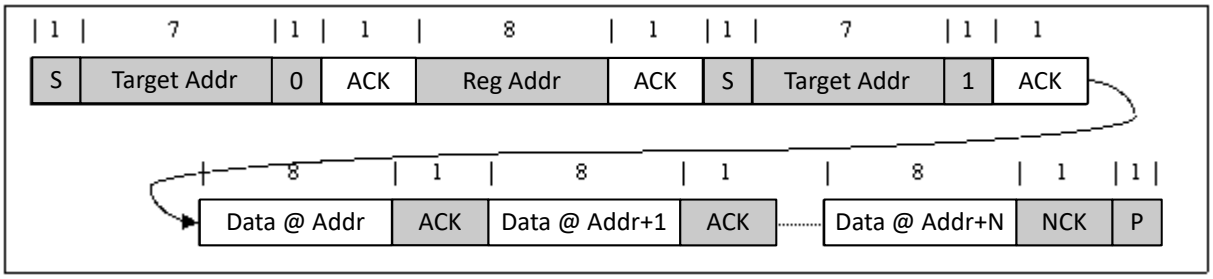


Figure 7-14. Multi-Read

7.4 Device Functional Modes

7.4.1 Host Mode and Default Mode

The device is a host controlled charger, but it can operate in default mode without host management. In default mode, the device can be used as an autonomous charger with no host or while host is in sleep mode. When the charger is in default mode, WD_STAT bit becomes HIGH, WD_FLAG is set to 1, and a $\overline{INT}$ is asserted low to alert the host (unless masked by WD_MASK). The WD_FLAG bit would read as a '1' upon the first read and then '0' upon subsequent reads. When the charger is in host mode, WD_STAT bit is LOW.

After power-on-reset, the device starts in default mode with watchdog timer expired. All the registers are in the default settings.

In default mode, the device keeps charging the battery with default 2-hour pre-charging safety timer and the 12-hour fast charging safety timer. At the end of the 2-hour or 12-hour timer expiration, the charging is stopped if termination has not been detected.

A write to any I^2C register transitions the charger from default mode to host mode, and initiates the watchdog timer. All the device parameters can be programmed by the host. To keep the device in host mode, the host has to reset the watchdog timer by writing 1 to WD_RST bit before the watchdog timer expires (WD_STAT bit is set), or disable watchdog timer by setting WATCHDOG bits = 00.

When the watchdog timer is expired, the device returns to default mode and select registers are reset to default values as detailed in the Register Map section. The Watchdog timer will be reset on any write if the watchdog timer has expired. When watchdog timer expires, WD_STAT and WD_FLAG is set to 1, and /INT is asserted low to alert the host (unless masked by WD_MASK).

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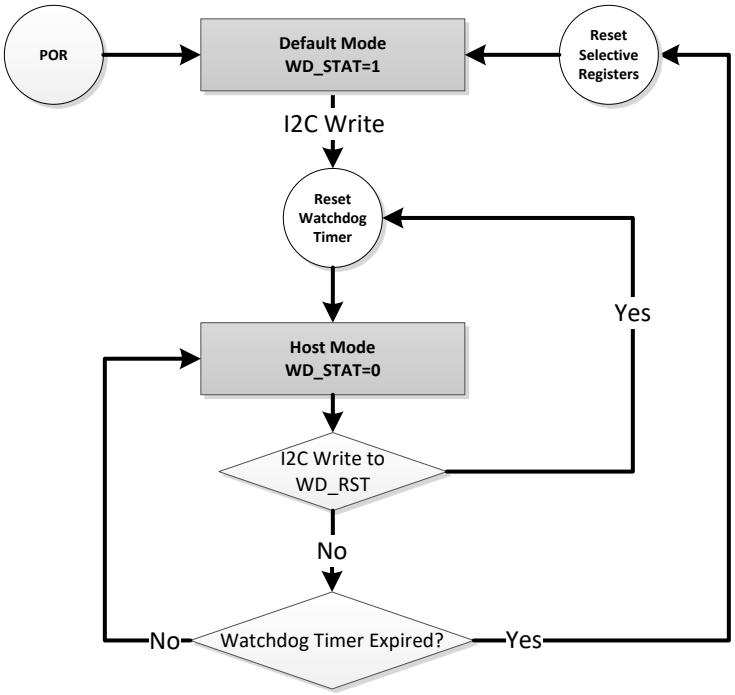


Figure 7-15. Watchdog Timer Flow Chart

7.4.2 Register Bit Reset

Besides the register reset by the watchdog timer in the default mode, the registers and the timer can be reset to the default value by writing the REG_RST bit to 1. The register bits which can be reset by the REG_RST bit are noted in the Register Map section. After the register reset, the REG_RST bit will go back from 1 to 0 automatically.

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7.5 BQ25751 Registers

Table 7-7 lists the memory-mapped registers for the BQ25751 registers. All register offset addresses not listed in Table 7-7 must be considered as reserved locations and the register contents must not be modified.

Table 7-7. BQ25751 Registers

Address	Acronym	Register Name	Section
0x0	REG0x00_Charge_Voltage_Limit	Charge Voltage Limit	Go
0x2	REG0x02_Charge_Current_Limit	Charge Current Limit	Go
0x6	REG0x06_Input_Current_DPM_Limit	Input Current DPM Limit	Go
0x8	REG0x08_Input_Voltage_DPM_Limit	Input Voltage DPM Limit	Go
0xA	REG0x0A_Reverse_Mode_Input_Current_Limit	Reverse Mode Input Current Limit	Go
0xC	REG0x0C_Reverse_Mode_System_Voltage_Limit	Reverse Mode System Voltage Limit	Go
0x12	REG0x12_Termination_Current_Limit	Termination Current Limit	Go
0x14	REG0x14_Termination_Control	Termination Control	Go
0x15	REG0x15_Timer_Control	Timer Control	Go
0x16	REG0x16_Three-Stage_Charge_Control	Three-Stage Charge Control	Go
0x17	REG0x17_Charger_Control	Charger Control	Go
0x18	REG0x18_Pin_Control	Pin Control	Go
0x19	REG0x19_Power_Path_and_Reverse_Mode_Control	Power Path and Reverse Mode Control	Go
0x1A	REG0x1A_MPPT_Control	MPPT Control	Go
0x1B	REG0x1B_TS_Charging_Threshold_Control	TS Charging Threshold Control	Go
0x1C	REG0x1C_TS_Charging_Region_Behavior_Control	TS Charging Region Behavior Control	Go
0x1D	REG0x1D_TS_Reverse_Mode_Threshold_Control	TS Reverse Mode Threshold Control	Go
0x1E	REG0x1E_Reverse_Undervoltage_Control	Reverse Undervoltage Control	Go
0x1F	REG0x1F_VAC_Max_Power_Point_Detected	VAC Max Power Point Detected	Go
0x21	REG0x21_Charger_Status_1	Charger Status 1	Go
0x22	REG0x22_Charger_Status_2	Charger Status 2	Go
0x23	REG0x23_Charger_Status_3	Charger Status 3	Go
0x24	REG0x24_Fault_Status	Fault Status	Go
0x25	REG0x25_Charger_Flag_1	Charger Flag 1	Go
0x26	REG0x26_Charger_Flag_2	Charger Flag 2	Go
0x27	REG0x27_Fault_Flag	Fault Flag	Go
0x28	REG0x28_Charger_Mask_1	Charger Mask 1	Go
0x29	REG0x29_Charger_Mask_2	Charger Mask 2	Go
0x2A	REG0x2A_Fault_Mask	Fault Mask	Go
0x2B	REG0x2B_ADC_Control	ADC Control	Go
0x2C	REG0x2C_ADC_Channel_Control	ADC Channel Control	Go
0x2D	REG0x2D_IAC_ADC	IAC ADC	Go
0x2F	REG0x2F_IBAT_ADC	IBAT ADC	Go
0x31	REG0x31_VAC_ADC	VAC ADC	Go
0x33	REG0x33_VBAT_ADC	VBAT ADC	Go
0x35	REG0x35_VSYS_ADC	VSYS ADC	Go
0x37	REG0x37_TS_ADC	TS ADC	Go
0x39	REG0x39_VFB_ADC	VFB ADC	Go
0x3B	REG0x3B_Gate_Driver_Strength_Control	Gate Driver Strength Control	Go
0x3C	REG0x3C_Gate_Driver_Dead_Time_Control	Gate Driver Dead Time Control	Go
0x3D	REG0x3D_Part_Information	Part Information	Go

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Table 7-7. BQ25751 Registers (continued)

Address	Acronym	Register Name	Section
0x62	REG0x62_Reverse_Mode_Battery_Discharge_Current	Reverse Mode Battery Discharge Current	Go

Complex bit access types are encoded to fit into small table cells. Table 7-8 shows the codes that are used for access types in this section.

Table 7-8. BQ25751 Access Type Codes

Access Type	Code	Description
Read Type		
R	R	Read
Write Type		
W	W	Write
Reset or Default Value		
-n		Value after reset or the default value

7.5.1 REG0x00_Charge_Voltage_Limit Register (Address = 0x0) [Reset = 0x0010]

REG0x00_Charge_Voltage_Limit is shown in Table 7-9.

Return to the Summary Table.

I2C REG0x01=[15:8], I2C REG0x00=[7:0]

Table 7-9. REG0x00_Charge_Voltage_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:5	RESERVED	R	0x0		Reserved
4:0	VFB_REG	R/W	0x10	Reset by: REG_RESET	FB Voltage Regulation Limit: POR: 1536mV (10h) Range: 1504mV-1566mV (0h-1Fh) Bit Step: 2mV Offset: 1504mV

7.5.2 REG0x02_Charge_Current_Limit Register (Address = 0x2) [Reset = 0x0640]

REG0x02_Charge_Current_Limit is shown in Table 7-10.

Return to the Summary Table.

I2C REG0x03=[15:8], I2C REG0x02=[7:0]

Table 7-10. REG0x02_Charge_Current_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:11	RESERVED	R	0x0		Reserved
10:2	ICHG_REG	R/W	0x190	Reset by: REG_RESET WATCHDOG	Fast Charge Current Regulation Limit with 5mΩ RBAT_SNS: Actual charge current is the lower of ICHG_REG and ICHG pin POR: 20000mA (190h) Range: 400mA-20000mA (8h-190h) Clamped Low Clamped High Bit Step: 50mA
1:0	RESERVED	R	0x0		Reserved

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7.5.3 REG0x06_Input_Current_DPM_Limit Register (Address = 0x6) [Reset = 0x0640]

REG0x06_Input_Current_DPM_Limit is shown in Table 7-11.

Return to the Summary Table.

I2C REG0x07=[15:8], I2C REG0x06=[7:0]

Table 7-11. REG0x06_Input_Current_DPM_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:11	RESERVED	R	0x0		Reserved
10:2	IAC_DPM	R/W	0x190	Reset by: REG_RESET	Input Current DPM Regulation Limit with 2mΩ RAC_SNS: Actual input current limit is the lower of IAC_DPM and ILIM_HIZ pin POR: 50000mA (190h) Range: 1000mA-50000mA (8h-190h) Clamped Low Clamped High Bit Step: 125mA
1:0	RESERVED	R	0x0		Reserved

7.5.4 REG0x08_Input_Voltage_DPM_Limit Register (Address = 0x8) [Reset = 0x0348]

REG0x08_Input_Voltage_DPM_Limit is shown in Table 7-12.

Return to the Summary Table.

I2C REG0x09=[15:8], I2C REG0x08=[7:0]

Table 7-12. REG0x08_Input_Voltage_DPM_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:14	RESERVED	R	0x0		Reserved
13:2	VAC_DPM	R/W	0xD2	Reset by: REG_RESET	Input Voltage Regulation Limit: Note if EN_MPPT = 1, the Full Sweep method will use this limit as the lower search window for Full Panel Sweep POR: 4400mV (DCh) Range: 4400mV-65000mV (DCh-CB2h) Clamped Low Clamped High Bit Step: 20mV
1:0	RESERVED	R	0x0		Reserved

7.5.5 REG0x0A_Reverse_Mode_Input_Current_Limit Register (Address = 0xA) [Reset = 0x0640]

REG0x0A_Reverse_Mode_Input_Current_Limit is shown in Table 7-13.

Return to the Summary Table.

I2C REG0x0B=[15:8], I2C REG0x0A=[7:0]

Table 7-13. REG0x0A_Reverse_Mode_Input_Current_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:11	RESERVED	R	0x0		Reserved

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Table 7-13. REG0x0A_Reverse_Mode_Input_Current_Limit Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
10:2	IAC_REV	R/W	0x190	Reset by: REG_RESET	Input Current Regulation in Reverse Mode with 2mΩ RAC_SNS: POR: 50000mA (190h) Range: 1000mA-50000mA (8h-190h) Clamped Low Clamped High Bit Step: 125mA
1:0	RESERVED	R	0x0		Reserved

7.5.6 REG0x0C_Reverse_Mode_System_Voltage_Limit Register (Address = 0xC) [Reset = 0x03E8]

REG0x0C_Reverse_Mode_System_Voltage_Limit is shown in Table 7-14.

Return to the Summary Table.

I2C REG0x0D=[15:8], I2C REG0x0C=[7:0]

Table 7-14. REG0x0C_Reverse_Mode_System_Voltage_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:14	RESERVED	R	0x0		Reserved
13:2	VSYS_REV	R/W	0xFA	Reset by: REG_RESET	System Voltage Regulation in Reverse Mode: POR: 5000mV (FAh) Range: 3300mV-65000mV (A5h-CB2h) Clamped Low Clamped High Bit Step: 20mV
1:0	RESERVED	R	0x0		Reserved

7.5.7 REG0x12_Termination_Current_Limit Register (Address = 0x12) [Reset = 0x00A0]

REG0x12_Termination_Current_Limit is shown in Table 7-15.

Return to the Summary Table.

I2C REG0x13=[15:8], I2C REG0x12=[7:0]

Table 7-15. REG0x12_Termination_Current_Limit Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:10	RESERVED	R	0x0		Reserved
9:2	ITERM	R/W	0x28	Actual termination current is the lower of ITERM and ICHG pin if both functions enabled Reset by: REG_RESET	Termination Current Threshold with 5mΩ RBAT_SNS: POR: 2000mA (28h) Range: 250mA-10000mA (5h-C8h) Clamped Low Clamped High Bit Step: 50mA
1:0	RESERVED	R	0x0		Reserved

7.5.8 REG0x14_Termination_Control Register (Address = 0x14) [Reset = 0x08]

REG0x14_Termination_Control is shown in Table 7-16.

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Table 7-16. REG0x14_Termination_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:4	RESERVED	R	0x0		Reserved
3	EN_TERM	R/W	0x1	Reset by: REG_RESET	Enable termination control: TERM is used to transition from Absorb phase to Float phase in PbAcid charging 0b = Disable 1b = Enable
2:1	RESERVED	R	0x0		Reserved
0	RESERVED	R	0x0		Reserved

7.5.9 REG0x15_Timer_Control Register (Address = 0x15) [Reset = 0x10]

REG0x15_Timer_Control is shown in Table 7-17.

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Table 7-17. REG0x15_Timer_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	TOPOFF_TMR	R/W	0x0	Reset by: REG_RESET	Top-off timer control: 00b = Disable 01b = 15 mins 10b = 30 mins 11b = 45 mins
5:4	WATCHDOG	R/W	0x1	Reset by: REG_RESET	Watchdog timer control: 00b = Disable 01b = 40s 10b = 80s 11b = 160s
3	RESERVED	R	0x0		Reserved
2:1	RESERVED	R	0x0		Reserved
0	RESERVED	R	0x0		Reserved

7.5.10 REG0x16_Three-Stage_Charge_Control Register (Address = 0x16) [Reset = 0xD5]

REG0x16_Three-Stage_Charge_Control is shown in Table 7-18.

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Table 7-18. REG0x16_Three-Stage_Charge_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	VBAT_ABSORB	R/W	0x3	Reset by: REG_RESET	Absorb voltage control, offset above VFB_REG: 00b = 50mV + VFB_REG - Float = 13.65V, Absorb = 14.1V 01b = 84mV + VFB_REG - Float = 13.65V, Absorb = 14.4V 10b = 118mV + VFB_REG - Float = 13.65V, Absorb = 14.7V 11b = 140mV + VFB_REG - Float = 13.2V, Absorb = 14.4V
5	RESERVED	R	0x0		Reserved

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Table 7-18. REG0x16_Three-Stage_Charge_Control Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
4	EN_3_STAGE_CHARGE	R/W	0x1	Reset by: REG_RESET	Three-Stage charging enable: When enabled, device will reduce regulation to VFLOAT after termination, and continue charging forever 0b = Disable 1b = Enable
3:0	CV_TMR	R/W	0x5	Reset by: REG_RESET WATCHDOG	CV timer setting: 0000b = disable 0001b = 1hr 0010b = 2hr ... = ... 1110b = 14hr 1111b = 15hr

7.5.11 REG0x17_Charger_Control Register (Address = 0x17) [Reset = 0x09]

REG0x17_Charger_Control is shown in Table 7-19.

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Table 7-19. REG0x17_Charger_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	VRECHG	R/W	0x0	Reset by: REG_RESET	Battery auto-recharge threshold, as percentage of VFB_REG: 00b = 93.0% x VFB_REG 01b = 94.3% x VFB_REG 10b = 95.2% x VFB_REG 11b = 97.6% x VFB_REG
5	WD_RST	R/W	0x0	Reset by: REG_RESET	I2C Watchdog timer reset control: 0b = Normal 1b = Reset (bit goes back to 0 after timer reset)
4	DIS_CE_PIN	R/W	0x0	Reset by: REG_RESET	/CE pin function disable: 0b = /CE pin enabled 1b = /CE pin disabled
3	EN_CHG_BIT_RESET_BEHAVIOR	R/W	0x1	Reset by: REG_RESET	Controls the EN_CHG bit behavior when WATCHDOG expires: 0b = EN_CHG bit resets to 0 1b = EN_CHG bit resets to 1
2	EN_HIZ	R/W	0x0	Reset by: REG_RESET WATCHDOG Adapter Plug In	HIZ mode enable: 0b = Disable 1b = Enable
1	EN_IBAT_LOAD	R/W	0x0	Sinks current from SRN to GND. Recommend to disable IBAT ADC (IBAT_ADC_DIS = 1) while this bit is active. Reset by: REG_RESET WATCHDOG	Battery Load (IBAT_LOAD) Enable: 0b = Disabled 1b = Enabled
0	EN_CHG	R/W	0x1	Reset by: REG_RESET WATCHDOG	Charge enable control: 0b = Disable 1b = Enable

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7.5.12 REG0x18_Pin_Control Register (Address = 0x18) [Reset = 0xC0]

REG0x18_Pin_Control is shown in Table 7-20.

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Table 7-20. REG0x18_Pin_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	EN_ICHG_PIN	R/W	0x1	Reset by: REG_RESET WATCHDOG	ICHG pin function enable: 0b = ICHG pin disabled 1b = ICHG pin enabled
6	EN_ILIM_HIZ_PIN	R/W	0x1	Reset by: REG_RESET WATCHDOG	ILIM_HIZ pin function enable: 0b = ILIM_HIZ pin disabled 1b = ILIM_HIZ pin enabled
5	DIS_PG_PIN	R/W	0x0	Reset by: REG_RESET	PG pin function disable: 0b = PG pin enabled 1b = PG pin disabled
4	DIS_STAT_PINS	R/W	0x0	Reset by: REG_RESET	STAT1, STAT2 pin function disable: 0b = STAT pins enabled 1b = STAT pins disabled
3	FORCE_STAT4_ON	R/W	0x0	Reset by: REG_RESET	CE_STAT4 pin override: Can only be forced on if DIS_CE_PIN = 1 0b = CE_STAT4 open-drain off 1b = CE_STAT4 pulls LOW
2	FORCE_STAT3_ON	R/W	0x0	Reset by: REG_RESET	PG_STAT3 pin override: Can only be forced on if DIS_PG_PIN = 1 0b = PG_STAT3 open-drain off 1b = PG_STAT3 pulls LOW
1	FORCE_STAT2_ON	R/W	0x0	Reset by: REG_RESET	STAT2 pin override: Can only be forced on if DIS_STAT_PINS = 1 0b = STAT2 open-drain off 1b = STAT2 pulls LOW
0	FORCE_STAT1_ON	R/W	0x0	Reset by: REG_RESET	STAT1 pin override: Can only be forced on if DIS_STAT_PINS = 1 0b = STAT1 open-drain off 1b = STAT1 pulls LOW

7.5.13 REG0x19_Power_Path_and_Reverse_Mode_Control Register (Address = 0x19) [Reset = 0x00]

REG0x19_Power_Path_and_Reverse_Mode_Control is shown in Table 7-21.

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Table 7-21. REG0x19_Power_Path_and_Reverse_Mode_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	REG_RST	R/W	0x0	Reset by: REG_RESET	Register reset to default values: 0b = Not reset 1b = Reset (bit goes back to 0 after register reset)
6	EN_IAC_LOAD	R/W	0x0	Reset by: REG_RESET WATCHDOG	VAC Load (IAC_LOAD) Enable: 0b = Disabled 1b = Enabled

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Table 7-21. REG0x19_Power_Path_and_Reverse_Mode_Control Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
5	EN_PFM	R/W	0x0	It is recommended to disable PFM when ITERM < 2A Reset by: REG_RESET	Enable PFM mode in light-load: Note this bit is reset to 0 upon a valid SYNC signal detection on FSW_SYNC pin. Host can set this bit back to 1 to force PFM operation even with a valid SYNC input 0b = Disable (Fixed-frequency DCM operation) 1b = Enable (PFM operation)
4	FORCE_BATFET_OFF	R/W	0x0	Reset by: REG_RESET Adapter Plug In	Force BATFET off control: 0b = Allow normal BATFET operation 1b = Force BATFET off
3	PWRPATH_REDUCE_VDRV	R/W	0x0	Reset by: REG_RESET WATCHDOG	Power-Path (ACFET, BATFET) Drive Voltage Select: 0b = 10V 1b = 7V
2	EN_BATFET_IDEAL_DIODE	R/W	0x0	Reset by: REG_RESET	Enable BATFET ideal diode turn-on mode: Note: Only recommended for single BATFET 0b = Disable 1b = Enable
1	EN_AUTO_REV	R/W	0x0	To exit reverse mode, it is recommended to clear both EN_AUTO_REV and EN_REV bits Reset by: REG_RESET WATCHDOG	Auto Reverse Mode to regulate SYS when VBAT < VSYS_REV register: 0b = Disable Auto Reverse 1b = Enable Auto Reverse
0	EN_REV	R/W	0x0	To exit reverse mode, it is recommended to clear both EN_AUTO_REV and EN_REV bits Reset by: REG_RESET WATCHDOG Adapter Plug In	Reverse Mode control: 0b = Disable 1b = Enable

7.5.14 REG0x1A_MPPT_Control Register (Address = 0x1A) [Reset = 0x20]

REG0x1A_MPPT_Control is shown in Table 7-22.

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Table 7-22. REG0x1A_MPPT_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	FORCE_SWEEP	R/W	0x0	Reset by: REG_RESET	Force Full Panel Sweep and reset MPPT timers: 0b = Normal 1b = Start Full Panel Sweep (bit goes back to 0 after Full Panel Sweep complete)
6:5	RESERVED	R	0x0		Reserved
4:3	RESERVED	R	0x0		Reserved
2:1	FULL_SWEEP_TMR	R/W	0x0	Reset by: REG_RESET	Full Panel Sweep timer control: 00b = 3 min 01b = 10 min 10b = 15 min 11b = 20 min

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Table 7-22. REG0x1A_MPPT_Control Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
0	EN_MPPT	R/W	0x0	When MPPT is enabled, the ADC is controlled by the device, writes to REG2A are ignored Reset by: REG_RESET	MPPT algorithm control: 0b = Disable MPPT 1b = Enable MPPT

7.5.15 REG0x1B_TS_Charging_Threshold_Control Register (Address = 0x1B) [Reset = 0x82]

REG0x1B_TS_Charging_Threshold_Control is shown in Table 7-23.

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Table 7-23. REG0x1B_TS_Charging_Threshold_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	TS_T5	R/W	0x2	Reset by: REG_RESET	TS T5 (HOT) threshold control: 00b = 41.2% (50C) 01b = 37.7% (55C) 10b = 34.375% (60C) 11b = 31.25%(65C)
5:4	RESERVED	R	0x0		Reserved
3:2	RESERVED	R	0x0		Reserved
1:0	TS_T1	R/W	0x2	Reset by: REG_RESET	TS T1 (COLD) threshold control: 00b = 77.15% (-10C) 01b = 75.32% (-5C) 10b = 73.25% (0C) 11b = 71.1% (5C)

7.5.16 REG0x1C_TS_Charging_Region_Behavior_Control Register (Address = 0x1C) [Reset = 0x81]

REG0x1C_TS_Charging_Region_Behavior_Control is shown in Table 7-24.

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Table 7-24. REG0x1C_TS_Charging_Region_Behavior_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	EN_VREG_TEMP_COMP	R/W	0x1	Reset by: REG_RESET	Enable VFB_REG temperature compensation for lead-acid battery charging:0b = Disable 1b = Enable
6:5	RESERVED	R	0x0		Reserved
4	RESERVED	R	0x0		Reserved
3:2	RESERVED	R	0x0		Reserved
1	RESERVED	R	0x0		Reserved
0	EN_TS	R/W	0x1	Reset by: REG_RESET	TS pin function control (applies to forward charging and reverse discharging modes): 0b = Disabled (ignore TS pin) 1b = Enabled

7.5.17 REG0x1D_TS_Reverse_Mode_Threshold_Control Register (Address = 0x1D) [Reset = 0x40]

REG0x1D_TS_Reverse_Mode_Threshold_Control is shown in Table 7-25.

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Table 7-25. REG0x1D_TS_Reverse_Mode_Threshold_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	BHOT	R/W	0x1	Reset by: REG_RESET	Reverse Mode TS HOT temperature threshold control: 00b = 37.7% (55C) 01b = 34.2% (60C) 10b = 31.25%(65C) 11b = Disable
5	BCOLD	R/W	0x0	Reset by: REG_RESET	Reverse Mode TS COLD temperature threshold control: 0b = 77.15% (-10C) 1b = 80% (-20C)
4:0	RESERVED	R	0x0		Reserved

7.5.18 REG0x1E_Reverse_Undervoltage_Control Register (Address = 0x1E) [Reset = 0x00]

REG0x1E_Reverse_Undervoltage_Control is shown in Table 7-26.

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Table 7-26. REG0x1E_Reverse_Undervoltage_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	RESERVED	R	0x0		Reserved
6	RESERVED	R	0x0		Reserved
5	SYSREV_UV	R/W	0x0	Reset by: REG_RESET	Reverse Mode System UVP: 0b = 80% of VSYS_REV target 1b = Fixed at 3.3V
4	RESERVED	R	0x0		Reserved
3	RESERVED	R	0x0		Reserved
2	RESERVED	R	0x0		Reserved
1	RESERVED	R	0x0		Reserved
0	RESERVED	R	0x0		Reserved

7.5.19 REG0x1F_VAC_Max_Power_Point_Detected Register (Address = 0x1F) [Reset = 0x0000]

REG0x1F_VAC_Max_Power_Point_Detected is shown in Table 7-27.

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I2C REG0x20=[15:8], I2C REG0x1F=[7:0]

Table 7-27. REG0x1F_VAC_Max_Power_Point_Detected Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:14	RESERVED	R	0x0		Reserved
13:2	VAC_MPP	R	0x0		Input Voltage for Max Power Point detected: POR: 0mV (0h) Range: 0mV-60000mV (0h-BB8h) Clamped High Bit Step: 20mV
1:0	RESERVED	R	0x0		Reserved

7.5.20 REG0x21_Charger_Status_1 Register (Address = 0x21) [Reset = 0x08]

REG0x21_Charger_Status_1 is shown in Table 7-28.

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Table 7-28. REG0x21_Charger_Status_1 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	ADC_DONE_STAT	R	0x0		ADC conversion status (in one-shot mode only): 0b = Conversion not complete 1b = Conversion complete
6	IAC_DPM_STAT	R	0x0		Input Current regulation status: 0b = Normal 1b = In Input Current regulation (ILIM pin or IAC_DPM)
5	VAC_DPM_STAT	R	0x0		Input Voltage regulation status: 0b = Normal 1b = In Input Voltage regulation (VAC_DPM or VSYS_REV)
4	RESERVED	R	0x0		Reserved
3	WD_STAT	R	0x1		I2C Watchdog timer status: 0b = Normal 1b = WD timer expired
2:0	CHARGE_STAT	R	0x0		Charge cycle status: 000b = Not charging 001b = Reserved 010b = Reserved 011b = Fast Charge (CC mode) 100b = Absorb Charge (CV mode) 101b = Float Charge (CV mode) 110b = Top-off Timer Charge 111b = Reserved

7.5.21 REG0x22_Charger_Status_2 Register (Address = 0x22) [Reset = 0x80]

REG0x22_Charger_Status_2 is shown in Table 7-29.

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Table 7-29. REG0x22_Charger_Status_2 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	PG_STAT	R	0x1		Input Power Good status: 0b = Not Power Good 1b = Power Good
6:4	TS_STAT	R	0x0		TS (Battery NTC) status: 000b = Normal 001b = TS Warm 010b = TS Cool 011b = TS Cold 100b = TS Hot
3:2	RESERVED	R	0x0		Reserved
1:0	MPPT_STAT	R	0x0		Max Power Point Tracking Algorithm status: 00b = MPPT Disabled 01b = MPPT Enabled, But Not Running 10b = Full Panel Sweep In Progress 11b = Max Power Voltage Detected

7.5.22 REG0x23_Charger_Status_3 Register (Address = 0x23) [Reset = 0x02]

REG0x23_Charger_Status_3 is shown in Table 7-30.

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Table 7-30. REG0x23_Charger_Status_3 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	RESERVED	R	0x0		Reserved
5:4	FSW_SYNC_STAT	R	0x0		FSW_SYNC pin status: 00b = Normal, no external clock detected 01b = Valid ext. clock detected 10b = Pin fault (frequency out-of-range) 11b = Reserved
3	CV_TMR_STAT	R	0x0		CV Timer status: 0b = Normal 1b = CV Timer Expired
2	REVERSE_STAT	R	0x0		Converter Reverse Mode status: 0b = Reverse Mode off 1b = Reverse Mode On
1	ACFET_STAT	R	0x1		ACFET driver status: 0b = ACFET off 1b = ACFET on
0	BATFET_STAT	R	0x0		BATFET driver status: 0b = BATFET off 1b = BATFET on

7.5.23 REG0x24_Fault_Status Register (Address = 0x24) [Reset = 0x00]

REG0x24_Fault_Status is shown in Table 7-31.

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Table 7-31. REG0x24_Fault_Status Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	VAC_UV_STAT	R	0x0		Input under-voltage status: 0b = Input Normal 1b = Device in Input under-voltage protection
6	VAC_OV_STAT	R	0x0		Input over-voltage status: 0b = Input Normal 1b = Device in Input over-voltage protection
5	IBAT_OCP_STAT	R	0x0		Battery over-current status: 0b = Battery current normal 1b = Battery over-current detected
4	VBAT_OV_STAT	R	0x0		Battery over-voltage status: 0b = Normal 1b = Device in Battery over-voltage protection
3	TSHUT_STAT	R	0x0		Thermal shutdown status: 0b = Normal 1b = Device in thermal shutdown protection
2	RESERVED	R	0x0		Reserved
1	DRV_OKZ_STAT	R	0x0	In battery-only mode with ADC disabled, this bit always reads '1'	DRV_SUP pin voltage status: 0b = Normal 1b = DRV_SUP pin voltage is out of valid range
0	RESERVED	R	0x0		Reserved

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7.5.24 REG0x25_Charger_Flag_1 Register (Address = 0x25) [Reset = 0x88]

REG0x25_Charger_Flag_1 is shown in Table 7-32.

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Table 7-32. REG0x25_Charger_Flag_1 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	ADC_DONE_FLAG	R	0x1		ADC conversion INT flag (in one-shot mode only): Note: always reads 0 in continuous mode Access: R (ClearOnRead) 0b = Conversion not complete 1b = Conversion complete
6	IAC_DPM_FLAG	R	0x0		Input Current regulation INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Device entered Input Current regulation
5	VAC_DPM_FLAG	R	0x0		Input Voltage regulation INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Device entered Input Voltage regulation
4	RESERVED	R	0x0		Reserved
3	WD_FLAG	R	0x1		I2C Watchdog timer INT flag: Access: R (ClearOnRead) 0b = Normal 1b = WD_STAT rising edge detected
2	RESERVED	R	0x0		Reserved
1	CV_TMR_FLAG	R	0x0		CV timer INT flag: Access: R (ClearOnRead) 0b = Normal 1b = CV timer expired rising edge detected
0	CHARGE_FLAG	R	0x0		Charge cycle INT flag: Access: R (ClearOnRead) 0b = Not charging 1b = CHARGE_STAT[2:0] bits changed (transition to any state)

7.5.25 REG0x26_Charger_Flag_2 Register (Address = 0x26) [Reset = 0xE0]

REG0x26_Charger_Flag_2 is shown in Table 7-33.

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Table 7-33. REG0x26_Charger_Flag_2 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	PG_FLAG	R	0x1		Input Power Good INT flag: Access: R (ClearOnRead) 0b = Normal 1b = PG signal toggle detected
6	ACFET_FLAG	R	0x1		ACFET driver INT flag: Access: R (ClearOnRead) 0b = Normal 1b = ACFET signal toggle detected
5	BATFET_FLAG	R	0x1		BATFET driver INT flag: Access: R (ClearOnRead) 0b = Normal 1b = BATFET signal toggle detected

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Table 7-33. REG0x26_Charger_Flag_2 Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
4	TS_FLAG	R	0x0		TS (Battery NTC) INT flag: Access: R (ClearOnRead) 0b = Normal 1b = TS_STAT[2:0] bits changed (transitioned to any state)
3	REVERSE_FLAG	R	0x0		Reverse Mode INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Reverse Mode toggle detected
2	RESERVED	R	0x0		Reserved
1	FSW_SYNC_FLAG	R	0x0		FSW_SYNC pin signal INT flag: Access: R (ClearOnRead) 0b = Normal 1b = FSW_SYNC status changed
0	MPPT_FLAG	R	0x0		Max Power Point Tracking INT flag: Access: R (ClearOnRead) 0b = Normal 1b = MPPT_STAT[1:0] bits changed (transitioned to any state)

7.5.26 REG0x27_Fault_Flag Register (Address = 0x27) [Reset = 0x02]

REG0x27_Fault_Flag is shown in Table 7-34.

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Table 7-34. REG0x27_Fault_Flag Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	VAC_UV_FLAG	R	0x0		Input under-voltage INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Entered input under-voltage fault
6	VAC_OV_FLAG	R	0x0		Input over-voltage INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Entered Input over-voltage fault
5	IBAT_OCP_FLAG	R	0x0		Battery over-current INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Entered Battery over-current fault
4	VBAT_OV_FLAG	R	0x0		Battery over-voltage INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Entered battery over-voltage fault
3	TSHUT_FLAG	R	0x0		Thermal shutdown INT flag: Access: R (ClearOnRead) 0b = Normal 1b = Entered TSHUT fault
2	RESERVED	R	0x0		Reserved
1	DRV_OKZ_FLAG	R	0x1		DRV_SUP pin voltage INT flag: Access: R (ClearOnRead) 0b = Normal 1b = DRV_SUP pin fault detected
0	RESERVED	R	0x0		Reserved

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7.5.27 REG0x28_Charger_Mask_1 Register (Address = 0x28) [Reset = 0x00]

REG0x28_Charger_Mask_1 is shown in Table 7-35.

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Table 7-35. REG0x28_Charger_Mask_1 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	ADC_DONE_MASK	R/W	0x0	Reset by: REG_RESET	ADC conversion INT mask (in one-shot mode only): 0b = ADC_DONE produces INT pulse 1b = ADC_DONE does not produce INT pulse
6	IAC_DPM_MASK	R/W	0x0	Reset by: REG_RESET	Input Current regulation INT mask: 0b = IAC_DPM_FLAG produces INT pulse 1b = IAC_DPM_FLAG does not produce INT pulse
5	VAC_DPM_MASK	R/W	0x0	Reset by: REG_RESET	Input Voltage regulation INT mask: 0b = VAC_DPM_FLAG produces INT pulse 1b = VAC_DPM_FLAG does not produce INT pulse
4	RESERVED	R	0x0		Reserved
3	WD_MASK	R/W	0x0	Reset by: REG_RESET	I2C Watchdog timer INT mask: 0b = WD expiration produces INT pulse 1b = WD expiration does not produce INT pulse
2	RESERVED	R	0x0		Reserved
1	CV_TMR_MASK	R/W	0x0	Reset by: REG_RESET	CV timer INT mask: 0b = CV Timer expired rising edge produces INT pulse 1b = CV Timer expired rising edge does not produce INT pulse
0	CHARGE_MASK	R/W	0x0	Reset by: REG_RESET	Charge cycle INT mask: 0b = CHARGE_STAT change produces INT pulse 1b = CHARGE_STAT change does not produces INT pulse

7.5.28 REG0x29_Charger_Mask_2 Register (Address = 0x29) [Reset = 0x00]

REG0x29_Charger_Mask_2 is shown in Table 7-36.

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Table 7-36. REG0x29_Charger_Mask_2 Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	PG_MASK	R/W	0x0	Reset by: REG_RESET	Input Power Good INT mask: 0b = PG toggle produces INT pulse 1b = PG toggle does not produce INT pulse
6	ACFET_MASK	R/W	0x0	Reset by: REG_RESET	ACFET driver INT mask: 0b = ACFET toggle produces INT pulse 1b = ACFET toggle does not produce INT pulse
5	BATFET_MASK	R/W	0x0	Reset by: REG_RESET	BATFET driver INT mask: 0b = BATFET toggle produces INT pulse 1b = BATFET toggle does not produce INT pulse
4	TS_MASK	R/W	0x0	Reset by: REG_RESET	TS (Battery NTC) INT mask: 0b = TS_STAT change produces INT pulse 1b = TS_STAT change does not produce INT pulse
3	REVERSE_MASK	R/W	0x0	Reset by: REG_RESET	Reverse Mode INT mask: 0b = REVERSE_STAT toggle produces INT pulse 1b = REVERSE_STAT toggle does no produce INT pulse

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Table 7-36. REG0x29_Charger_Mask_2 Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
2	RESERVED	R	0x0		Reserved
1	FSW_SYNC_MASK	R/W	0x0	Reset by: REG_RESET	FSW_SYNC pin signal INT mask: 0b = FSW_SYNC status change produces INT pulse 1b = FSW_SYNC status change does not produce INT pulse
0	RESERVED	R	0x0		Reserved

7.5.29 REG0x2A_Fault_Mask Register (Address = 0x2A) [Reset = 0x00]

REG0x2A_Fault_Mask is shown in Table 7-37.

Return to the Summary Table.

Table 7-37. REG0x2A_Fault_Mask Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	VAC_UV_MASK	R/W	0x0	Reset by: REG_RESET	Input under-voltage INT mask: 0b = Input under-voltage event produces INT pulse 1b = Input under-voltage event does not produce INT pulse
6	VAC_OV_MASK	R/W	0x0	Reset by: REG_RESET	Input over-voltage INT mask: 0b = Input over-voltage event produces INT pulse 1b = Input over-voltage event does not produce INT pulse
5	IBAT_OCP_MASK	R/W	0x0	Reset by: REG_RESET	Battery over-current INT mask: 0b = Battery over-current event produces INT pulse 1b = Battery over-current event does not produce INT pulse
4	VBAT_OV_MASK	R/W	0x0	Reset by: REG_RESET	Battery over-voltage INT mask: 0b = Battery over-voltage event produces INT pulse 1b = Battery over-voltage event does not produce INT pulse
3	TSHUT_MASK	R/W	0x0	Reset by: REG_RESET	Thermal shutdown INT mask: 0b = TSHUT event produces INT pulse 1b = TSHUT event does not produce INT pulse
2	RESERVED	R	0x0		Reserved
1	DRV_OKZ_MASK	R/W	0x0	Reset by: REG_RESET	DRV_SUP pin voltage INT mask: 0b = DRV_SUP pin fault produces INT pulse 1b = DRV_SUP pin fault does not produce INT pulse
0	RESERVED	R	0x0		Reserved

7.5.30 REG0x2B_ADC_Control Register (Address = 0x2B) [Reset = 0xE0]

REG0x2B_ADC_Control is shown in Table 7-38.

Return to the Summary Table.

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Table 7-38. REG0x2B_ADC_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	ADC_EN	R/W	0x1	When EN_VREG_TEMP_COMP = 1, the ADC will be automatically enabled, regardless of the status of ADC_EN Reset by: REG_RESET WATCHDOG	ADC control: 0b = Disable ADC 1b = Enable ADC
6	ADC_RATE	R/W	0x1	Reset by: REG_RESET	ADC conversion rate control: 0b = Continuous conversion 1b = One-shot conversion
5:4	ADC_SAMPLE	R/W	0x2	Reset by: REG_RESET	ADC sample speed: 00b = 15 bit effective resolution 01b = 14 bit effective resolution 10b = 13 bit effective resolution 11b = Reserved
3	ADC_AVG	R/W	0x0	Reset by: REG_RESET	ADC average control: 0b = Single value 1b = Running average
2	ADC_AVG_INIT	R/W	0x0	Reset by: REG_RESET	ADC average initial value control: 0b = Start average using existing register value 1b = Start average using new ADC conversion
1:0	RESERVED	R	0x0		Reserved

7.5.31 REG0x2C_ADC_Channel_Control Register (Address = 0x2C) [Reset = 0x02]

REG0x2C_ADC_Channel_Control is shown in Table 7-39.

Return to the Summary Table.

Table 7-39. REG0x2C_ADC_Channel_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	IAC_ADC_DIS	R/W	0x0	Reset by: REG_RESET	IAC ADC control 0b = Enable 1b = Disable
6	IBAT_ADC_DIS	R/W	0x0	Recommend to disable IBAT ADC channel when EN_IBAT_LOAD bit is 1 Reset by: REG_RESET	IBAT ADC control 0b = Enable 1b = Disable
5	VAC_ADC_DIS	R/W	0x0	Reset by: REG_RESET	VAC ADC control 0b = Enable 1b = Disable
4	VBAT_ADC_DIS	R/W	0x0	Reset by: REG_RESET	VBAT ADC control 0b = Enable 1b = Disable
3	VSYS_ADC_DIS	R/W	0x0	Reset by: REG_RESET	VSYS ADC control 0b = Enable 1b = Disable
2	TS_ADC_DIS	R/W	0x0	Reset by: REG_RESET	TS ADC control 0b = Enable 1b = Disable

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Table 7-39. REG0x2C_ADC_Channel_Control Register Field Descriptions (continued)

Bit	Field	Type	Reset	Notes	Description
1	VFB_ADC_DIS	R/W	0x1	Reset by: REG_RESET	VFB ADC control Recommend to disable this channel when charging is enabled 0b = Enable 1b = Disable
0	RESERVED	R	0x0		Reserved

7.5.32 REG0x2D_IAC_ADC Register (Address = 0x2D) [Reset = 0x0000]

REG0x2D_IAC_ADC is shown in Table 7-40.

Return to the Summary Table.

I2C REG0x2E=[15:8], I2C REG0x2D=[7:0]

Table 7-40. REG0x2D_IAC_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	IAC_ADC	R	0x0		IAC ADC reading with 2mΩ RAC_SNS: Reported as 2s complement POR: 0mA (0h) Format: 2s Complement Range: -50000mA-50000mA (9E58h-61A8h) Clamped Low Clamped High Bit Step: 2mA

7.5.33 REG0x2F_IBAT_ADC Register (Address = 0x2F) [Reset = 0x0000]

REG0x2F_IBAT_ADC is shown in Table 7-41.

Return to the Summary Table.

I2C REG0x30=[15:8], I2C REG0x2F=[7:0]

Table 7-41. REG0x2F_IBAT_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	IBAT_ADC	R	0x0		IBAT ADC reading with 5mΩ RBAT_SNS: Reported as 2s complement POR: 0mA (0h) Format: 2s Complement Range: -20000mA-20000mA (D8F0h-2710h) Clamped Low Clamped High Bit Step: 2mA

7.5.34 REG0x31_VAC_ADC Register (Address = 0x31) [Reset = 0x16F8]

REG0x31_VAC_ADC is shown in Table 7-42.

Return to the Summary Table.

I2C REG0x32=[15:8], I2C REG0x31=[7:0]

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Table 7-42. REG0x31_VAC_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	VAC_ADC	R	0x16F8		VAC ADC reading: Reported as unsigned integer POR: 0mV (0h) Format: 2s Complement Range: 0mV-65534mV (0h-7FFFh) Clamped Low Bit Step: 2mV

7.5.35 REG0x33_VBAT_ADC Register (Address = 0x33) [Reset = 0x16DE]

REG0x33_VBAT_ADC is shown in Table 7-43.

Return to the Summary Table.

I2C REG0x34=[15:8], I2C REG0x33=[7:0]

Table 7-43. REG0x33_VBAT_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	VBAT_ADC	R	0x16DE		VBAT ADC reading: Reported as unsigned integer POR: 0mV (0h) Format: 2s Complement Range: 0mV-65534mV (0h-7FFFh) Clamped Low Bit Step: 2mV

7.5.36 REG0x35_VSYS_ADC Register (Address = 0x35) [Reset = 0x171B]

REG0x35_VSYS_ADC is shown in Table 7-44.

Return to the Summary Table.

I2C REG0x36=[15:8], I2C REG0x35=[7:0]

Table 7-44. REG0x35_VSYS_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	VSYS_ADC	R	0x171B		VSYS ADC reading: Reported as unsigned integer POR: 0mV (0h) Format: 2s Complement Range: 0mV-65534mV (0h-7FFFh) Clamped Low Bit Step: 2mV

7.5.37 REG0x37_TS_ADC Register (Address = 0x37) [Reset = 0x0253]

REG0x37_TS_ADC is shown in Table 7-45.

Return to the Summary Table.

I2C REG0x38=[15:8], I2C REG0x37=[7:0]

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Table 7-45. REG0x37_TS_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	TS_ADC	R	0x0253		TS ADC reading as percentage of REGN: Reported as unsigned integer POR: 0%(0h) Range: 0% - 99.90234375% (0h-3FFh) Clamped High Bit Step: 0.09765625%

7.5.38 REG0x39_VFB_ADC Register (Address = 0x39) [Reset = 0x0000]

REG0x39_VFB_ADC is shown in Table 7-46.

Return to the Summary Table.

I2C REG0x3A=[15:8], I2C REG0x39=[7:0]

Table 7-46. REG0x39_VFB_ADC Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
15:0	VFB_ADC	R	0x0		VFB ADC reading: POR: 0mV (0h) Range: 0mV-2047mV (0h-7FFh) Clamped High Bit Step: 1mV

7.5.39 REG0x3B_Gate_Driver_Strength_Control Register (Address = 0x3B) [Reset = 0x00]

REG0x3B_Gate_Driver_Strength_Control is shown in Table 7-47.

Return to the Summary Table.

Table 7-47. REG0x3B_Gate_Driver_Strength_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	BOOST_HS_DRV	R/W	0x0	Reset by: REG_RESET	Boost High Side FET Gate Driver Strength: 00b = Fastest 01b = Faster 10b = Slower 11b = Slowest
5:4	BUCK_HS_DRV	R/W	0x0	Reset by: REG_RESET	Buck High Side FET Gate Driver Strength: 00b = Fastest 01b = Faster 10b = Slower 11b = Slowest
3:2	BOOST_LS_DRV	R/W	0x0	Reset by: REG_RESET	Boost Low Side FET Gate Driver Strength: 00b = Fastest 01b = Faster 10b = Slower 11b = Slowest
1:0	BUCK_LS_DRV	R/W	0x0	Reset by: REG_RESET	Buck Low Side FET Gate Driver Strength: 00b = Fastest 01b = Faster 10b = Slower 11b = Slowest

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7.5.40 REG0x3C_Gate_Driver_Dead_Time_Control Register (Address = 0x3C) [Reset = 0x00]

REG0x3C_Gate_Driver_Dead_Time_Control is shown in Table 7-48.

Return to the Summary Table.

Table 7-48. REG0x3C_Gate_Driver_Dead_Time_Control Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:4	RESERVED	R	0x0		Reserved
3:2	BOOST_DEAD_TIME	R/W	0x0	Reset by: REG_RESET	Boost Side FETs Dead Time Control: 00b = 45ns 01b = 75ns 10b = 105ns 11b = 135ns
1:0	BUCK_DEAD_TIME	R/W	0x0	Reset by: REG_RESET	Buck Side FETs Dead Time Control: 00b = 45ns 01b = 75ns 10b = 105ns 11b = 135ns

7.5.41 REG0x3D_Part_Information Register (Address = 0x3D) [Reset = 0x0A]

REG0x3D_Part_Information is shown in Table 7-49.

Return to the Summary Table.

Table 7-49. REG0x3D_Part_Information Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7	RESERVED	R	0x0		Reserved
6:3	PART_NUM	R	0x1		Part Number: 001 - BQ25751
2:0	DEV_REV	R	0x2		Device Revision:

7.5.42 REG0x62_Reverse_Mode_Battery_Discharge_Current Register (Address = 0x62) [Reset = 0x02]

REG0x62_Reverse_Mode_Battery_Discharge_Current is shown in Table 7-50.

Return to the Summary Table.

Table 7-50. REG0x62_Reverse_Mode_Battery_Discharge_Current Register Field Descriptions

Bit	Field	Type	Reset	Notes	Description
7:6	IBAT_REV	R/W	0x0	Reset by: REG_RESET	Reverse mode battery discharge current limit: 00b = 20A 01b = 15A 10b = 10A 11b = 5A
5:2	RESERVED	R	0x0		Reserved
1	EN_CONV_FAST_TRANSIENT	R/W	0x1	Reset by: REG_RESET	Enable converter fast transient response in reverse mode only - 0b = Disable 1b = Enable
0	HANDOFF_OC_DG	R/W	0x0	Reset by: REG_RESET	Deglitch on OC trip during handoff 0b = Sync 1b = 100us

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The BQ25751 battery charger is ideal for high current charging (up-to 20A) and can charge Pb-Acid batteries up-to 70V. The BQ25751EVM evaluation module is a complete charge module for evaluating the device performance. The application curves are taken using the BQ25751EVM.

8.2 Typical Applications

8.2.1 Typical Application (Standalone)

The device can be configured for direct power path applications, where the input source can be used to power both system as well as charge the battery. When the input source falls outside the VAC operating window programmed through ACUV and ACOV, the battery is automatically connected to the system. Figure 8-1 shows a typical schematic when using the device with power path to charge a 48V lead-acid battery from a 48V input source.

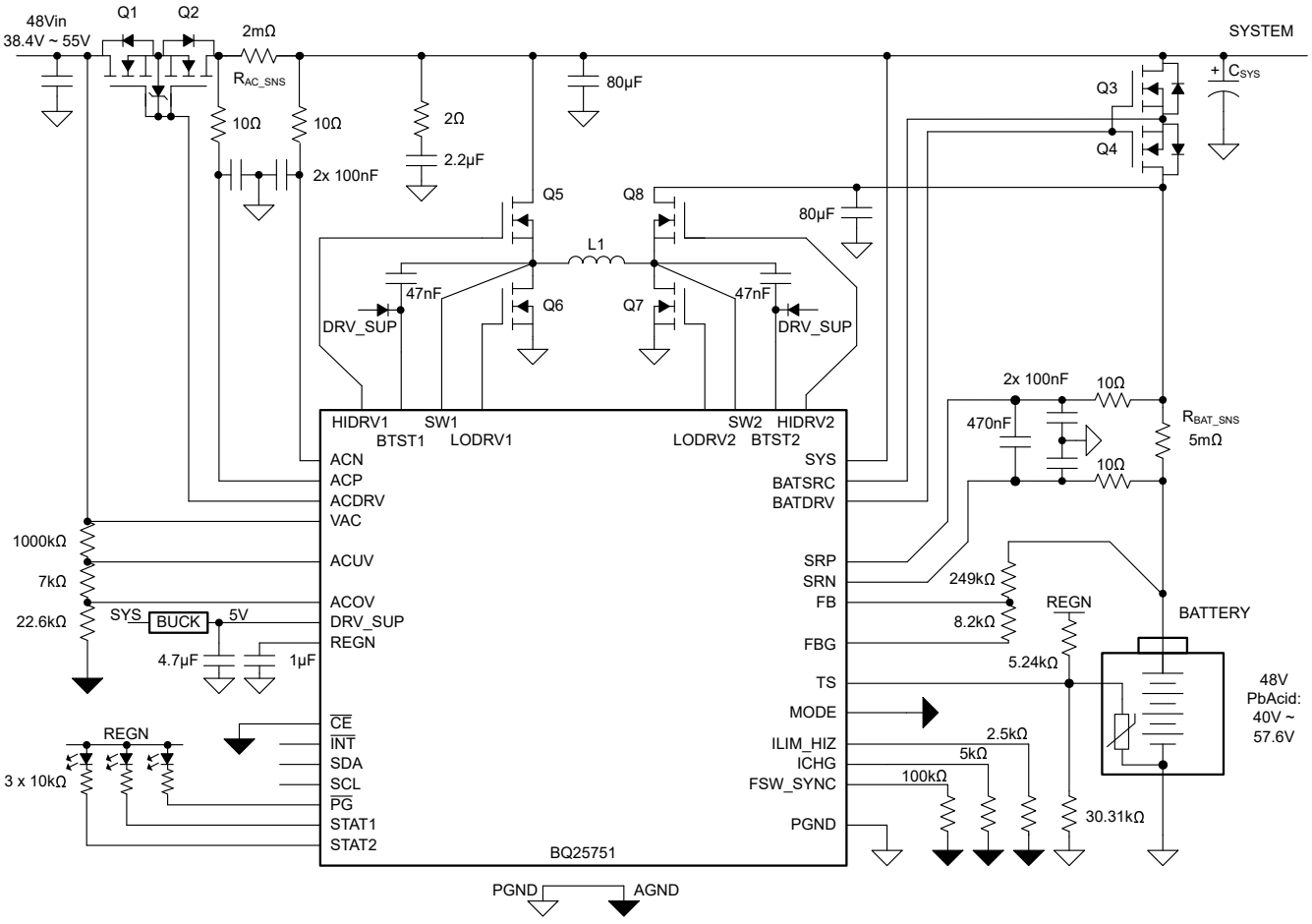


Figure 8-1. BQ25751: Standalone, 48VAC with 48V Lead-Acid Battery and 10A Charge Current

Table 8-1. Recommended Part Numbers:

COMPONENT	VALUE	RECOMMENDED PART NUMBER
Q1, Q2	80V, 2.6mΩ	AON6276
Q3, Q4	100V, 4.3mΩ	NTMFSC4D2N10MC
Q5, Q6, Q7, Q8	100V, 8.2mΩ	AONS66920
L1	4.7uH, 15mΩ	IHLP5050EZER4R7M01

8.2.1.1 Design Requirements

For this design example, use the parameters shown in the table below.

Table 8-2. Design Parameters

PARAMETER	VALUE
Input voltage operating range (V_{AC})	48V
Input current limit (I_{AC})	10A
Fast-charge current limit (I_{CHG})	10A
Battery Charge Voltage (V_{BAT_REG})	48V
Switching frequency	300kHz

8.2.1.2 Detailed Design Procedure

8.2.1.2.1 ACUV / ACOV Input Voltage Operating Window Programming

The input voltage operating window is programmed by an ACUV / ACOV window with a resistor divider from VAC to GND. The top resistor, RAC1, is typically selected as 1,000kΩ to minimize the input voltage leakage current. Assuming the desired trip-points for under-voltage and over-voltage protection are labeled V_{VACUVP} and V_{VACOVP}, the resistor divider required can be calculated as follows. The internal reference for the over-voltage threshold (VREF_ACOV) is 1.2V. The internal reference for the under-voltage threshold (VREF_ACUV) is 1.1V.

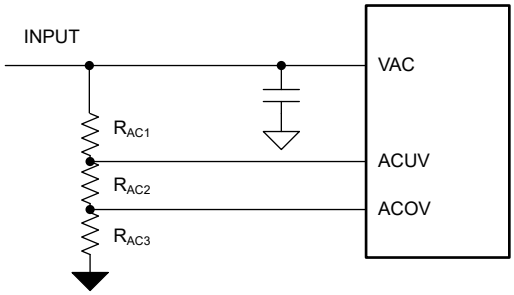


Figure 8-2. ACUV and ACOV Resistor Divider

$$V_{VACOVP} = \frac{1.2V(1{,}000k\Omega + R_{AC2} + R_{AC3})}{R_{AC3}} \quad (6)$$

$$V_{VACUVP} = \frac{1.1V(1{,}000k\Omega + R_{AC2} + R_{AC3})}{R_{AC2} + R_{AC3}} \quad (7)$$

For the default device operating window of 4.4V to 60V, the ACUV can be pulled up directly to VAC, while the ACOV can be pulled directly to GND.

8.2.1.2.2 Charge Voltage Selection

The battery regulation voltage is programmed using a resistor divider to the FB pin. The default internal voltage reference is 1.536V, and can be changed via the VFB_REG register bits. The top of the resistor divider is selected to be 249 kΩ.

R_{TOP} = 249 kΩ

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The bottom resistor can be calculated as:

$$R_{BOT} = R_{TOP} \times \frac{V_{FB}}{V_{BATREG} - V_{FB}} - R_{FBG} \quad (8)$$

where

- V_{FB} is the target feedback voltage programmed through I^2C (default 1.536 V),
- V_{BATREG} is the desired battery regulation target (48V in this example)
- R_{FBG} is the internal FBG pull-down resistor (33 Ω)

R_{FB_BOT} = 8.2 kΩ.

Choosing the nearest 0.1% resistor value, gives R_{FB_BOT} = 8.2 kΩ, for a nominal charge voltage of 48 V. Further fine-tuning of the regulation voltage can be achieved by changing the internal feedback reference.

It is recommended to use 0.1% accurate resistors to maximize the charge voltage accuracy.

8.2.1.2.3 Switching Frequency Selection

The switching frequency is set by a resistor connected from the FSW_SYNC pin to PGND. The RFSW resistor required to set the desired frequency is calculated using Equation 3 or Table 7-2. A 0.1% standard resistor of 100kΩ is selected to set f_{SW} = 300kHz.

8.2.1.2.4 Inductor Selection

Higher switching frequency allows the use of smaller inductor and capacitor values. Inductor saturation current must be higher than the inductor current (I_L) plus half the ripple current (I_{RIPPLE}):

$$I_{SAT} \geq I_L + \frac{1}{2} I_{RIPPLE} \quad (9)$$

The inductor ripple current in buck operation depends on input voltage (V_{AC}), duty cycle (D_{BUCK} = V_{BAT} /V_{AC}), switching frequency (f_{SW}) and inductance (L):

$$I_{RIPPLE_BUCK} = \frac{V_{AC} \times D_{BUCK} \times (1 - D_{BUCK})}{f_{SW} \times L} \quad (10)$$

The maximum inductor ripple current happens with D = 0.5 or close to 0.5. Ripple calculations must be analyzed for both forward and reverse operating modes if applicable.

Usually inductor ripple is designed in the range of (20 – 40%) maximum inductor current (in either forward or reverse mode) as a trade-off between inductor size and efficiency for a practical design. For system stability, the inductor's time constant must be between 0.05µH/mΩ and 1.26µH/mΩ.

8.2.1.2.5 Input (VAC / SYS) Capacitor

Input capacitor should have enough ripple current rating to absorb input switching ripple current. The worst case RMS ripple current is half of the output when duty cycle is 0.5 in forward buck mode, or reverse boost mode. If the converter does not operate at 50% duty cycle, then the worst case capacitor RMS current occurs where the duty cycle is closest to 50% and can be estimated by Equation 11:

$$I_{CIN} = I_{CHG} \times \sqrt{D \times (1 - D)} \quad (11)$$

A combination of ceramic and bulk capacitors must be used to provide a short path for high di/dt current and to reduce the voltage ripple. Ceramic capacitors must be placed close to the switching half-bridge. Given total bulk input capacitance, it is recommended to distribute equally on either side of R_{AC_SNS}. The complete schematic is a good starting point for input capacitor for typical applications.

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8.2.1.2.6 Output (VBAT) Capacitor

The output capacitor conducts high ripple current. The output capacitor RMS ripple current is given by where the minimum VAC corresponds to the maximum capacitor current.

$$I_{CBAT} = I_{BAT}\sqrt{\frac{V_{BAT}}{V_{AC}} - 1} \quad (12)$$

A 5mΩ output capacitor ESR causes an output voltage ripple of 74mV as given by:

$$\Delta V_{RIPPLE(ESR)} = I_{BAT} \times \frac{V_{BAT}}{V_{AC,min}} \times ESR \quad (13)$$

A 140µF output capacitor causes a capacitive ripple voltage of 66mV as given by:

$$\Delta V_{RIPPLE(CBAT)} = I_{BAT} \times \frac{\left(1 - \frac{V_{AC,min}}{V_{BAT}}\right)}{C_{BAT} \times f_{SW}} \quad (14)$$

A combination of ceramic and bulk capacitors must be used to provide low ESR and high ripple current capacity. Ceramic capacitors must be placed close to the switching half-bridge. Given total bulk output capacitance, it is recommended to distribute equally on either side of R_{BAT_SNS}. The complete schematic is a good starting point for C_{BAT} for typical applications.

8.2.1.2.7 Sense Resistor (R_{AC_SNS} and R_{BAT_SNS}) and Current Programming

The battery current sense resistor between SRP and SRN is fixed at 5mΩ; using a different value is not recommended. The input current sense resistor between ACP and ACN is typically 2mΩ, but can be changed to 5mΩ. In USB-PD applications, a 5mΩ sense resistor is recommended to achieve programmability in 50mA/step whereas for power-path applications, a 2mΩ sense resistor is preferred. In addition, if input current limit function is not desired, ACP and ACN can be shorted together. For both of these sense resistors, a filter network is recommended as shown in the Typical Application.

For both the input current and the output current, the limits may be programmed using the I^2C interface or an external programming resistor on ILIM_HIZ and ICHG pins, respectively.

Table 8-3. Sense Resistor and Current Programming

PARAMETER	FORMULA	VALUE
Input Current Hardware Limit	$R_{ILIM_HIZ} = K_{ILIM} / 20A$	2.5kΩ for 20A with 2mΩ R_{AC_SNS}
Output Current Hardware Limit	$R_{ICHG} = K_{ICHG} / 10A$	5kΩ for 10A with 5mΩ R_{BAT_SNS}

The default input sense resistor (R_{AC_SNS}) is 2mΩ, and the register allows for a range of up-to 50A input current limit.If a 5mΩ R_{AC_SNS} is used, and the register is programmed to a value of 0x60, the true maximum current across the R_{AC_SNS} will be: 50A * 2/5= 20A. With a 5mΩ R_{AC_SNS} resistor, a 6A current limit would be achieved as: $R_{ILIM} = K_{ILIM} * (2/5) / 6A = 3.3k\Omega$.

8.2.1.2.8 ACFETs and BATFETs Selection

External N-channel MOSFETs are used for power path transfer. Those on the VAC side are called ACFETs and those on the VBAT side are called BATFETs.

The proper trade off for selecting these MOSFETs depends on the SOA characteristics. All FETs follow the same trend hence the same FET can be used at all places for regular operation and power path handover. It is essential to select a MOSFET that offers close to 10A Drain Current at 30V V_{DS} at DC and also has the capability to offer 100A Drain Current at 30V V_{DS} at 10 µs without breaking. Furthermore, the SOA characteristics must be such that the maximum junction temperature must be at least 125°C. The FETs selected for this application are AON6276 and can withstand a voltage swing of up-to 30V from VAC to VBAT and vice-versa.

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Even though rugged high SOA MOSFETs are being used, it is still essential to limit the maximum amount of current that is allowed to flow from the battery to the system load. This is done by setting the power path overcurrent protection to a limit of 15A. This means that the maximum load for which we can achieve a successful power path transfer from VAC to VBAT is 15A. Furthermore, it must be noted that in cases where VAC > VBAT, the ACUV must be set to a value between VAC and VBAT. For cases where VBAT > VAC, the ACUV must be set just below VAC.

In some special cases, the battery has to be plugged into the system suddenly at a very high voltage which causes a large inrush current. This is called a battery hot plug. In such an application is desired, our recommendation is to replace the BATFETs with NTMFSC4D2N10MC FETs. These FETs have a higher threshold voltage which is desirable for hot plug applications. For hot plug applications, R9 and C36 on the EVM must be populated with a 10Ω resistor and 10nF capacitor respectively. This prevents a sudden rise and shoot through of the current and protects the FETs from being damaged.

8.2.1.2.9 Converter Fast Transient Response

The device integrates all the loop compensation, thereby providing a high density solution with ease of use. For faster a transient response, the EN_CONV_FAST_TRANSIENT bit can be set to 1. If device is not used in boost mode operation, this section can be disregarded.

When the converter is operating in boost mode, the non-continuous inductor current flow to the load results in a right-half plane (RHP) zero. The RHP zero location is:

$$RHPz = \frac{V_{IN,boost}}{I_{IN,boost}} \frac{1}{2\pi L} \tag{15}$$

For good phase margin, the unity gain bandwidth (UGBW) of the converter must be about 1/3 of the RHPz. The boost output capacitor (C_{load}), and the converter transient parameters (R_1, gm_1) need to be scaled to move the location of the UGBW of the converter.

$$1 \approx \frac{Adiv \times gm_1(sR_1C_1 + 1)}{sC_1}\left[\frac{V_i}{I_O \times 50m}\right]\left[\frac{1}{1 + s\frac{C_{load}R_{load}}{2}}\right] \tag{16}$$

The device adjusts *Adiv*, gm_1 and R_1 based on the output voltage and the EN_CONV_FAST_TRANSIENT bit setting per the table below. During some boost case scenarios, the C_{load} needs to be adjusted to limit the converter bandwidth.

Table 8-4. Converter Fast Transient Response

BOOST OUTPUT VOLTAGE	*Adiv*	C_1	EN_CONV_FAST_TRANSIENT = 0		EN_CONV_FAST_TRANSIENT = 1	
			gm_1	R_1	gm_1	R_1
≤8V	1/5	75pF	0.4µ	600kΩ	2µ	1.3MΩ
8V to 16V	1/10	75pF	0.47µ	1MΩ	2µ	1.8MΩ
16V to 32V	1/20	75pF	0.67µ	2.8MΩ	2µ	2.8MΩ
>32V	1/40	75pF	2µ	2.8MΩ	2µ	2.8MΩ

As an example, assume the device operates in reverse boost mode from a 5V supply to provide a 7V boost output voltage with load up-to 5A and 10µH inductor. The RHPz is approximately located at:

$$RHPz = \frac{V_{IN,boost}}{I_{IN,boost}} \frac{1}{2\pi L} = 11.4kHz \tag{17}$$

For best stability, the UGBW of the converter must be limited to 1/3 of the RHP zero, or 3.8kHz. If EN_CONV_FAST_TRANSIENT = 1, the equation becomes:

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$$1 \approx \frac{0.2 \times 2\mu\,(j\omega \times 1.3M\Omega \times 75pF + 1)}{j\omega \times 75pF}\left[\frac{5V}{5A \times 50m}\right]\left[\frac{1}{1 + j\omega\frac{C_{load} \times 1.4}{2}}\right] \quad (18)$$

Solving the above for C_{load} gives ≥674µF capacitor requirement.

Conversely, if EN_CONV_FAST_TRANSIENT = 0, the UGBW equation becomes:

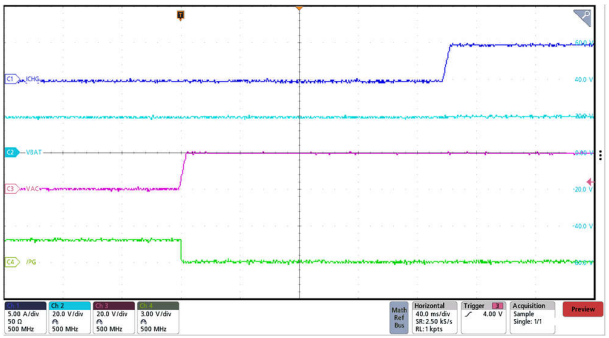
$$1 \approx \frac{0.2 \times 0.4\mu\,(j\omega \times 0.6M\Omega \times 75pF + 1)}{j\omega \times 75pF}\left[\frac{5V}{5A \times 50m}\right]\left[\frac{1}{1 + j\omega\frac{C_{load} \times 1.4}{2}}\right] \quad (19)$$

Solving the above for C_{load} gives ≥51µF capacitor requirement. However, the minimum recommended capacitor for converter stability is 80µF, so this minimum value must be used.

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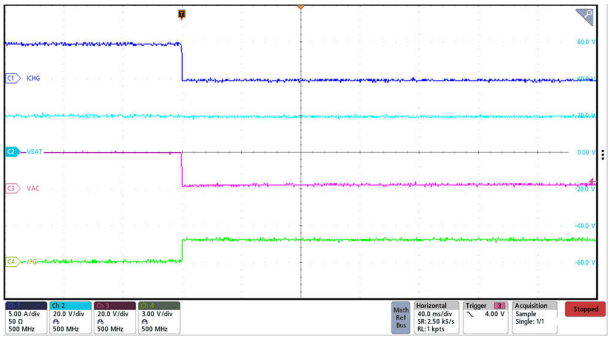
8.2.1.3 Application Curves

C_{VAC} = 160µF, C_{OUT} = 160µF



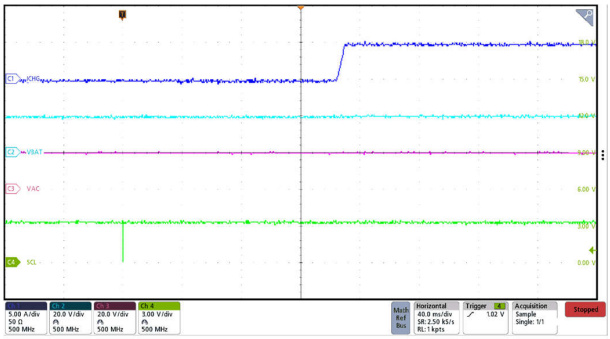
VAC = 20V VBAT = 20V ICHG = 5A

Figure 8-3. VAC Plug-In Power Up with 5A ICHG



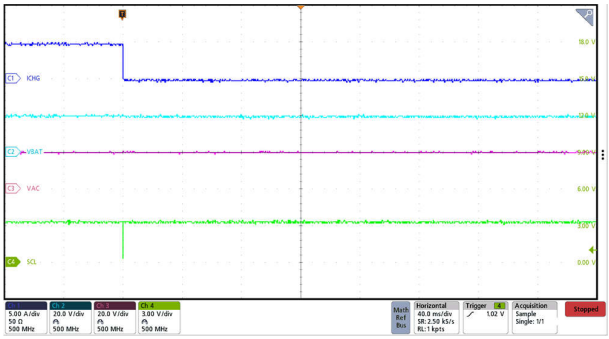
VAC = 20V → 0V VBAT = 20V ICHG = 5A

Figure 8-4. VAC Un-plug Power Down with 5A ICHG



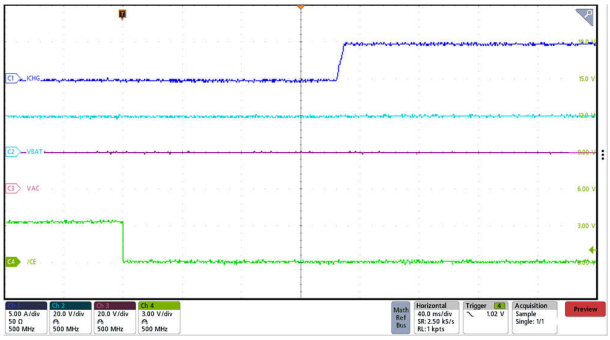
VAC = 20V VBAT = 24V ICHG = 5A

Figure 8-5. Charge Enable via I²C with 5A ICHG



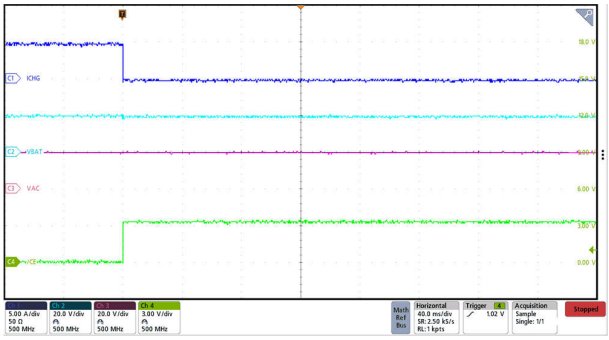
VAC = 20V VBAT = 24V ICHG = 5A

Figure 8-6. Charge Disable via I²C with 5A ICHG



VAC = 20V VBAT = 24V ICHG = 5A

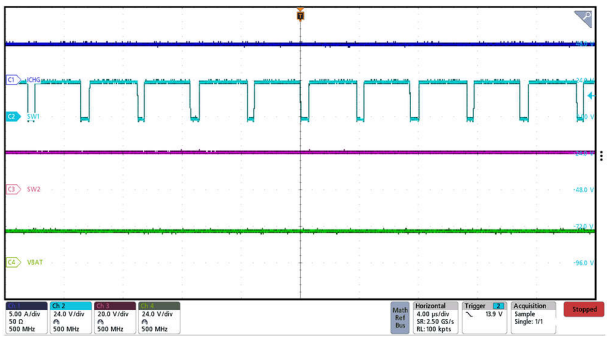
Figure 8-7. Charge Enable via $\overline{CE}$ Pin with 5A ICHG



VAC = 20V VBAT = 24V ICHG = 5A

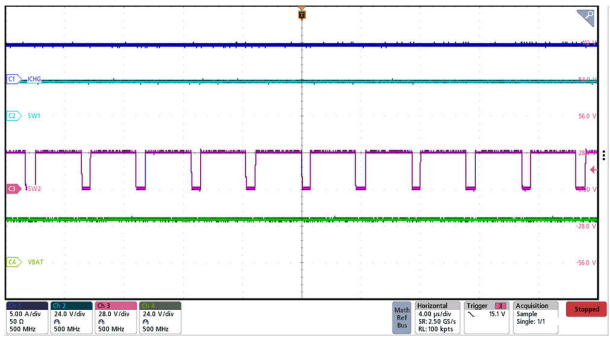
Figure 8-8. Charge Disable via $\overline{CE}$ Pin with 5A ICHG

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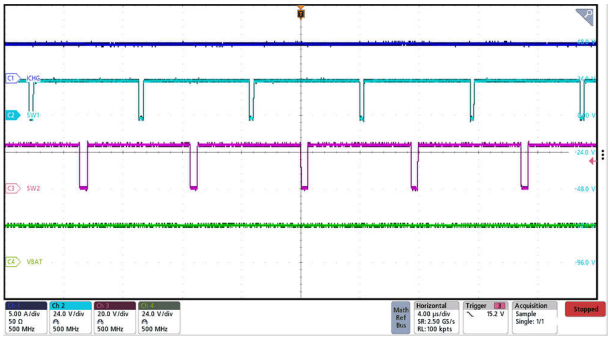
VAC = 24V VBAT = 20V ICHG = 5A

Figure 8-9. Buck Switching Waveform



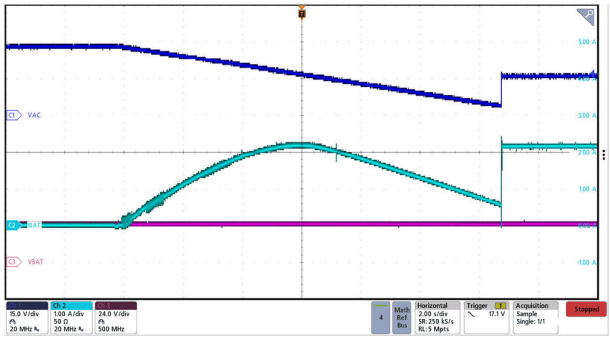
VAC = 24V VOUT = 28V ICHG = 5A

Figure 8-10. Boost Switching Waveform



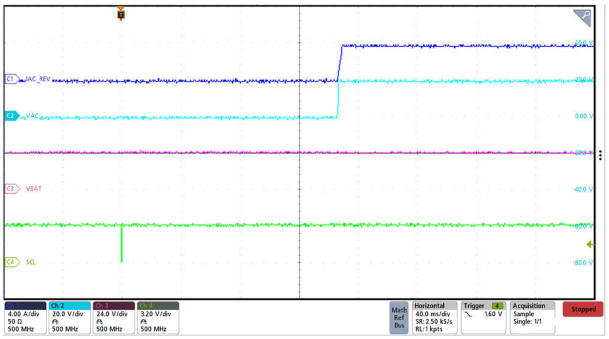
VAC = 24V VBAT = 24V ICHG = 5A

Figure 8-11. Buck-Boost Switching Waveform



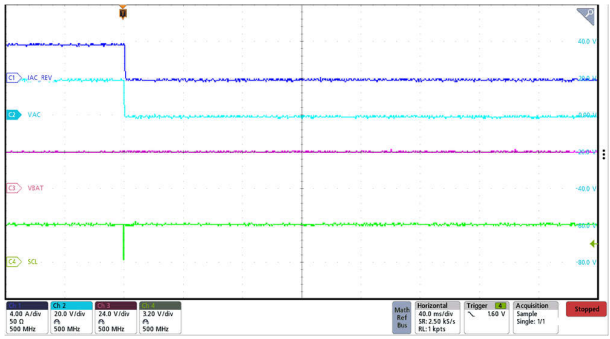
V_{OC} = 30V VBAT = 24V EN_CHG = 0→ 1
I_{SC} = 3.5A

Figure 8-12. Max Power Point Tracking (MPPT) Full Panel Sweep



VBAT = 24V VAC_REV = 20V ILOAD = 4A

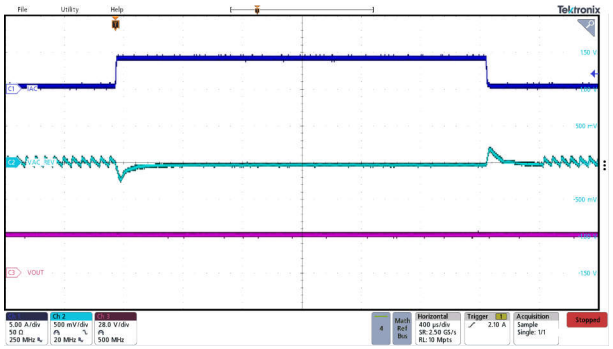
Figure 8-13. Reverse Mode Power Up with 4A Load



VBAT = 24V VAC_REV = 20V ILOAD = 4A

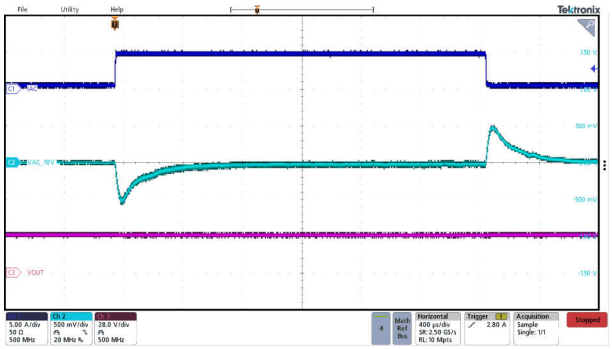
Figure 8-14. Reverse Mode Power Down with 4A Load

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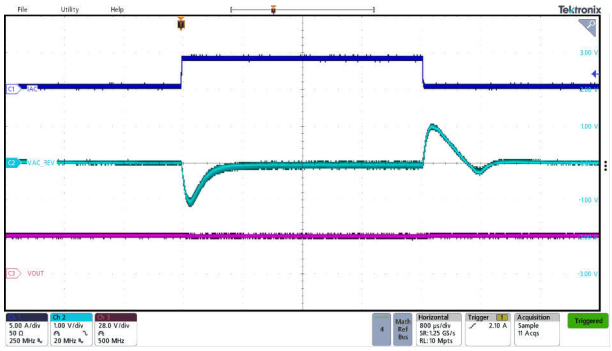
VBAT = 28V VAC_REV = 5V ILOAD = 0.5A → 4.5A

Figure 8-15. Reverse Mode Buck Transient Response



VBAT = 28V VAC_REV = 28V ILOAD = 0.5A → 4.5A

Figure 8-16. Reverse Mode Buck-Boost Transient Response



VBAT = 28V VAC_REV = 48V ILOAD = 0.5A → 4.5A

Figure 8-17. Reverse Mode Boost Transient Response

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9 Power Supply Recommendations

The power supply for the device is any DC voltage source within the specified input range. The supply must also be capable of supplying sufficient current based on the programmed input current limit. The input supply must be bypassed with a combination of electrolytic and ceramic capacitors to avoid ringing due to the parasitic impedance of the connecting cables.

When device is operating in the reverse direction, the supply at the OUTPUT should follow the same recommendations as the input supply mentioned above.

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10 Layout

10.1 Layout Guidelines

Proper layout of the components to minimize high frequency current path loops is important to prevent electrical and magnetic field radiation and high frequency resonant problems. Here is a PCB layout priority list for proper layout.

Table 10-1. PCB Layout Guidelines

COMPONENTS	FUNCTION	IMPACT	GUIDELINES
Buck high side FET, Buck low side FET, input capacitors	Buck input loop	High frequency noise, ripple, efficiency	This path forms a high frequency switching loop due to the pulsating current at the input of the buck. Place components on the same side of the board. Minimize loop area to reduce parasitic inductance. Maximize trace width to reduce parasitic resistance. Place input ceramic capacitors close to the switching FETs.
Boost low side FET, boost high side FET, output capacitors	Boost output loop	High frequency noise, ripple, efficiency	This path forms a high frequency switching loop due to the pulsating current at the output of the boost. Place components on the same side of the board. Minimize loop area to reduce parasitic inductance. Maximize trace width to reduce parasitic resistance. Place output ceramic capacitors close to the switching FETs.
Sense resistors, switching FETs, inductor	Current path	Efficiency	The current path from input to output through the power stage and sense resistors needs to have low impedance. Pay attention to via resistance if the components are not on the same side. The number of vias can be estimated as 1 to 2A per via for a 10-mil via with 1 oz. copper thickness.
Switching FETs, inductor	Power stage	Thermal, efficiency	The switching FETs and inductor are the components with highest power loss. Allow enough copper area for heat dissipation. Multiple thermal vias can be used to connect more copper layers together and dissipate more heat.
DRV_SUP, BTST1, BTST2 capacitors	Switching FET gate drive	High frequency noise, parasitic ringing, gate drive integrity	The DRV_SUP capacitor is used to supply the power to drive the low side FETs. The BTST capacitors are used to drive the high side FETs. It is recommended to place the capacitors as close as possible to the IC.
LODRV1, LODRV2	Low side gate drive	High frequency noise, parasitic ringing, gate drive integrity	LODRV1 and LODRV2 supplies the gate drive current to turn on the low side FETs. The return of LODRV1 and LODRV2 is PGND. As current takes the path of least impedance, a ground plane close to the low side gate drive traces is recommended. Minimize gate drive length and aim for at least 20-mil gate drive trace width.
HIDRV1, HIDRV2, SW1 (pin trace), SW2 (pin trace)	High side gate drive	High frequency noise, parasitic ringing, gate drive integrity	HIDRV1 and HIDRV2 supplies the gate drive current to turn on the high side FETs. The return of HIDRV1 and HIDRV2 are SW1 and SW2, respectively. Route the HIDRV1/SW1 and the HIDRV2/SW2 pair next to each other to reduce gate drive parasitic inductance. Minimize gate drive length and aim for at least 20-mil gate drive trace width. Do not route the HIDRV1/HIDRV2 trace next to the LODRV1/LODRV2 trace.

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Table 10-1. PCB Layout Guidelines (continued)

COMPONENTS	FUNCTION	IMPACT	GUIDELINES
Current limit resistors, FSW_SYNC resistor	IC programmable settings	Regulation accuracy, switching integrity	Pin voltage determines the settings for input current limit, output current limit and switching frequency. Ground noise on these could lead to inaccuracy. Minimize ground return from these resistors to the IC ground pin.
Input (ACP, ACN) and output (SRP, SRN) current sense	Current regulation	Regulation accuracy	Use Kelvin-sensing technique for input and output current sense resistors. Connect the current sense traces to the center of the pads, and run current sense traces as differential pairs, away from switching nodes.
Input (ACUV), and output (FB, VO_SNS) voltage sensing	Voltage sense and regulation	Regulation accuracy	ACUV divider sets internal input voltage regulation in forward mode (V_{ACUV_DPM}). FB divider sets battery voltage regulation in forward mode (V_{FB_ACC}). Route the top of the divider point to the target regulation location. Avoid routing close to high power switching nodes.
Bypass capacitors	Noise filter	Noise immunity	Place lowest value capacitors closest to the IC.

10.2 Layout Example

Based on the above layout guidelines, the PCB layout example top view is shown below including all the key power components.

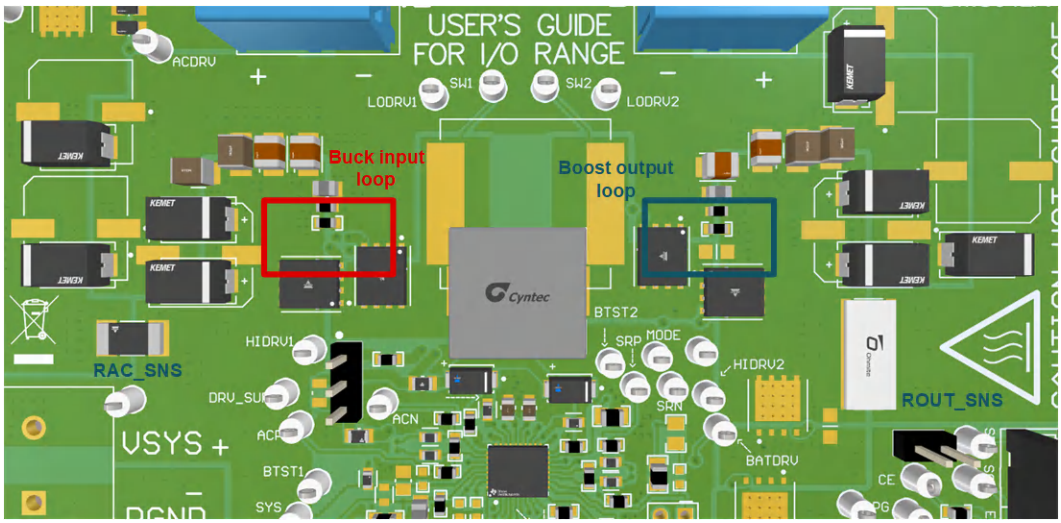


Figure 10-1. PCB Layout Reference Example Top View

For both input and output current sensing resistors, differential sensing and routing method are suggested and highlighted in figure below. Use wide trace for gate drive traces, minimum 20-mil trace width. Connect all analog grounds to a dedicated low-impedance copper plane, which is tied to the power ground underneath the IC exposed pad.

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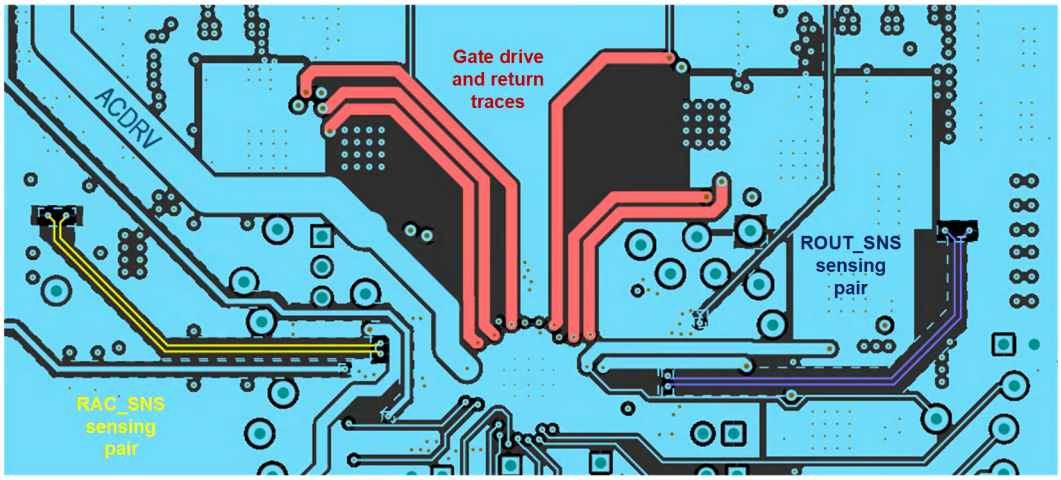


Figure 10-2. PCB Layout Gate Drive and Current Sensing Signal Layer Routing

11 Power Supply Recommendations

The power supply for the device is any DC voltage source within the specified input range. The supply must also be capable of supplying sufficient current based on the programmed input current limit. The input supply must be bypassed with a combination of electrolytic and ceramic capacitors to avoid ringing due to the parasitic impedance of the connecting cables.

When device is operating in the reverse direction, the supply at the OUTPUT should follow the same recommendations as the input supply mentioned above.

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12 Device and Documentation Support

12.1 Device Support

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

TI Glossary — This glossary lists and explains terms, acronyms, and definitions.

13 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (November 2024) to Revision A (September 2026) — **Page**

- Changed Mode to PGND 4
- Added "When the converter is disabled, the DRV_SUP supply needs to be disabled such that BTST1/BTST2 and DRV_SUP pins are not biased." 22
- Added Section 7.3.3.3 22
- Added Section 7.3.3.4 23

DATE	REVISION	NOTES
November 2024	*	Initial release

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
BQ25751RRVR	Active	Production	VQFN (RRV) | 36	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQ25751
BQ25751RRVR.A	Active	Production	VQFN (RRV) | 36	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	BQ25751

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

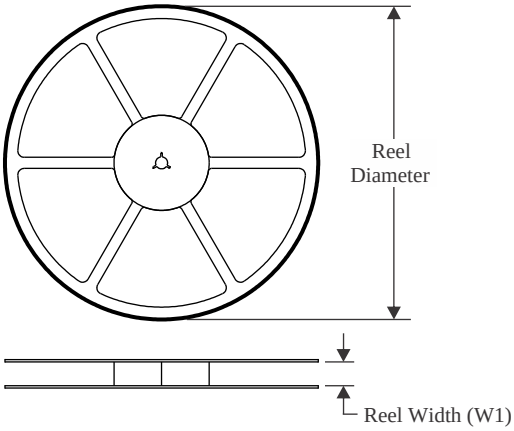
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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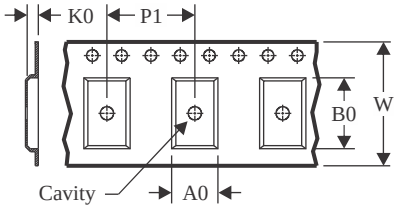
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

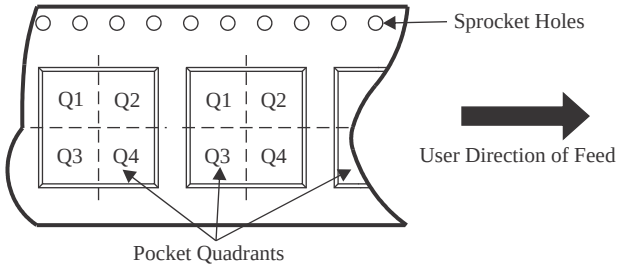


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

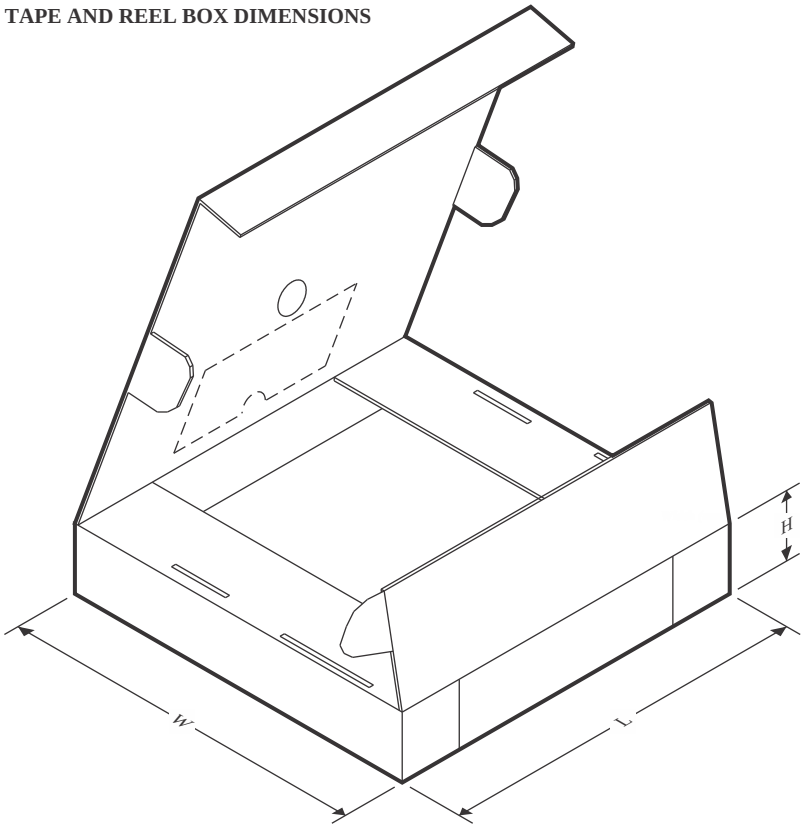
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25751RRVR	VQFN	RRV	36	3000	330.0	12.4	5.3	6.3	1.15	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ25751RRVR	VQFN	RRV	36	3000	367.0	367.0	35.0

GENERIC PACKAGE VIEW

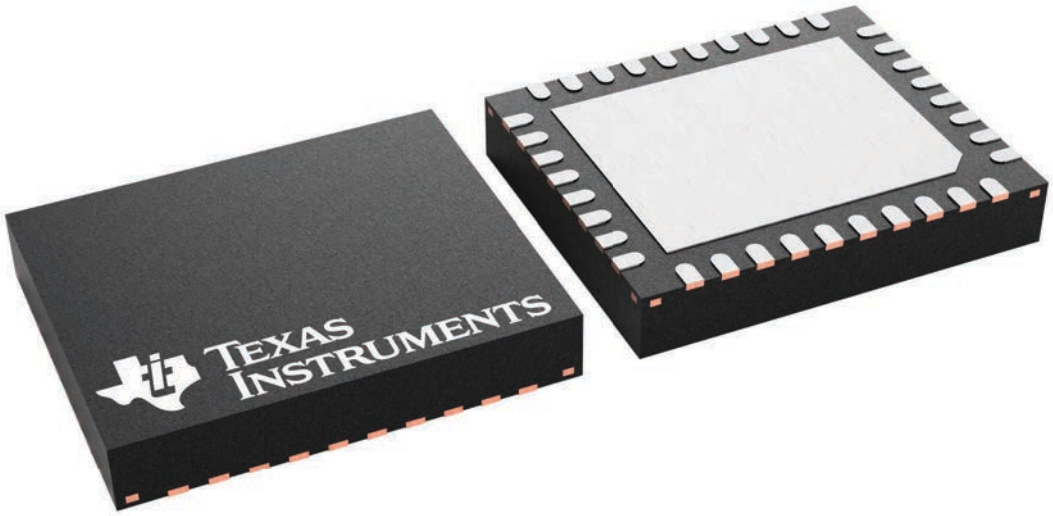
RRV 36

VQFN - 1 mm max height

5 x 6, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



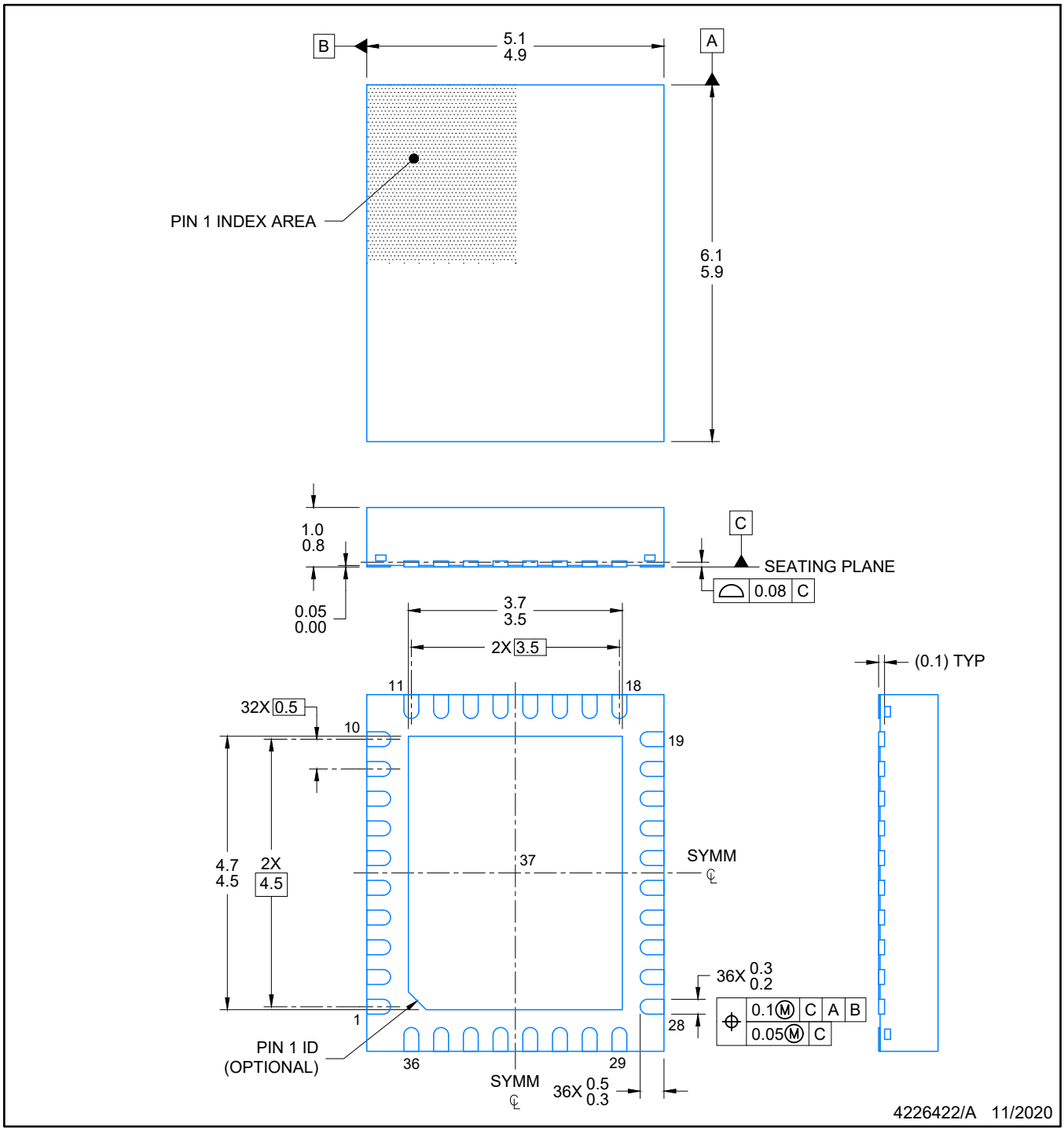
4229484/A

PACKAGE OUTLINE

RRV0036A

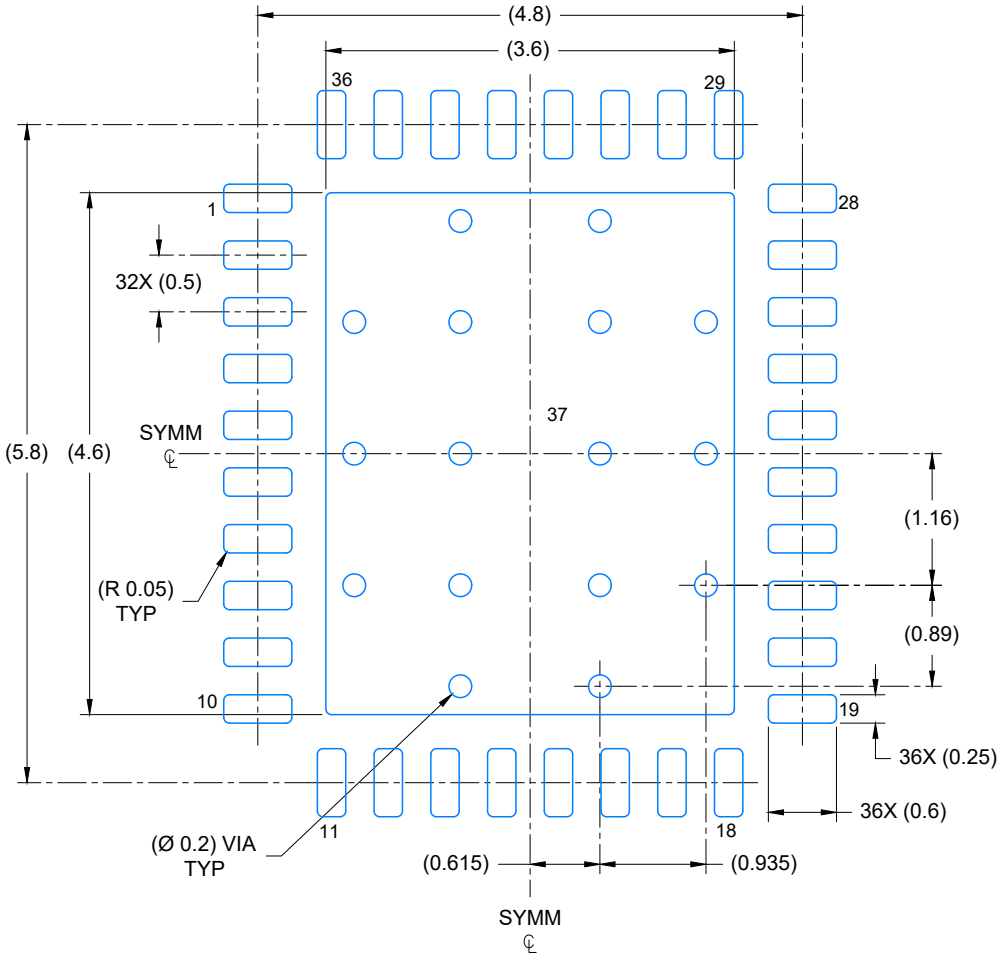
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK-NO LEAD

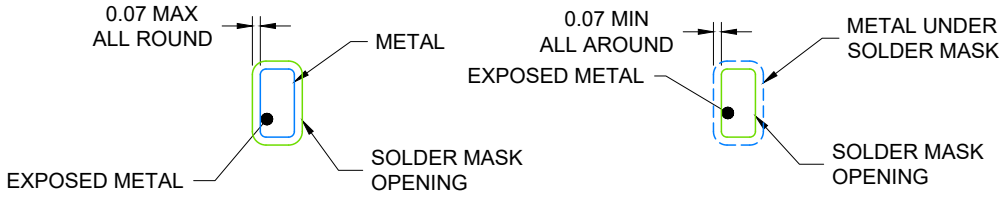


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



NON- SOLDER MASK DEFINED (PREFERRED)

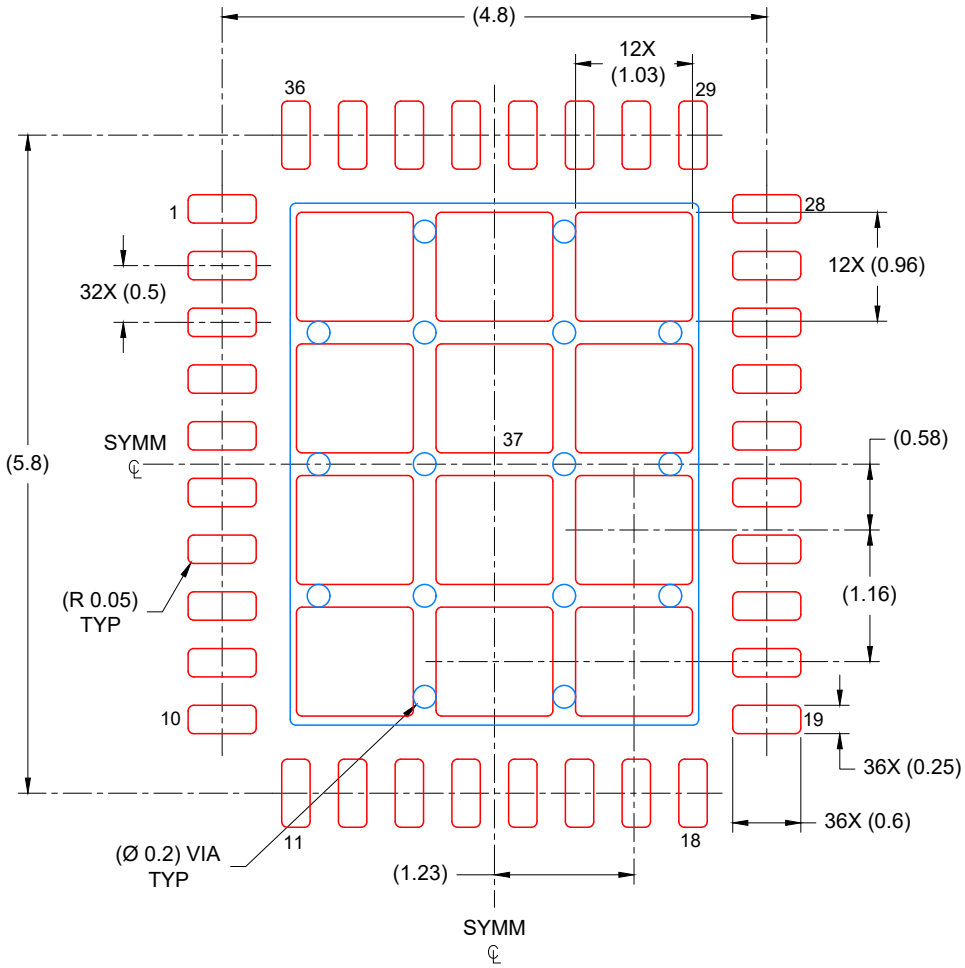
SOLDER MASK DEFINED

SOLDER MASK DETAILS

4226422/A 11/2020

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271) .
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
72% PRINTED COVERAGE BY AREA
SCALE: 15X

4226422/A 11/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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